EFR32FG28 Wireless SoC Family Data Sheet

The EFR32FG28 SoC is an ideal dual band Sub-GHz + 2.4 GHz BLE SoC solution for “Internet of Things” applications in smart homes, security, lighting, building automation, and metering. This dual band solution combines a high-performance Sub-GHz radio that provides long range capabilities and a 2.4 GHz BLE radio for multiprotocol applications.

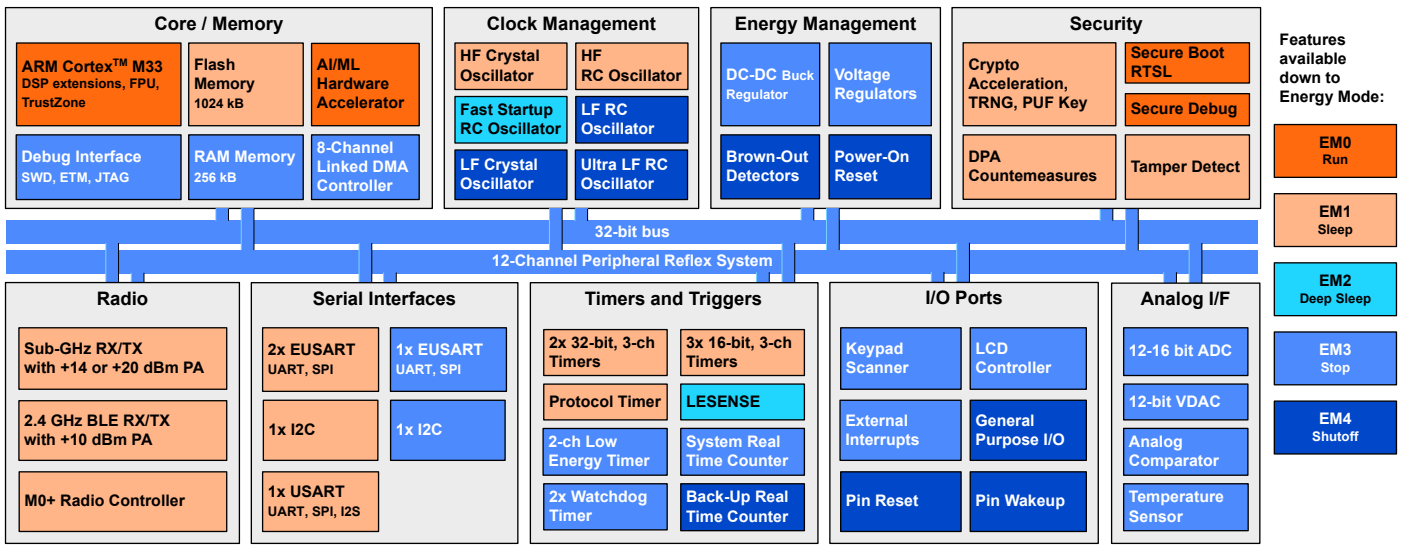
The single die, multi-core solution, provides industry leading security, low power consumption with fast wakeup times, and integrated power amplifiers to enable the next level of secure connectivity for IoT devices. Large memory footprint enables flexible solutions for Dynamic Protocol support and the integration of a Matrix Vector Processor empowers AI/ML implementation for Smart End Nodes.

EFR32FG28 applications include:

- Metering
- Home and Building Automation and Security
- Industrial Automation
- Street Lighting

KEY FEATURES

- 32-bit ARM® Cortex®-M33 core with 78 MHz maximum operating frequency
- 1024 kB of flash and up to 256 kB of RAM
- Energy-efficient radio core with low active and sleep currents
- Integrated PAs with up to 20 dBm for sub-GHz and 10 dBm for BLE transmit power
- Robust peripheral set and up to 49 GPIO
- QFN48 and QFN68 package options



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1. Feature List

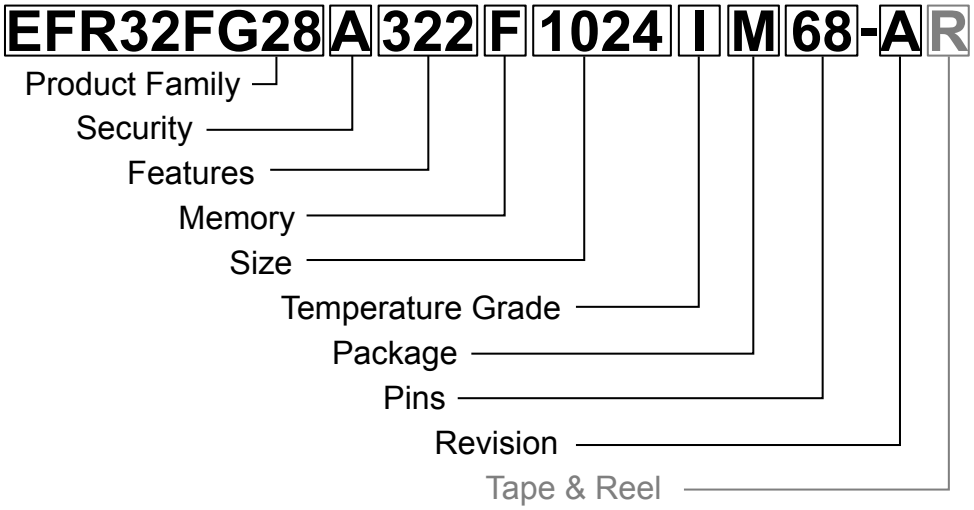
The EFR32FG28 highlighted features are listed below.

- **Low Power Wireless System-on-Chip**
  - High Performance 32-bit 78 MHz ARM Cortex®-M33 with DSP instruction and floating-point unit for efficient signal processing
  - Up to 1024 kB flash program memory
  - Up to 256 kB RAM data memory
  - Sub-GHz radio operation with TX power up to +20 dBm
  - 2.4 GHz BLE radio operation with TX power up to +10 dBm
  - Matrix Vector Processor for AI/ML acceleration
- **Low Energy Consumption**
  - 4.4 mA RX current at 920 MHz (400 kbps 4-FSK)
  - 4.0 mA RX current at 915 MHz (4.8 kbps O-QPSK)
  - 5.4 mA RX current at 915 MHz (2 Mbps GFSK)
  - 3.9 mA RX current at 868 MHz (2.4 kbps GFSK)
  - 3.9 mA RX current at 868 MHz (38.4 kbps FSK)
  - 4.2 mA RX current at 433 MHz (100 kbps 2GFSK)
  - 5.2 mA RX current at 2.4 GHz, 1 Mbps BLE
  - 25.7 mA TX current @ 14 dBm output power at 915 MHz (14 dBm part numbers)
  - 12.3 mA TX current @ 0 dBm output power, 2.4 GHz
  - 23.2 mA TX current @ 10 dBm output power, 2.4 GHz
  - 33 µA/MHz in Active Mode (EM0) at 39.0 MHz
  - 2.8 µA EM2 DeepSleep current (256 kB RAM retention and RTC running from LFXO)
  - 1.3 µA EM2 DeepSleep current (16 kB RAM retention and RTC running from LFRCO)
  - Preamble Sense Mode (PSM) low duty-cycle listen
- **High Receiver Performance**
  - -98.1 dBm sensitivity @ 400 kbps 920 MHz 4-GFSK
  - -124.8 dBm sensitivity @ 4.8 kbps 915 MHz O-QPSK
  - -96.0 dBm sensitivity @ 2 Mbps 915 MHz GFSK
  - -124.1 dBm sensitivity @ 2.4 kbps 868 MHz GFSK
  - -110.4 dBm sensitivity @ 38.4 kbps 868 MHz FSK
  - -110.6 dBm sensitivity @ 100 kbps 433 MHz 2GFSK
- **Supported Modulation Format**
  - 2/4 (G)FSK with fully configurable shaping
  - OQPSK DSSS
  - (G)MSK
  - OOK
- **Protocol Support**
  - Proprietary
  - CONNECT
  - Amazon Sidewalk
  - WM-BUS
  - Wi-SUN
  - Bluetooth Low Energy
- **Wide selection of MCU peripherals**
  - Analog to Digital Converter (ADC)
    - 12-bit @ 1 Msps
    - 16-bit @ 76.9 ksps
  - 2 × Analog Comparator (ACMP)
  - 2-Channel Digital to Analog Converter (VDAC)
  - Low-Energy Sensor Interface (LESENSE)
  - Up to 49 General Purpose I/O pins with output state retention and asynchronous interrupts
  - 8 Channel DMA Controller
  - 12 Channel Peripheral Reflex System (PRS)
  - 4 × 16-bit Timer/Counter with 3 Compare/Capture/PWM channels
  - 1 × 32-bit Timer/Counter with 3 Compare/Capture/PWM channels
  - 32-bit Real Time Counter
  - 24-bit Low Energy Timer for waveform generation
  - 16-bit Pulse Counter with asynchronous operation (PCNT)
  - 2 × Watchdog Timer
  - 3 × Enhanced Universal Synchronous/Asynchronous Receiver/Transmitter (EUSART)
  - 1 × Universal Synchronous/Asynchronous Receiver/Transmitter (UART/SPI/SmartCard (ISO 7816)/IrDA/I^2S)
  - 2 × I^2C interface with SMBus support
  - Integrated Low-Energy LCD Controller supporting up to 192 segments
  - Keypad scanner supporting up to 6×8 matrix (KEYSCAN)
  - Die temperature sensor with ±2 °C typical accuracy across temperature range
- **Secure Vault**
  - Hardware Cryptographic Acceleration for AES128/192/256, ChaCha20-Poly1305, SHA-1, SHA-2/256/384/512, ECDSA +ECDH(P-192, P-256, P-384, P-521), Ed25519 and Curve25519, J-PAKE, PBKDF2
  - True Random Number Generator (TRNG)
  - ARM® TrustZone®
  - Secure Boot (Root of Trust Secure Loader)
  - Secure Debug Unlock
  - DPA Countermeasures
  - Secure Key Management with PUF
  - Anti-Tamper
  - Secure Attestation
- **Wide Operating Range**
  - 1.71 V to 3.8 V single power supply
  - -40 °C to +125 °C
- **Packages**
  - **QFN68** 8 mm × 8 mm × 0.85 mm
  - **QFN48** 6 mm × 6 mm × 0.85 mm

2. Ordering Information

Table 2.1. Ordering Information

Ordering Code	Sub-GHz TX Power	BLE TX Power	Flash (kB)	RAM (kB)	Secure Vault	GPIO	Matrix Vector Processor	Package / Pinout	Temp Range
EFR32FG28B322F1024IM68-A	20 dBm	10 dBm	1024	256	High	49	Yes	QFN68 Dual-Band	-40 to 125 °C
EFR32FG28B322F1024IM48-A	20 dBm	10 dBm	1024	256	High	31	Yes	QFN48 Dual-Band	-40 to 125 °C
EFR32FG28B320F1024IM68-A	20 dBm	n/a	1024	256	High	49	Yes	QFN68 Sub-GHz	-40 to 125 °C
EFR32FG28B320F1024IM48-A	20 dBm	n/a	1024	256	High	31	Yes	QFN48 Sub-GHz	-40 to 125 °C
EFR32FG28B312F1024IM68-A	14 dBm	10 dBm	1024	256	High	49	Yes	QFN68 Dual-Band	-40 to 125 °C
EFR32FG28B312F1024IM48-A	14 dBm	10 dBm	1024	256	High	31	Yes	QFN48 Dual-Band	-40 to 125 °C
EFR32FG28B310F1024IM68-A	14 dBm	n/a	1024	256	High	49	Yes	QFN68 Sub-GHz	-40 to 125 °C
EFR32FG28B310F1024IM48-A	14 dBm	n/a	1024	256	High	31	Yes	QFN48 Sub-GHz	-40 to 125 °C
EFR32FG28A122F1024GM68-A	20 dBm	10 dBm	1024	256	Mid	49	No	QFN68 Dual-Band	-40 to 85 °C
EFR32FG28A122F1024GM48-A	20 dBm	10 dBm	1024	256	Mid	31	No	QFN48 Dual-Band	-40 to 85 °C
EFR32FG28A120F1024GM68-A	20 dBm	n/a	1024	256	Mid	49	No	QFN68 Sub-GHz	-40 to 85 °C
EFR32FG28A120F1024GM48-A	20 dBm	n/a	1024	256	Mid	31	No	QFN48 Sub-GHz	-40 to 85 °C
EFR32FG28A112F1024GM68-A	14 dBm	10 dBm	1024	256	Mid	49	No	QFN68 Dual-Band	-40 to 85 °C
EFR32FG28A112F1024GM48-A	14 dBm	10 dBm	1024	256	Mid	31	No	QFN48 Dual-Band	-40 to 85 °C
EFR32FG28A110F1024GM68-A	14 dBm	n/a	1024	256	Mid	49	No	QFN68 Sub-GHz	-40 to 85 °C
EFR32FG28A110F1024GM48-A	14 dBm	n/a	1024	256	Mid	31	No	QFN48 Sub-GHz	-40 to 85 °C
EFR32FG28A010F1024GM68-A	14 dBm	n/a	1024	128	Mid	49	No	QFN68 Sub-GHz	-40 to 85 °C
EFR32FG28A010F1024GM48-A	14 dBm	n/a	1024	128	Mid	31	No	QFN48 Sub-GHz	-40 to 85 °C



Field	Options
Product Family	• **EFR32FG28**: Wireless Gecko Flex 28 Family
Security	• **A**: Secure Vault Mid • **B**: Secure Vault High

Features [f1][f2][f3]	• f1
	  • **0**: 8-to-1 Flash / RAM ratio, no MVP
	  • **1**: 4-to-1 Flash / RAM ratio, no MVP
	  • **3**: 4-to-1 Flash / RAM ratio, with MVP
	• f2, f3
	  • **10**: Two 14 dBm Sub-GHz PAs (RF0 and RF1)
	  • **12**: One 14 dBm Sub-GHz PA (RF1) and one 10 dBm BLE 2.4 GHz PA (RF0)
	  • **20**: Two 20 dBm Sub-GHz PAs (RF0 and RF1)
	  • **22**: One 20 dBm Sub-GHz PA (RF1) and one 10 dBm BLE 2.4 GHz PA (RF0)

Memory	• **F**: Flash
Size	• **Memory Size** in kBytes
Temperature Grade	• **G**: -40 to +85 °C • **I**: -40 to +125 °C
Package	• **M**: QFN
Pins	• **Number of Package Pins**
Revision	• **A**: Revision A
Tape & Reel	• **R**: Tape & Reel (optional)

Figure 2.1. Ordering Code Key

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3. System Overview

3.1 Introduction

The EFR32 product family combines an energy-friendly MCU with a high performance radio transceiver. The devices are well suited for secure connected IoT multi-protocol devices requiring high performance and low energy consumption. This section gives a short introduction to the full radio and MCU system. The detailed functional description can be found in the EFR32xG28 Reference Manual.

A block diagram of the EFR32FG28 family is shown in Figure 3.1 Detailed EFR32FG28 Block Diagram on page 9. The diagram shows a superset of features available on the family, which vary by part number. For more information about specific device features, consult 2. Ordering Information.

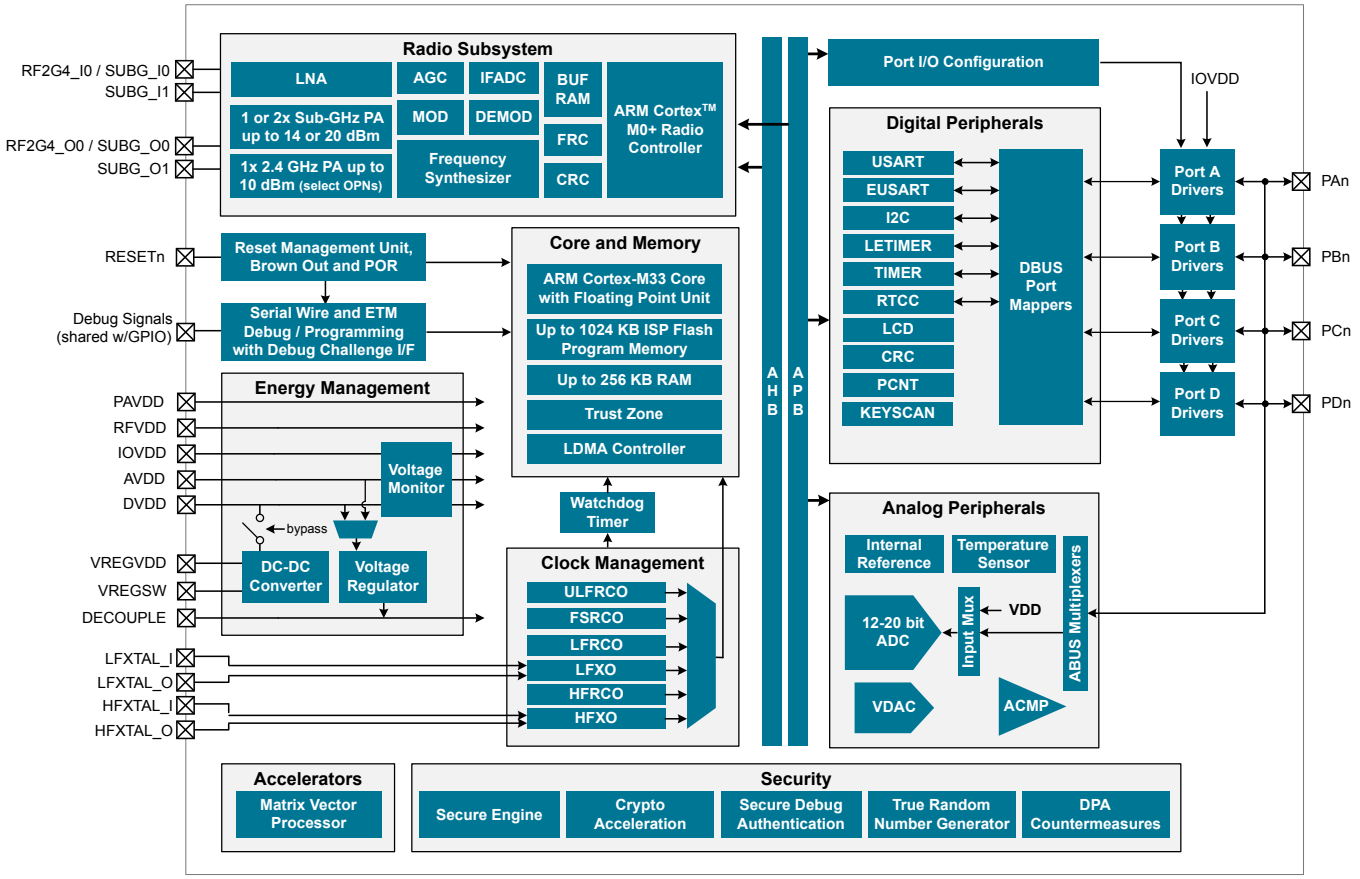

Figure 3.1. Detailed EFR32FG28 Block Diagram

3.2 Radio

The EFR32FG28 family features a radio transceiver supporting proprietary wireless protocols, and on certain OPNs, Bluetooth Low-Energy.

3.2.1 Antenna Interface

The antenna interface consists of two single-ended input pins that interface directly to two LNAs and two single-ended output pins that interface directly to two integrated PAs. Integrated switches select one of the two PAs to be to be the active path.

Different product options within the family include either one 2.4 GHz PA (10 dBm) and one Sub-GHz PA (14 or 20 dBm) or two Sub-GHz PAs (14 or 20 dBm). The RF0 interface is either SUBG_I0 and SUBG_O0 or RF2G4_I0 and RF2G4_O0. The RF1 interface is always SUBG_I1 and SUBG_O1.

The external components and power supply connections for the antenna interface in typical applications are shown in the RF Matching Networks section.

3.2.2 Fractional-N Frequency Synthesizer

The EFR32FG28 contains a high performance, low phase noise, fully integrated fractional-N frequency synthesizer. The synthesizer is used in receive mode to generate the LO frequency for the down-conversion mixer. It is also used in transmit mode to directly generate the modulated RF carrier.

The fractional-N architecture provides excellent phase noise performance, frequency resolution better than 24.8 Hz, and low energy consumption. The synthesizer's fast frequency settling allows for very short receiver and transmitter wake up times to reduce system energy consumption.

3.2.3 Receiver Architecture

The EFR32FG28 uses a low-IF receiver architecture, consisting of a Low-Noise Amplifier (LNA) followed by an I/Q down-conversion mixer, employing a crystal reference. The I/Q signals are further filtered and amplified before being sampled by the IF analog-to-digital converter (IFADC).

The IF frequency is configurable from 150 kHz to 1371 kHz. The IF can further be configured for high-side or low-side injection, providing flexibility with respect to known interferers at the image frequency.

The Automatic Gain Control (AGC) module adjusts the receiver gain to optimize performance and avoid saturation for excellent selectivity and blocking performance. The sub-GHz radio can be calibrated on-demand by the user for the desired frequency band.

Demodulation is performed in the digital domain. The demodulator performs configurable decimation and channel filtering to allow receive bandwidths ranging from 0.1 to 2530 kHz. High carrier frequency and baud rate offsets are tolerated by active estimation and compensation. Advanced features supporting high quality communication under adverse conditions include forward error correction by block and convolutional coding as well as Direct Sequence Spread Spectrum (DSSS).

A Received Signal Strength Indicator (RSSI) is available for signal quality metrics, for level-based proximity detection, and for RF channel access by Collision Avoidance (CA) or Listen Before Talk (LBT) algorithms. An RSSI capture value is associated with each received frame and the dynamic RSSI measurement can be monitored throughout reception.

The EFR32FG28 features integrated support for antenna diversity to improve link budget configuration in the sub-GHz band, using complementary control outputs to an external switch. Internal configurable hardware controls automatic switching between antennae during RF receive detection operations.

3.2.4 Transmitter Architecture

The EFR32FG28 uses a direct-conversion transmitter architecture. For constant envelope modulation formats, the modulator controls phase and frequency modulation in the frequency synthesizer. Transmit symbols or chips are optionally shaped by a digital shaping filter. The shaping filter is fully configurable, including the BT product, and can be used to implement Gaussian or Raised Cosine shaping.

Carrier Sense Multiple Access - Collision Avoidance (CSMA-CA) or Listen Before Talk (LBT) algorithms can be automatically timed by the EFR32FG28. These algorithms are typically defined by regulatory standards to improve inter-operability in a given bandwidth between devices that otherwise lack synchronized RF channel access.

3.2.5 Packet and State Trace

The EFR32FG28 Frame Controller has a packet and state trace unit that provides valuable information during the development phase. It features:

- Non-intrusive trace of transmit data, receive data and state information
- Data observability on a single-pin UART data output, or on a two-pin SPI data output
- Configurable data output bitrate / baudrate
- Multiplexed transmitted data, received data and state / meta information in a single serial data stream

3.2.6 Data Buffering

The EFR32FG28 features an advanced Radio Buffer Controller (BUFC) capable of handling up to 4 buffers of adjustable size from 64 bytes to 4096 bytes. Each buffer can be used for RX, TX or both. The buffer data is located in RAM, enabling zero-copy operations.

3.2.7 Radio Controller (RAC)

The Radio Controller controls the top level state of the radio subsystem in the EFR32FG28. It performs the following tasks:

- Precisely-timed control of enabling and disabling of the receiver and transmitter circuitry
- Run-time calibration of receiver, transmitter and frequency synthesizer
- Detailed frame transmission timing, including optional LBT or CSMA-CA

3.2.8 Preamble Sense Mode

Preamble Sense Mode (PSM) is a radio receiver mode suitable for very low power applications. PSM takes advantage of fast preamble detection and, when combined with duty cycling of the receiver, can significantly reduce the average receive current in a system. PSM is only supported by 2(G)FSK modulation and the power saving is dependent on the protocol. PSM has higher benefit with long preambles and lower data rates. PSM can be used via the Signal Qualifier (SQ) feature.

3.3 General Purpose Input/Output (GPIO)

EFR32FG28 has up to 49 General Purpose Input/Output pins. Each GPIO pin can be individually configured as either an output or input. More advanced configurations including open-drain, open-source, and glitch-filtering can be configured for each individual GPIO pin. The GPIO pins can be overridden by peripheral connections, like SPI communication. Each peripheral connection can be routed to several GPIO pins on the device. The input value of a GPIO pin can be routed through the Peripheral Reflex System to other peripherals. The GPIO subsystem supports asynchronous external pin interrupts.

All of the pins on ports A and port B are EM2 capable. These pins may be used by Low-Energy peripherals in EM2/3 and may also be used as EM2/3 pin wake-ups. Pins on ports C and D are latched/retained in their current state when entering EM2 until EM2 exit upon which internal peripherals could once again drive those pads.

A few GPIOs also have EM4 wake functionality. These pins are listed in the Alternate Function Table.

3.4 Keypad Scanner (KEYSCAN)

A low-energy keypad scanner (KEYSCAN) is included, which can scan up to a 6 x 8 matrix of keyboard switches. The KEYSCAN peripheral contains logic for debounce and settling time, allowing it to scan through the switch matrix autonomously in EM0 and EM1, and interrupt the processor when a key press is detected. A wake-on-keypress feature is also supported, allowing for the detection of any key press down to EM3.

3.5 Clocking

3.5.1 Clock Management Unit (CMU)

The Clock Management Unit controls oscillators and clocks in the EFR32FG28. Individual enabling and disabling of clocks to all peripheral modules is performed by the CMU. The CMU also controls enabling and configuration of the oscillators. A high degree of flexibility allows software to optimize energy consumption in any specific application by minimizing power dissipation in unused peripherals and oscillators.

3.5.2 Internal and External Oscillators

The EFR32FG28 supports two crystal oscillators and fully integrates four RC oscillators, listed below.

- A high frequency crystal oscillator (HFXO) with integrated load capacitors, tunable in small steps, provides a precise timing reference for the MCU. The HFXO provides excellent RF clocking performance using a 39.0 MHz crystal. The HFXO can also support an external clock source such as a TCXO for applications that require an extremely accurate clock frequency over temperature.
- A 32.768 kHz crystal oscillator (LFXO) provides an accurate timing reference for low energy modes.
- An integrated high frequency RC oscillator (HFRCO) is available for the MCU system, when crystal accuracy is not required. The HFRCO employs fast start-up at minimal energy consumption combined with a wide frequency range, from 1 MHz to 80 MHz.
- An integrated fast start-up RC oscillator (FSRCO) that runs at a fixed 20 MHz
- An integrated low frequency 32.768 kHz RC oscillator (LFRCO) for low power operation where high accuracy is not required.
- An integrated ultra-low frequency 1 kHz RC oscillator (ULFRCO) is available to provide a timing reference at the lowest energy consumption in low energy modes.

3.6 Counters/Timers and PWM

3.6.1 Timer/Counter (TIMER)

TIMER peripherals keep track of timing, count events, generate PWM outputs and trigger timed actions in other peripherals through the Peripheral Reflex System (PRS). The core of each TIMER is a 16-bit or 32-bit counter with up to 3 compare/capture channels. Each channel is configurable in one of three modes. In capture mode, the counter state is stored in a buffer at a selected input event. In compare mode, the channel output reflects the comparison of the counter to a programmed threshold value. In PWM mode, the TIMER supports generation of pulse-width modulation (PWM) outputs of arbitrary waveforms defined by the sequence of values written to the compare registers. In addition some timers offer dead-time insertion.

See 3.14 Configuration Summary for information on the feature set of each timer.

3.6.2 Low Energy Timer (LETIMER)

The unique LETIMER is a 24-bit timer that is available in energy mode EM0 Active, EM1 Sleep, EM2 Deep Sleep, and EM3 Stop. This allows it to be used for timing and output generation when most of the device is powered down, allowing simple tasks to be performed while the power consumption of the system is kept at an absolute minimum. The LETIMER can be used to output a variety of waveforms with minimal software intervention. The LETIMER is connected to the Peripheral Reflex System (PRS), and can be configured to start counting on compare matches from other peripherals such as the Real Time Clock.

3.6.3 System Real Time Clock with Capture (SYSRTC)

The System Real Time Clock (SYSRTC) is a 32-bit counter providing timekeeping down to EM3. The SYSRTC can be clocked by any of the on-board low-frequency oscillators, and it is capable of providing system wake-up at user defined intervals.

3.6.4 Back-Up Real Time Counter (BURTC)

The Back-Up Real Time Counter (BURTC) is a 32-bit counter providing timekeeping in all energy modes, including EM4. The BURTC can be clocked by any of the on-board low-frequency oscillators, and it is capable of providing system wake-up at user-defined intervals.

3.6.5 Watchdog Timer (WDOG)

The watchdog timer can act both as an independent watchdog or as a watchdog synchronous with the CPU clock. It has windowed monitoring capabilities, and can generate a reset or different interrupts depending on the failure mode of the system. The watchdog can also monitor autonomous systems driven by the Peripheral Reflex System (PRS).

3.7 Communications and Other Digital Peripherals

3.7.1 Universal Synchronous/Asynchronous Receiver/Transmitter (USART)

The Universal Synchronous/Asynchronous Receiver/Transmitter is a flexible serial I/O module. It supports full duplex asynchronous UART communication with hardware flow control as well as RS-485, SPI, MicroWire and 3-wire. It can also interface with devices supporting:

- ISO7816 SmartCards
- IrDA
- I^2S

3.7.2 Enhanced Universal Synchronous/Asynchronous Receiver/Transmitter (EUSART)

The Enhanced Universal Synchronous/Asynchronous Receiver/Transmitter supports full duplex asynchronous UART communication with hardware flow control, RS-485, and IrDA support. The EUSART also supports high-speed SPI. In EM0 and EM1 the EUSART provides a high-speed, buffered communication interface.

When routed to GPIO ports A or B, the EUSART0 may also be used in a low-energy mode and operate in EM2. A 32.768 kHz clock source allows full duplex UART communication up to 9600 baud. EUSART0 can also act as a SPI secondary device in EM2 and EM3, and wake the system when data is received from an external bus controller.

3.7.3 Inter-Integrated Circuit Interface (I^2C)

The I^2C module provides an interface between the MCU and a serial I^2C bus. It is capable of acting as a main or secondary interface and supports multi-drop buses. Standard-mode, fast-mode and fast-mode plus speeds are supported, allowing transmission rates from 10 kbit/s up to 1 Mbit/s. Bus arbitration and timeouts are also available, allowing implementation of an SMBus-compliant system. The interface provided to software by the I^2C module allows precise timing control of the transmission process and highly automated transfers. Automatic recognition of addresses is provided in active and low energy modes. Note that not all instances of I^2C are available in all energy modes.

3.7.4 Peripheral Reflex System (PRS)

The Peripheral Reflex System provides a communication network between different peripheral modules without software involvement. Peripheral modules producing Reflex signals are called producers. The PRS routes Reflex signals from producers to consumer peripherals which in turn perform actions in response. Edge triggers and other functionality such as simple logic operations (AND, OR, NOT) can be applied by the PRS to the signals. The PRS allows peripherals to act autonomously without waking the MCU core, saving power.

3.7.5 Low Energy Sensor Interface (LESENSE)

The Low Energy Sensor Interface LESENSE™ is a highly configurable sensor interface with support for up to 16 individually configurable sensors. By controlling the analog comparators, ADC, and DAC, LESENSE is capable of supporting a wide range of sensors and measurement schemes, and can for instance measure LC sensors, resistive sensors and capacitive sensors. LESENSE also includes a programmable finite state machine which enables simple processing of measurement results without CPU intervention. LESENSE is available in energy mode EM2, in addition to EM0 and EM1, making it ideal for sensor monitoring in applications with a strict energy budget.

3.8 Secure Vault Features

A dedicated hardware secure engine containing its own CPU enables the Secure Vault functions. It isolates cryptographic functions and data from the host Cortex-M33 core, and provides several additional security features. The EFR32FG28 family includes devices with Secure Vault High and Secure Vault Mid capabilities, which are summarized in the table below.

Table 3.1. Secure Vault Features

Feature	Secure Vault Mid	Secure Vault High
True Random Number Generator (TRNG)	Yes	Yes
Secure Boot with Root of Trust and Secure Loader (RTSL)	Yes	Yes
Secure Debug with Lock/Unlock	Yes	Yes
DPA Countermeasures	Yes	Yes
Anti-Tamper		Yes
Secure Attestation		Yes
Secure Key Management		Yes

Symmetric Encryption	• AES 128 / 192 / 256 bit
	  • ECB, CTR, CBC, CFB, CCM, GCM, CBC-MAC, and GMAC
		• AES 128 / 192 / 256 bit
		  • ECB, CTR, CBC, CFB, CCM, GCM, CBC-MAC, and GMAC
		• ChaCha20

Public Key Encryption - ECDSA / ECDH / EdDSA	• p192 and p256	• p192, p256, p384 and p521 • Curve25519 (ECDH) • Ed25519 (EdDSA)
Key Derivation	• ECJ-PAKE p192 and p256	• ECJ-PAKE p192, p256, p384, and p521 • PBKDF2 • HKDF
Hashes	• SHA-1 • SHA-2/256	• SHA-1 • SHA-2/256/384/512 • Poly1305

3.8.1 Secure Boot with Root of Trust and Secure Loader (RTSL)

The Secure Boot with RTSL authenticates a chain of trusted firmware that begins from an immutable memory (ROM).

It prevents malware injection, prevents rollback, ensures that only authentic firmware is executed, and protects Over The Air updates.

For more information about this feature, see AN1218: Series 2 Secure Boot with RTSL.

3.8.2 Cryptographic Accelerator

The Cryptographic Accelerator is an autonomous hardware accelerator with Differential Power Analysis (DPA) countermeasures to protect keys.

It supports AES encryption and decryption with 128/192/256-bit keys, ChaCha20 encryption, and Elliptic Curve Cryptography (ECC) to support public key operations, and hashes.

Supported block cipher modes of operation for AES include:

- ECB (Electronic Code Book)
- CTR (Counter Mode)
- CBC (Cipher Block Chaining)
- CFB (Cipher Feedback)
- GCM (Galois Counter Mode)
- CCM (Counter with CBC-MAC)
- CBC-MAC (Cipher Block Chaining Message Authentication Code)
- GMAC (Galois Message Authentication Code)

The Cryptographic Accelerator accelerates Elliptical Curve Cryptography and supports the NIST (National Institute of Standards and Technology) recommended curves including P-192, P-256, P-384, and P-521 for ECDH (Elliptic Curve Diffie-Hellman) key derivation, and ECDSA (Elliptic Curve Digital Signature Algorithm) sign and verify operations. Also supported is the non-NIST Curve25519 for ECDH and Ed25519 for EdDSA (Edwards-curve Digital Signature Algorithm) sign and verify operations.

Secure Vault also supports ECJ-PAKE (Elliptic Curve variant of Password Authenticated Key Exchange by Juggling) and PBKDF2 (Password-Based Key Derivation Function 2).

Supported hashes include SHA-1, SHA-2/256/384/512 and Poly1305.

This implementation provides a fast and energy efficient solution to state of the art cryptographic needs.

3.8.3 True Random Number Generator

The True Random Number Generator module is a non-deterministic random number generator that harvests entropy from a thermal energy source. It includes start-up health tests for the entropy source as required by NIST SP800-90B and AIS-31 as well as online health tests required for NIST SP800-90C.

The TRNG is suitable for periodically generating entropy to seed an approved pseudo random number generator.

3.8.4 Secure Debug with Lock/Unlock

For obvious security reasons, it is critical for a product to have its debug interface locked before being released in the field.

Secure Vault also provides a secure debug unlock function that allows authenticated access based on public key cryptography. This functionality is particularly useful for supporting failure analysis while maintaining confidentiality of IP and sensitive end-user data.

For more information about this feature, see AN1190: Series 2 Secure Debug.

3.8.5 DPA Countermeasures

The AES and ECC accelerators have Differential Power Analysis (DPA) countermeasures support. This makes it very expensive from a time and effort standpoint to use DPA to recover secret keys.

3.8.6 Secure Key Management with PUF

Key material in Secure Vault High products is protected by "key wrapping" with a standardized symmetric encryption mechanism. This method has the advantage of protecting a virtually unlimited number of keys, limited only by the storage that is accessible by the Cortex-M33, which includes off-chip storage as well. The symmetric key used for this wrapping and unwrapping must be highly secure because it can expose all other key materials in the system. The Secure Vault Key Management system uses a Physically Unclonable Function (PUF) to generate a persistent device-unique seed key on power up to dynamically generate this critical wrapping/unwrapping key which is only visible to the AES encryption engine and is not retained when the device loses power.

3.8.7 Anti-Tamper

Secure Vault High devices provide internal tamper protection which monitors parameters such as voltage, temperature, and electromagnetic pulses as well as detecting tamper of the security sub-system itself. Additionally, 8 external configurable tamper pins support external tamper sources, such as enclosure tamper switches.

For each tamper event, the user is able to select the severity of the tamper response ranging from an interrupt, to a reset, to destroying the PUF reconstruction data which will make all protected key materials un-recoverable and effectively render the device inoperable. The tamper system also has an internal resettable event counter with programmable trigger threshold and refresh periods to mitigate false positive tamper events.

For more information about this feature, see AN1247: Anti-Tamper Protection Configuration and Use.

3.8.8 Secure Attestation

Secure Vault High products support Secure Attestation, which begins with a secure identity that is created during the Silicon Labs manufacturing process. During device production, each device generates its own public/private keypair and securely stores the wrapped private key into immutable OTP memory and this key never leaves the device. The corresponding public key is extracted from the device and inserted into a binary DER-encoded X.509 device certificate, which is signed into a Silicon Labs CA chain and then programmed back into the chip into an immutable OTP memory.

The secure identity can be used to authenticate the chip at any time in the life of the product. The production certification chain can be requested remotely from the product. This certification chain can be used to verify that the device was authentically produced by Silicon Labs. The device unique public key is also bound to the device certificate in the certification chain. A challenge can be sent to the chip at any point in time to be signed by the device private key. The public key in the device certificate can then be used to verify the challenge response, proving that the device has access to the securely-stored private key, which prevents counterfeit products or impersonation attacks.

For more information about this feature, see AN1268: Authenticating Silicon Labs Devices Using Device Certificates.

3.9 Analog

3.9.1 Analog to Digital Converter (IADC)

The IADC is a hybrid architecture combining techniques from both SAR and Delta-Sigma style converters. It has a resolution of 12 bits at 1 Msps and 16 bits at up to 76.9 ksps. Hardware oversampling reduces system-level noise over multiple front-end samples. The IADC includes integrated voltage reference options. Inputs are selectable from a wide range of sources, including pins configurable as either single-ended or differential.

3.9.2 Analog Comparator (ACMP)

The Analog Comparator is used to compare the voltage of two analog inputs, with a digital output indicating which input voltage is higher. Inputs are selected from among internal references and external pins. The tradeoff between response time and current consumption is configurable by software. Two 6-bit reference dividers allow for a wide range of internally-programmable reference sources. The ACMP can also be used to monitor the supply voltage. An interrupt can be generated when the supply falls below or rises above the programmable threshold.

3.9.3 Digital to Analog Converter (VDAC)

The Digital to Analog Converter (VDAC) can convert a digital value to an analog output voltage. The VDAC is a fully differential, 500 ksps, 12-bit converter. The VDAC may be used for a number of different applications such as sensor interfaces or sound output. The VDAC can generate high-resolution analog signals while the MCU is operating at low frequencies and with low total power consumption. Using DMA and a timer, the VDAC can be used to generate waveforms without any CPU intervention. The VDAC is available in all energy modes down to and including EM3.

3.9.4 Liquid Crystal Display Driver (LCD)

The LCD driver is capable of directly driving a segmented LCD. The configurable interface allows for up to 8x24 or 4x28 segments. A voltage boost function enables it to provide the LCD with higher voltage than the supply voltage for the device. A patented charge redistribution driver can reduce the LCD peripheral supply current by up to 40%. In addition, an animation feature can run custom animations on the LCD without any CPU intervention. The LCD driver can also remain active even in Energy Mode 2 and provides a Frame Counter interrupt that can wake-up the device on a regular basis for updating data.

3.10 Power

The EFR32FG28 has an Energy Management Unit (EMU) and efficient integrated regulators to generate internal supply voltages. Only a single external supply voltage is required, from which all internal voltages are created. An optional integrated DC-DC buck regulator can be utilized to further reduce the current consumption. The DC-DC regulator requires one external inductor and one external capacitor.

The EFR32FG28 device family includes support for internal supply voltage scaling, as well as two different power domains groups for peripherals. These enhancements allow for further supply current reductions and lower overall power consumption.

3.10.1 Energy Management Unit (EMU)

The Energy Management Unit manages transitions of energy modes in the device. Each energy mode defines which peripherals and features are available and the amount of current the device consumes. The EMU can also be used to implement system-wide voltage scaling and turn off the power to unused RAM blocks to optimize the energy consumption in the target application. The DC-DC regulator operation is tightly integrated with the EMU.

3.10.2 Voltage Scaling

The EFR32FG28 supports supply voltage scaling for the LDO powering DECOUPLE, with independent selections for EM0 / EM1 and EM2 / EM3. Voltage scaling helps to optimize the energy efficiency of the system by operating at lower voltages when possible. The EM0 / EM1 voltage scaling level defaults to VSCALE2, which allows the core to operate in active mode at full speed. The intermediate level, VSCALE1, allows operation in EM0 and EM1 at up to 40 MHz. The lowest level, VSCALE0, can be used to conserve power further in EM2 and EM3. The EMU will automatically switch the target voltage scaling level when transitioning between energy modes.

3.10.3 DC-DC Converter

The DC-DC buck converter covers a wide range of load currents, providing high efficiency in energy modes EM0, EM1, EM2 and EM3. RF noise mitigation allows operation of the DC-DC converter without significantly degrading sensitivity of radio components. An on-chip supply-monitor signals when the supply voltage is low to allow bypass of the regulator via programmable software interrupt. It employs soft switching at boot and DCDC regulating-to-bypass transitions to limit the max supply slew-rate and mitigate inrush current.

3.10.4 Power Domains

Peripherals may exist on several independent power domains which are powered down to minimize supply current when not in use. Power domains are managed automatically by the EMU.

The lowest-energy power domain is the "high-voltage" power domain (PDHV), which supports extremely low-energy infrastructure and peripherals. Circuits powered from PDHV are always on and available in all energy modes down to EM4.

The next power domain is the low power domain (PD0), which is further divided to power subsets of peripherals. All PD0 power domains are shut down in EM4. Circuits powered from PD0 power domains may be available in EM0, EM1, EM2, and EM3.

Low power domain A (PD0A) is the base power domain for EM2 and EM3 and will always remain on in EM0-EM3. It powers the most commonly-used EM2 and EM3-capable peripherals and infrastructure required to operate in EM2 and EM3. The lowest-power EM2 and EM3 operation is achieved when only the base PD0A power domain is active. Auxiliary PD0 power domains (PD0B, PD0C, PD0D, PD0E) power additional EM2 and EM3-capable peripherals on demand. If any peripherals on one of the auxiliary power domains is enabled, that power domain will be active in EM2 and EM3. Otherwise, the auxiliary PD0 power domains will be shut down to reduce current.

Note: Power domain PD0E is also turned on when peripherals on PD0B, PD0C, or PD0D are used.

The active power domain (PD1) powers the rest of the device circuitry, including the CPU core and EM0 / EM1 peripherals. PD1 is always powered on in EM0 and EM1. PD1 is always shut down in EM2, EM3, and EM4.

Table 3.2 Peripheral Power Subdomains on page 18 shows the peripherals on the PDHV and PD0x domains. Any peripheral not listed is on PD1.

Table 3.2. Peripheral Power Subdomains

Always On in EM2/EM3		Selectively On in EM2/3			
PDHV[1]	PD0A	PD0B[2]	PD0C[2]	PD0D[2]	PD0E
LFRCO	SYSRTC	LETIMER0	HFRCOEM23	DEBUG	GPIO
LFXO	FSRCO	IADC0	HFXO	WDOG0	KEYSCAN
BURTC	LCD	PCNT0		WDOG1	PRS
ULFRCO		ACMP0		EUSART0	
		ACMP1		I2C0	
		LESENSE			
		VDAC0			

Note:
1. Peripherals on PDHV are also available in EM4.
2. If any of PD0B, PD0C, or PD0D are enabled, PD0E will also be automatically enabled.

3.11 Reset Management Unit (RMU)

The RMU is responsible for handling reset of the EFR32FG28. A wide range of reset sources are available, including several power supply monitors, pin reset, software controlled reset, core lockup reset, and watchdog reset.

3.12 Core, Memory, and Accelerators

3.12.1 Processor Core

The ARM Cortex-M processor includes a 32-bit RISC processor integrating the following features and tasks in the system:

- ARM Cortex-M33 RISC processor achieving 1.50 Dhrystone MIPS/MHz
- ARM TrustZone security technology
- Embedded Trace Macrocell (ETM) for real-time trace and debug
- Up to 1024 kB flash program memory
- Up to 256 kB RAM data memory
- Configuration and event handling of all modules
- 2-pin Serial-Wire debug interface

3.12.2 Memory System Controller (MSC)

The Memory System Controller (MSC) is the program memory unit of the microcontroller. The flash memory is readable and writable from both the Cortex-M33 and LDMA. In addition to the main flash array where Program code is normally written the MSC also provides an Information block where additional information such as special user information or flash-lock bits are stored. There is also a read-only page in the information block containing system and device calibration data. Read and write operations are supported in energy modes EM0 Active and EM1 Sleep.

3.12.3 Linked Direct Memory Access Controller (LDMA)

The Linked Direct Memory Access (LDMA) controller allows the system to perform memory operations independently of software. This reduces both energy consumption and software workload. The LDMA allows operations to be linked together and staged, enabling sophisticated operations to be implemented.

3.12.4 Matrix Vector Processor (MVP)

The Matrix Vector Processor (MVP) is designed to offload the major computationally intensive floating point operations, particularly matrixed complex floating point multiplications and additions. The MVP supports the acceleration of the key Angle-of-Arrival (AoA) MUSIC (MUltiple SIgnal Classification) algorithm computations, as well as other heavily floating-point computational problems such as Machine Learning (ML) or linear algebra.

3.13 Memory Map

The EFR32FG28 memory map is shown in the figures below. RAM and flash sizes are for the largest memory configuration.

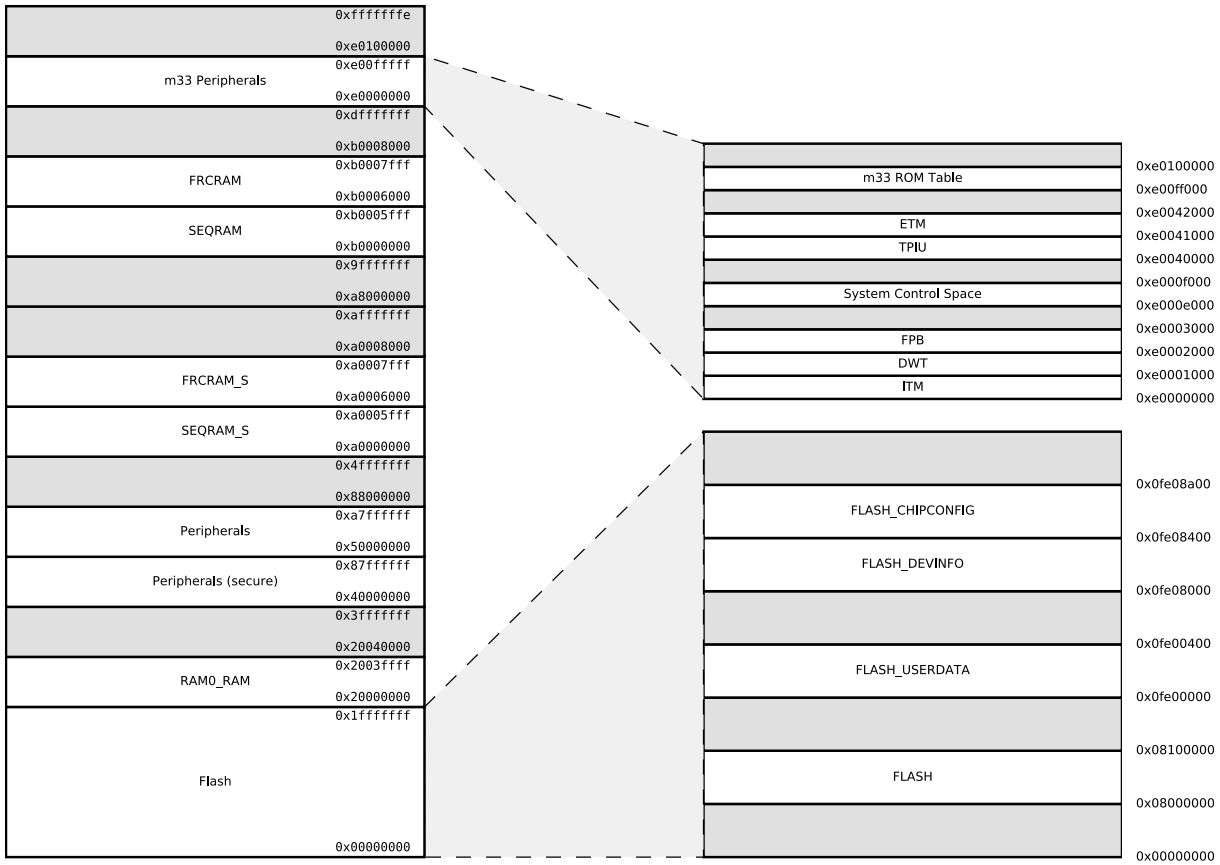

Figure 3.2. EFR32FG28 Memory Map — Core Peripherals and Code Space

3.14 Configuration Summary

The features of the EFR32FG28 are a subset of the feature set described in the device reference manual. The table below describes device specific implementation of the features. Remaining modules support full configuration.

Table 3.3. Configuration Summary

Module	Lowest Energy Mode	Configuration
I2C0	EM2/EM3[1]	
I2C1	EM1	
IADC0	EM2/EM3	
LETIMER0	EM2/EM3[1]	
TIMER0	EM1	32-bit, 3-channels, +DTI
TIMER1	EM1	16-bit, 3-channels, +DTI
TIMER2	EM1	16-bit, 3-channels, +DTI
TIMER3	EM1	16-bit, 3-channels, +DTI
TIMER4	EM1	16-bit, 3-channels, +DTI
EUSART0	EM1 - Full high-speed operation, all modes EM2[1] - Low-energy UART operation, 9600 Baud EM2 or EM3[1] - Low-energy SPI secondary receiver	
EUSART1	EM1 - Full high-speed operation	
EUSART2	EM1 - Full high-speed operation	
USART0	EM1	+IrDA, +I2S, +SmartCard

Note:

1. EM2 and EM3 operation is only supported for digital peripheral I/O on Port A and Port B. All GPIO ports support digital peripheral operation in EM0 and EM1.

4. Electrical Specifications

4.1 Electrical Characteristics

All electrical parameters in all tables are specified under the following conditions, unless stated otherwise:

- Typical values are based on T_A=25 °C and all supplies at 3.3 V, by production test and/or technology characterization.
- Radio performance numbers are measured in conducted mode, based on Silicon Laboratories reference designs using output power-specific external RF impedance-matching networks for interfacing to a 50 Ω antenna.
- Minimum and maximum values represent the worst conditions across supply voltage, process variation, and operating temperature, unless stated otherwise.

Due to on-chip circuitry (e.g., diodes), some EFR32FG28 power supply pins have a dependent relationship with one or more other power supply pins. These internal relationships between the external voltages applied to the various EFR32FG28 supply pins are defined below. Exceeding the below constraints can result in damage to the device and/or increased current draw.

- VREGVDD and DVDD
  - In systems using the DCDC converter, DVDD (the buck converter output) should not be driven externally and VREGVDD (the buck converter input) must be greater than DVDD (VREGVDD ≥ DVDD)
  - In systems not using the DCDC converter, DVDD must be shorted to VREGVDD on the PCB (VREGVDD = DVDD)
- AVDD, IOVDD: No dependency with each other or any other supply pin. Additional leakage may occur if DVDD remains unpowered with power applied to these supplies.
- DVDD ≥ DECOUPLE
- PAVDD ≥ RFVDD

4.2 Absolute Maximum Ratings

Stresses above those listed below may cause permanent damage to the device. This is a stress rating only and functional operation of the devices at those or any other conditions above those indicated in the operation listings of this specification is not implied. Exposure to maximum rating conditions for extended periods may affect device reliability.

Table 4.1. Absolute Maximum Ratings

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Storage temperature range	T_{STG}		-50	—	+150	°C
Voltage on any supply pin	V_{DDMAX}		-0.3	—	3.8	V
Junction temperature	T_{JMAX}	-G grade	—	—	+105	°C
		-I grade	—	—	+125	°C
Voltage ramp rate on any supply pin	$V_{DDRAMPMAX}$		—	—	1.0	V / µs
Voltage on HFXO pins	$V_{HFXOPIN}$		-0.3	—	1.2	V
DC voltage on any GPIO pin[1]	V_{DIGPIN}		-0.3	—	V_{IOVDD} + 0.3	V
DC voltage on RESETn pin[2]	V_{RESETn}		-0.3	—	3.8	V
Absolute voltage on 2.4 GHz RF pins	V_{MAX2G4}	RF2G4_O pins	-0.3	—	1.2	V
		RF2G4_I pins	-0.3	—	0.3	V
Absolute voltage on Sub-GHz RF pins	$V_{MAXSUBG}$	SUBG_O pins	-0.3	—	1.2	V
		SUBG_I pins	-0.3	—	0.3	V
Total current into VDD power lines	I_{VDDMAX}	Source	—	—	200	mA
Total current into VSS ground lines	I_{VSSMAX}	Sink	—	—	200	mA
Current per I/O pin	I_{IOMAX}	Sink	—	—	50	mA
		Source	—	—	50	mA
Current for all I/O pins	$I_{IOALLMAX}$	Sink	—	—	200	mA
		Source	—	—	200	mA

Note:

1. When operating as an LCD driver, the output voltage on a GPIO may safely exceed this specification. The pin output voltage may be up to 3.8 V in this case.
2. The RESETn pin has a pull-up device to the DVDD supply. For minimum leakage, RESETn should not exceed the voltage at DVDD.

4.3 General Operating Conditions

Table 4.2. General Operating Conditions

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Operating ambient temperature range	T_A	-G temperature grade [1]	-40	—	+85	°C
		-I temperature grade [1]	-40	—	+125	° C
DVDD supply voltage	V_{DVDD}	EM0/1	1.71	3.3	3.8	V
		EM2/3/4[2]	1.71	3.3	3.8	V
AVDD supply voltage	V_{AVDD}		1.71	3.3	3.8	V
IOVDD operating supply voltage	V_{IOVDD}		1.71	3.3	3.8	V
PAVDD operating supply voltage	V_{PAVDD}		1.71	3.3	3.8	V
VREGVDD operating supply voltage	$V_{VREGVDD}$	DCDC in regulation	2.2	3.3	3.8	V
		DCDC in bypass 60 mA load	1.8	3.3	3.8	V
		DCDC in bypass 120 mA load	1.9	3.3	3.8	V
		DCDC not in use. DVDD externally shorted to VREGVDD	1.71	3.3	3.8	V
RFVDD operating supply voltage	V_{RFVDD}		1.71	3.3	V_{PAVDD}	V
DECOUPLE output capacitor[3]	$C_{DECOUPLE}$	1.0 µF ± 10% X8L capacitor used for performance characterization.	0.75	1.0	2.75	µF
HCLK and SYSCLK frequency	f_{HCLK}	VSCALE2, MODE = WS1	—	—	78	MHz
		VSCALE2, MODE = WS0	—	—	40	MHz
		VSCALE1, MODE = WS1	—	—	40	MHz
		VSCALE1, MODE = WS0	—	—	20	MHz
PCLK frequency	f_{PCLK}	VSCALE2 or VSCALE1	—	—	40	MHz
EM01 Group A clock frequency	$f_{EM01GRPACLK}$	VSCALE2	—	—	80	MHz
		VSCALE1	—	—	40	MHz
EM01 Group C clock frequency	$f_{EM01GRPCCLK}$	VSCALE2	—	—	80	MHz
		VSCALE1	—	—	40	MHz
HCLK Radio frequency[4]	f_{RHCLK}	VSCALE2 or VSCALE1	—	39.0	40	MHz
DPLL Reference Clock	$f_{DPLLREFCLK}$	VSCALE2 or VSCALE1	—	—	40	MHz

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. The device may operate continuously at the maximum allowable ambient T_A rating as long as the absolute maximum T_{JMAX} is not exceeded. For an application with significant power dissipation, the allowable T_A may be lower than the maximum T_A rating. T_A = T_{JMAX} - ($THETA_{JA}$ x PowerDissipation). Refer to the Absolute Maximum Ratings table and the Thermal Characteristics table for T_{JMAX} and $THETA_{JA}$.
2. The DVDD supply is monitored by the DVDD BOD in EM0/1 and the LE DVDD BOD in EM2/3/4.
3. The system designer should consult the characteristic specs of the capacitor used on DECOUPLE to ensure its capacitance value stays within the specified bounds across temperature and DC bias.
4. The recommended radio crystal frequency for the sub-GHz radio is 39.0 MHz. The minimum and maximum RHCLK frequency in this table represent the design timing limits, which are much wider than the typical crystal tolerance.

4.4 DC-DC Converter

Test conditions: L_{DCDC} = 2.2 µH (Samsung CIG22H2R2MNE), C_{DCDC} = 4.7 µF (TDK CGA5L3X8R1C475K160AB), $V_{VREGVDD}$ = 3.3 V, V_{OUT} = 1.8 V, IPKVAL in EM0/1 modes is set to 150 mA, and in EM2/3 modes is set to 90 mA, unless otherwise indicated.

Table 4.3. DC-DC Converter

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Input voltage range at VREGVDD pin	$V_{VREGVDD}$	DCDC in regulation, I_{LOAD} = I_{LOAD} MAX[1], EM0/EM1 mode	2.2	—	3.8	V
		DCDC in regulation, I_{LOAD} = 5 mA, EM0/EM1 or EM2/EM3 mode	1.8	—	3.8	V
		Bypass Mode, I_{LOAD} ≤ 60 mA	1.8	—	3.8	V
		Bypass Mode, I_{LOAD} ≤ 120 mA	1.9	—	3.8	V
Regulated output voltage	V_{OUT}		—	1.8	—	V
Regulation DC accuracy	ACC_{DC}	$V_{VREGVDD}$ ≥ 2.2 V, Steady state in EM0/EM1 mode or EM2/EM3 mode	-2.5	—	4.0	%
Regulation total accuracy	ACC_{TOT}	All error sources (including DC errors, overshoot, undershoot)	-5	—	7	%
Steady-state output ripple	V_R	I_{LOAD} = 20 mA in EM0/EM1 mode	—	12	—	mVpp
DC line regulation	V_{REG}	I_{LOAD} = I_{LOAD} MAX[2]in EM0/EM1 mode, $V_{VREGVDD}$ ≥ 2.2 V	—	-2.6	—	mV/V
Efficiency	EFF	Load current between 100 µA and 60 mA in EM0/EM1 mode	—	90	—	%
		Load current between 10 µA and 5 mA in EM2/EM3 mode	—	89	—	%
DC load regulation	I_{REG}	Load current between 100 µA and I_{LOAD} MAX[2] in EM0/EM1 mode	—	-0.08	—	mV/mA
Output load current	I_{LOAD}	EM0/EM1 mode, DCDC in regulation, DCDC_EM01CTRL0.IPKVAL = 9, Pulse-pairing disabled, Radio not transmitting[2]	—	—	60	mA
		EM0/EM1 mode, DCDC in regulation, Radio in receive mode, with pulse-pairing enabled [2]	—	—	36	mA
		EM0/EM1 mode, DCDC in regulation, Radio transmitting[1]	—	—	120	mA
		EM2/EM3 mode, DCDC in regulation	—	—	5	mA
		Bypass mode, 1.8 V ≤ $V_{VREGVDD}$ ≤ 3.8 V	—	—	60	mA
		Bypass mode, 1.9 V ≤ $V_{VREGVDD}$ ≤ 3.8 V	—	—	120	mA
Nominal output capacitor	C_{DCDC}	4.7 µF ± 10% X7R capacitor used for performance characterization[3]	—	4.7	10	µF
Nominal inductor	L_{DCDC}	± 20% tolerance	—	2.2	—	µH

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Nominal input capacitor	C_{IN}		C_{DCDC}	—	—	µF
Resistance in bypass mode	R_{BYP}	Bypass switch from VREGVDD to DVDD, $V_{VREGVDD}$ = 1.8 V	—	0.45	0.8	Ω
		Powertrain PFET switch from VREGVDD to VREGSW, $V_{VREGVDD}$ = 1.8 V	—	0.6	0.9	Ω
Supply monitor threshold programming range	V_{CMP_RNG}	Programmable in 0.1 V steps	2	—	2.3	V
Supply monitor threshold accuracy	V_{CMP_ACC}	Supply falling edge trip point	-5	—	5	%
Supply monitor threshold hysteresis	V_{CMP_HYST}	Positive hysteresis on the supply rising edge referred to the falling edge trip point	—	4	—	%
Supply monitor response time	t_{CMP_DELAY}	Supply falling edge at -100 mV / µs	—	0.6	—	µs

Note:

1. During radio transmit operations, the RAIL library will place the DCDC into a mode that increases the maximum load current, to support higher TX output power supplied from the DCDC converter.
2. Pulse-pairing is an optional feature to improve performance at radio frequencies below 550 MHz, but has limited output current. It is enabled by default when using RAIL with an IPKVAL setting of 3 or less. Pulse pairing may be disabled from application code by setting IPKVAL > 3. This must be done before RAIL software is initialized.
3. TDK CGA5L3X8R1C475K160AB used for performance characterization. Actual capacitor values can be significantly de-rated from their specified nominal value by the rated tolerance, as well as the application's AC voltage, DC bias, and temperature. The minimum capacitance counting all error sources should be no less than 3.6 µF.

4.4.1 Buck DC-DC Minimum Input

The minimum input voltage for the DC-DC in EM0/EM1 mode is a function of the maximum load current, and the peak current setting. Figure 4.1 Transient maximum load current vs. Minimum input voltage on page 27 shows the max load current vs. input voltage for different DC-DC peak inductor current settings.

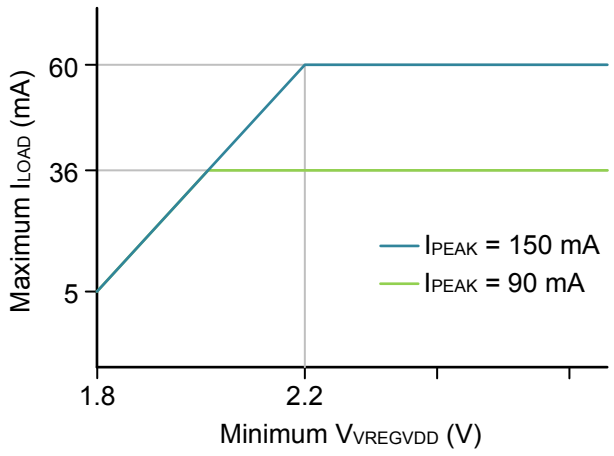

Figure 4.1. Transient maximum load current vs. Minimum input voltage

4.5 Thermal Characteristics

Table 4.4. Thermal Characteristics, 68QFN

Package	Board	Parameter	Symbol	Test Condition	Value	Unit
68QFN (8x8 mm)	JEDEC 4-Layer High Thermal Cond. (JESD51-7)[1]	Thermal Resistance, Junction to Ambient	Θ_{JA}	Still Air (JEDS51-2A)	28.4	°C/W
		Thermal Resistance, Junction to Top Center	Ψ_{JT}		0.82	°C/W
		Thermal Resistance, Junction to Board	Ψ_{JB}		8.9	°C/W
		Thermal Resistance, Junction to Board	Θ_{JB}	Junction to Board (JESD51-8)	8.9	°C/W
	JEDEC - Low Thermal Cond. (JESD51-3)[2]	Thermal Resistance, Junction to Ambient	Θ_{JA}	Still Air (JEDS51-2A)	54.2	°C/W
		Thermal Resistance, Junction to Top Center	Ψ_{JT}		1.1	°C/W
		Thermal Resistance, Junction to Board	Ψ_{JB}		37	°C/W
	No Board	Thermal Resistance, Junction to Case	Θ_{JC}	Temperature controlled heat sink on top of package, all other sides of package insulated to prevent heat flow, per JESD51-14.	12.6	°C/W

Note:

1. PCB Center Land with 9 Via to top internal plane of PCB per JESD51- 5.
2. Based on 2 layer PCB with dimension 3" x 4.5", PCB Thickness of 1.6 mm.

Table 4.5. Thermal Characteristics, 48QFN

Package	Board	Parameter	Symbol	Test Condition	Value	Unit
48QFN (6x6 mm)	JEDEC 4-Layer High Thermal Cond. (JESD51-7)[1]	Thermal Resistance, Junction to Ambient	Θ_{JA}	Still Air (JEDS51-2A)	25.9	°C/W
		Thermal Resistance, Junction to Top Center	Ψ_{JT}		0.17	°C/W
		Thermal Resistance, Junction to Board	Ψ_{JB}		6.8	°C/W
		Thermal Resistance, Junction to Board	Θ_{JB}	Junction to Board (JESD51-8)	12	°C/W
	JEDEC - Low Thermal Cond. (JESD51-3)[2]	Thermal Resistance, Junction to Ambient	Θ_{JA}	Still Air (JEDS51-2A)	95.5	°C/W
		Thermal Resistance, Junction to Top Center	Ψ_{JT}		0.66	°C/W
		Thermal Resistance, Junction to Board	Ψ_{JB}		6.8	°C/W
	No Board	Thermal Resistance, Junction to Case	Θ_{JC}	Temperature controlled heat sink on top of package, all other sides of package insulated to prevent heat flow, per JESD51-14.	20	°C/W

Note:

1. PCB Center Land with 9 Via to top internal plane of PCB per JESD51- 5.
2. Based on 2 layer PCB with dimension 3" x 4.5", PCB Thickness of 1.6 mm.

4.6 Current Consumption

4.6.1 MCU current consumption using DC-DC at 3.3 V input

Unless otherwise indicated, typical conditions are: VREGVDD = 3.3 V. AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V from DC-DC. Voltage scaling level = VSCALE1. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.6. MCU current consumption using DC-DC at 3.3 V input

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in EM0 mode with all peripherals disabled	I_{ACTIVE}	78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running Prime from flash, VSCALE2	—	31	—	µA/MHz
		78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running while loop from flash, VSCALE2	—	32	—	µA/MHz
		78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running CoreMark loop from flash, VSCALE2	—	45	—	µA/MHz
		39 MHz crystal, CPU running Prime from flash	—	33	—	µA/MHz
		39 MHz crystal, CPU running while loop from flash	—	33	—	µA/MHz
		39 MHz crystal, CPU running CoreMark loop from flash	—	46	—	µA/MHz
		38 MHz HFRCO, CPU running while loop from flash	—	29	—	µA/MHz
		26 MHz HFRCO, CPU running while loop from flash	—	33	—	µA/MHz
		16 MHz HFRCO, CPU running while loop from flash	—	42	—	µA/MHz
		1 MHz HFRCO, CPU running while loop from flash	—	378	—	µA/MHz
Current consumption in EM1 mode with all peripherals disabled	I_{EM1}	78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, VSCALE2	—	21	—	µA/MHz
		39 MHz crystal	—	23	—	µA/MHz
		38 MHz HFRCO	—	19	—	µA/MHz
		26 MHz HFRCO	—	24	—	µA/MHz
		16 MHz HFRCO	—	32	—	µA/MHz
		1 MHz HFRCO	—	369	—	µA/MHz

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in EM2 mode, VSCALE0	I_{EM2_VS}	256 kB RAM and full Radio RAM retention, RTC running from LFXO	—	2.8	—	µA
		256 kB RAM and full Radio RAM retention, RTC running from LFRCO	—	2.8	—	µA
		16 kB RAM and full Radio RAM retention, RTC running from LFXO	—	1.3	—	µA
		16 kB RAM and full Radio RAM retention, RTC running from LFRCO	—	1.3	—	µA
Current consumption in EM3 mode, VSCALE0	I_{EM3_VS}	256 kB RAM and full Radio RAM retention, RTC running from ULFRCO	—	2.6	—	µA
		16 kB RAM and full Radio RAM retention, RTC running from ULFRCO	—	1.1	—	µA
Change in current consumption if CPU cached unretained in EM2 or EM3	$I_{EM23_CPUCACHE}$		—	0.06	—	µA
Change in current consumption if EM0/1 peripheral states unretained in EM2 or EM3	$I_{EM23_STATERET}$		—	0.02	—	µA
Change in current consumption for retained RAM bank in EM2 or EM3	I_{EM23_RAM}	Per 16 kB RAM bank	—	0.10	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0B is enabled[1]	I_{PD0B_VS}		—	0.95	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0C is enabled[1]	I_{PD0C_VS}		—	0.15	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0D is enabled[1]	I_{PD0D_VS}		—	1.12	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0E is enabled[1]	I_{PD0E_VS}		—	0.06	—	µA

Note:

1. Extra current consumed by power domain. Does not include current associated with the enabled peripherals. See 3.10.4 Power Domains for a list of the peripherals in each power domain. Note that if the PD0B, PD0C, or PD0D domains are enabled, PD0E will also automatically be enabled.

4.6.2 MCU current consumption at 3.3 V

Unless otherwise indicated, typical conditions are: AVDD = DVDD = RFVDD = PAVDD = VREGVDD = 3.3 V. DC-DC not used. Voltage scaling level = VSCALE1. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.7. MCU current consumption at 3.3 V

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in EM0 mode with all peripherals disabled	I_{ACTIVE}	78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running Prime from flash, VSCALE2	—	49	—	µA/MHz
		78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running while loop from flash, VSCALE2	—	49	—	µA/MHz
		78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running CoreMark loop from flash, VSCALE2	—	70	—	µA/MHz
		39 MHz crystal, CPU running Prime from flash	—	51	—	µA/MHz
		39 MHz crystal, CPU running while loop from flash	—	52	—	µA/MHz
		39 MHz crystal, CPU running CoreMark loop from flash	—	73	—	µA/MHz
		38 MHz HFRCO, CPU running while loop from flash	—	45	79	µA/MHz
		26 MHz HFRCO, CPU running while loop from flash	—	52	—	µA/MHz
		16 MHz HFRCO, CPU running while loop from flash	—	66	—	µA/MHz
		1 MHz HFRCO, CPU running while loop from flash	—	590	1900	µA/MHz
Current consumption in EM1 mode with all peripherals disabled	I_{EM1}	78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, VSCALE2	—	34	—	µA/MHz
		39 MHz crystal	—	37	—	µA/MHz
		38 MHz HFRCO	—	30	68	µA/MHz
		26 MHz HFRCO	—	37	—	µA/MHz
		16 MHz HFRCO	—	51	—	µA/MHz
		1 MHz HFRCO	—	576	1850	µA/MHz

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in EM2 mode, VSCALE0	I_{EM2_VS}	256 kB RAM and full Radio RAM retention, RTC running from LFXO	—	4.4	—	µA
		256 kB RAM and full Radio RAM retention, RTC running from LFRCO	—	4.4	7.9	µA
		16 kB RAM and full Radio RAM retention, RTC running from LFXO	—	2.0	—	µA
		16 kB RAM and full Radio RAM retention, RTC running from LFRCO	—	2.0	—	µA
Current consumption in EM3 mode, VSCALE0	I_{EM3_VS}	256 kB RAM and full Radio RAM retention, RTC running from ULFRCO	—	4.0	—	µA
		16 kB RAM and full Radio RAM retention, RTC running from ULFRCO	—	1.7	3.3	µA
Change in current consumption if CPU cached unretained in EM2 or EM3	$I_{EM23_CPUCACHE}$		—	0.1	—	µA
Change in current consumption if EM0/1 peripheral states unretained in EM2 or EM3	$I_{EM23_STATERET}$		—	0.025	—	µA
Change in current consumption for retained RAM bank in EM2 or EM3	I_{EM23_RAM}	Per 16 kB RAM bank	—	0.16	—	µA
Current consumption in EM4 mode	I_{EM4}	No BURTC, no LF oscillator	—	0.31	0.65	µA
		BURTC with LFXO	—	0.71	—	µA
Current consumption during reset	I_{RST}	Hard pin reset held	—	473	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0B is enabled[1]	I_{PD0B_VS}		—	1.48	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0C is enabled[1]	I_{PD0C_VS}		—	0.23	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0D is enabled[1]	I_{PD0D_VS}		—	1.75	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0E is enabled[1]	I_{PD0E_VS}		—	0.10	—	µA

Note:

1. Extra current consumed by power domain. Does not include current associated with the enabled peripherals. See 3.10.4 Power Domains for a list of the peripherals in each power domain. Note that if the PD0B, PD0C, or PD0D domains are enabled, PD0E will also automatically be enabled.

4.6.3 MCU current consumption at 1.8 V

Unless otherwise indicated, typical conditions are: AVDD = DVDD = RFVDD = PAVDD = VREGVDD = 1.8 V. DC-DC not used. Voltage scaling level = VSCALE1. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.8. MCU current consumption at 1.8 V

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in EM0 mode with all peripherals disabled	I_{ACTIVE}	78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running Prime from flash, VSCALE2	—	48	—	µA/MHz
		78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running while loop from flash, VSCALE2	—	49	—	µA/MHz
		78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, CPU running CoreMark loop from flash, VSCALE2	—	70	—	µA/MHz
		39 MHz crystal, CPU running Prime from flash	—	51	—	µA/MHz
		39 MHz crystal, CPU running while loop from flash	—	52	—	µA/MHz
		39 MHz crystal, CPU running CoreMark loop from flash	—	72	—	µA/MHz
		38 MHz HFRCO, CPU running while loop from flash	—	45	—	µA/MHz
		26 MHz HFRCO, CPU running while loop from flash	—	52	—	µA/MHz
		16 MHz HFRCO, CPU running while loop from flash	—	65	—	µA/MHz
		1 MHz HFRCO, CPU running while loop from flash	—	582	—	µA/MHz
Current consumption in EM1 mode with all peripherals disabled	I_{EM1}	78 MHz HFRCO w/ DPLL referenced to 39 MHz crystal, VSCALE2	—	33	—	µA/MHz
		39 MHz crystal	—	37	—	µA/MHz
		38 MHz HFRCO	—	30	—	µA/MHz
		26 MHz HFRCO	—	36	—	µA/MHz
		16 MHz HFRCO	—	50	—	µA/MHz
		1 MHz HFRCO	—	568	—	µA/MHz

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in EM2 mode, VSCALE0	I_{EM2_VS}	256 kB RAM and full Radio RAM retention, RTC running from LFXO	—	4.2	—	µA
		256 kB RAM and full Radio RAM retention, RTC running from LFRCO	—	4.2	—	µA
		16 kB RAM and full Radio RAM retention, RTC running from LFXO	—	1.8	—	µA
		16 kB RAM and full Radio RAM retention, RTC running from LFRCO	—	1.8	—	µA
Current consumption in EM3 mode, VSCALE0	I_{EM3_VS}	256 kB RAM and full Radio RAM retention, RTC running from ULFRCO	—	3.9	—	µA
		16 kB RAM and full Radio RAM retention, RTC running from ULFRCO	—	1.5	—	µA
Change in current consumption if CPU cached unretained in EM2 or EM3	$I_{EM23_CPUCACHE}$		—	0.1	—	µA
Change in current consumption if EM0/1 peripheral states unretained in EM2 or EM3	$I_{EM23_STATERET}$		—	0.025	—	µA
Change in current consumption for retained RAM bank in EM2 or EM3	I_{EM23_RAM}	Per 16 kB RAM bank	—	0.16	—	µA
Current consumption in EM4 mode	I_{EM4}	No BURTC, no LF oscillator	—	0.16	—	µA
		BURTC with LFXO	—	0.51	—	µA
Current consumption during reset	I_{RST}	Hard pin reset held	—	392	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0B is enabled[1]	I_{PD0B_VS}		—	1.48	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0C is enabled[1]	I_{PD0C_VS}		—	0.23	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0D is enabled[1]	I_{PD0D_VS}		—	1.75	—	µA
Additional current in EM2 or EM3 when any peripheral in PD0E is enabled[1]	I_{PD0E_VS}		—	0.11	—	µA

Note:

1. Extra current consumed by power domain. Does not include current associated with the enabled peripherals. See 3.10.4 Power Domains for a list of the peripherals in each power domain. Note that if the PD0B, PD0C, or PD0D domains are enabled, PD0E will also automatically be enabled.

4.6.4 Radio current consumption at 3.3 V with DCDC

RF current consumption measured with HCLK = 39 MHz, and all MCU peripherals disabled. Unless otherwise indicated, typical conditions are: VREGVDD = 3.3 V. AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V from DC-DC. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.9. Radio current consumption at 3.3 V with DCDC

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in receive mode for proprietary Sub-GHz operation, active packet reception, VSCALE1, EM1P	$I_{RX_ACTIVE_SUBG}$	f = 924 MHz, 4-GFSK, 400 kbps	—	4.4	—	mA
		f = 915 MHz, 2-GFSK, 2 Mbps	—	5.4	—	mA
		f = 915 MHz, O-QPSK, 4.8 kbps	—	4.0	—	mA
		f = 915 MHz, FSK, 50 kbps	—	4.2	—	mA
		f = 915 MHz, O-QPSK, 250 kbps	—	5.6	—	mA
		f = 868 MHz, 2-GFSK, 2.4 kbps	—	3.9	—	mA
		f = 868 MHz, 2-GFSK, 38.4 kbps	—	3.9	—	mA
		f = 868 MHz, GMSK, 500 kbps	—	4.5	—	mA
		f = 868 MHz, O-QPSK, 100 kbps	—	4.5	—	mA
		f = 433 MHz, 2-GFSK, 100 kbps	—	4.2	—	mA
Current consumption in receive mode for Amazon Sidewalk operation, active packet reception, VSCALE1, EM1P	$I_{RX_ACTIVE_ASW}$	f = 915 MHz, 2-GFSK, 50 kbps	—	4.2	—	mA
Current consumption in receive mode for BLE operation, active packet reception, VSCALE1, EM1P	$I_{RX_ACTIVE_BLE}$	f = 2.4 GHz, 2GFSK, 1 Mbit/s	—	5.2	—	mA
		f = 2.4 GHz, 2GFSK, 2 Mbit/s	—	5.9	—	mA
Current consumption in receive mode for proprietary Sub-GHz operation, listening for packet, VSCALE1, EM1P	$I_{RX_LISTEN_SUBG}$	f = 924 MHz, 4-GFSK, 400 kbps	—	4.4	—	mA
		f = 915 MHz, 2-GFSK, 2 Mbps	—	5.5	—	mA
		f = 915 MHz, O-QPSK, 4.8 kbps	—	4.0	—	mA
		f = 915 MHz, FSK, 50 kbps	—	4.2	—	mA
		f = 915 MHz, O-QPSK, 250 kbps	—	6.0	—	mA
		f = 868 MHz, 2-GFSK, 2.4 kbps	—	3.9	—	mA
		f = 868 MHz, 2-GFSK, 38.4 kbps	—	3.9	—	mA
		f = 868 MHz, GMSK, 500 kbps	—	4.5	—	mA
		f = 868 MHz, O-QPSK, 100 kbps	—	4.5	—	mA
		f = 433 MHz, 2-GFSK, 100 kbps	—	4.2	—	mA
Current consumption in receive mode for Amazon Sidewalk operation, listening for packet, VSCALE1, EM1P	$I_{RX_LISTEN_ASW}$	f = 915 MHz, 2-GFSK, 50 kbps	—	4.2	—	mA
Current consumption in receive mode for BLE operation, listening for packet, VSCALE1, EM1P	$I_{RX_LISTEN_BLE}$	f = 2.4 GHz, 2GFSK, 1 Mbit/s	—	5.1	—	mA
		f = 2.4 GHz, 2GFSK, 2 Mbit/s	—	5.9	—	mA

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in transmit mode for proprietary Sub-GHz operation, VSCALE2, EM1	I_{TX_SUBG}	f = 868 MHz, CW, 14 dBm PA, 0 dBm output power[1]	—	8.2	—	mA
		f = 868 MHz, CW, 14 dBm PA,10 dBm output power[1]	—	13.8	—	mA
		f = 868.3 MHz, CW, 14 dBm PA, 14 dBm output power[2]	—	25.8	—	mA
		f = 869.5 MHz, CW, 20 dBm PA, 20 dBm output power[3], PAVDD = 3.3 V, Sub-GHz OPNs only	—	84.8	—	mA
		f = 869.5 MHz, CW, 20 dBm PA, 20 dBm output power[3], PAVDD = 3.3 V, Dual-band OPNs only	—	90.6	—	mA
		f = 915 MHz, CW, 14 dBm PA,14 dBm output power[2]	—	25.7	—	mA
		f = 915 MHz, CW, 20 dBm PA,20 dBm output power[3], PAVDD = 3.3 V, Sub-GHz OPNs only	—	81.8	—	mA
		f = 915 MHz, CW, 20 dBm PA,20 dBm output power[3], PAVDD = 3.3 V, Dual-band OPNs only	—	91.2	—	mA
Current consumption in transmit mode for BLE operation, VSCALE2, EM1	I_{TX_BLE}	f = 2.4 GHz, CW, 0 dBm output power[4]	—	12.3	—	mA
		f = 2.4 GHz, CW, 0 dBm output power[4], PAVDD = 3.3V	—	14.8	—	mA
		f = 2.4 GHz, CW, 10 dBm output power[4]	—	23.2	—	mA
		f = 2.4 GHz, CW, 10 dBm output power[4], PAVDD = 3.3V	—	30.3	—	mA

Note:

1. Using the +10 dBm matching network for 868/915/920 MHz Bands.
2. Using the +14 dBm matching network for 868/915/920 MHz Bands.
3. Using the +20 dBm matching network for 868/915/920 MHz Bands.
4. Using the +10 dBm matching network for BLE.

4.6.5 Radio current consumption at 3.3 V

RF current consumption measured with HCLK = 39 MHz, and all MCU peripherals disabled. Unless otherwise indicated, typical conditions are: AVDD = DVDD = IOVDD = RFVDD = PAVDD = 3.3 V. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.10. Radio current consumption at 3.3 V

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in receive mode for proprietary Sub-GHz operation, active packet reception, VSCALE1, EM1P	$I_{RX_ACTIVE_SUBG}$	f = 924 MHz, 4-GFSK, 400 kbps	—	7.2	—	mA
		f = 915 MHz, 2-GFSK, 2 Mbps	—	8.9	—	mA
		f = 915 MHz, O-QPSK, 4.8 kbps	—	6.6	—	mA
		f = 915 MHz, FSK, 50 kbps	—	6.9	—	mA
		f = 915 MHz, O-QPSK, 250 kbps	—	9.2	—	mA
		f = 868 MHz, 2-GFSK, 2.4 kbps	—	6.4	—	mA
		f = 868 MHz, 2-GFSK, 38.4 kbps	—	6.5	—	mA
		f = 868 MHz, GMSK, 500 kbps	—	7.3	—	mA
		f = 868 MHz, O-QPSK, 100 kbps	—	7.4	—	mA
		f = 433 MHz, 2-GFSK, 100 kbps	—	6.9	—	mA
Current consumption in receive mode for Amazon Sidewalk operation, active packet reception, VSCALE1, EM1P	$I_{RX_ACTIVE_ASW}$	f = 915 MHz, 2-GFSK, 50 kbps	—	6.9	—	mA
Current consumption in receive mode for BLE operation, active packet reception, VSCALE1, EM1P	$I_{RX_ACTIVE_BLE}$	f = 2.4 GHz, 2GFSK, 1 Mbit/s	—	9.0	—	mA
		f = 2.4 GHz, 2GFSK, 2 Mbit/s	—	10.2	—	mA
Current consumption in receive mode for proprietary Sub-GHz operation, listening for packet, VSCALE1, EM1P	$I_{RX_LISTEN_SUBG}$	f = 924 MHz, 4-GFSK, 400 kbps	—	7.3	—	mA
		f = 915 MHz, 2-GFSK, 2 Mbps	—	9.1	—	mA
		f = 915 MHz, O-QPSK, 4.8 kbps	—	6.5	—	mA
		f = 915 MHz, FSK, 50 kbps	—	6.9	—	mA
		f = 915 MHz, O-QPSK, 250 kbps	—	9.8	—	mA
		f = 868 MHz, 2-GFSK, 2.4 kbps	—	6.4	—	mA
		f = 868 MHz, 2-GFSK, 38.4 kbps	—	6.4	—	mA
		f = 868 MHz, GMSK, 500 kbps	—	7.4	—	mA
		f = 868 MHz, O-QPSK, 100 kbps	—	7.4	—	mA
		f = 433 MHz, 2-GFSK, 100 kbps	—	7.0	—	mA
Current consumption in receive mode for Amazon Sidewalk operation, listening for packet, VSCALE1, EM1P	$I_{RX_LISTEN_ASW}$	f = 915 MHz, 2-GFSK, 50 kbps	—	7.0	—	mA
Current consumption in receive mode for BLE operation, listening for packet, VSCALE1, EM1P	$I_{RX_LISTEN_BLE}$	f = 2.4 GHz, 2GFSK, 1 Mbit/s	—	8.9	—	mA
		f = 2.4 GHz, 2GFSK, 2 Mbit/s	—	10.1	—	mA

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in transmit mode for proprietary Sub-GHz operation, VSCALE2, EM1	I_{TX_SUBG}	f = 868 MHz, CW, 14 dBm PA, 0 dBm output power[1]	—	13.6	—	mA
		f = 868 MHz, CW, 14 dBm PA,10 dBm output power[1]	—	22.5	—	mA
		f = 868.3 MHz, CW, 14 dBm PA, 14 dBm output power[2]	—	42.1	—	mA
		f = 869.5 MHz, CW, 20 dBm PA, 14 dBm output power[3]	—	50.7	—	mA
		f = 869.5 MHz, CW, 20 dBm PA, 20 dBm output power[3], Sub-GHz OPNs only	—	90.6	—	mA
		f = 869.5 MHz, CW, 20 dBm PA, 20 dBm output power[3], Dual-band OPNs only	—	97.1	—	mA
		f = 915 MHz, CW, 14 dBm PA,14 dBm output power[2]	—	41.9	—	mA
		f = 915 MHz, CW, 20 dBm PA,14 dBm output power[3]	—	51.8	—	mA
		f = 915 MHz, CW, 20 dBm PA,20 dBm output power[3], Sub-GHz OPNs only	—	87.9	—	mA
		f = 915 MHz, CW, 20 dBm PA,20 dBm output power[3], Dual-band OPNs only	—	98	—	mA
Current consumption in transmit mode for BLE operation, VSCALE2, EM1	I_{TX_BLE}	f = 2.4 GHz, CW, 0 dBm output power[4]	—	20	—	mA
		f = 2.4 GHz, CW, 10 dBm output power[4]	—	38	—	mA

Note:

1. Using the +10 dBm matching network for 868/915/920 MHz Bands.
2. Using the +14 dBm matching network for 868/915/920 MHz Bands.
3. Using the +20 dBm matching network for 868/915/920 MHz Bands.
4. Using the +10 dBm matching network for BLE.

4.6.6 Radio current consumption at 1.8 V

RF current consumption measured with HCLK = 39 MHz, and all MCU peripherals disabled. Unless otherwise indicated, typical conditions are: AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation at T_A = 25 °C.

Table 4.11. Radio current consumption at 1.8 V

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in receive mode for proprietary Sub-GHz operation, active packet reception, VSCALE1, EM1P	$I_{RX_ACTIVE_SUBG}$	f = 924 MHz, 4-GFSK, 400 kbps	—	7.2	—	mA
		f = 915 MHz, 2-GFSK, 2 Mbps	—	8.9	—	mA
		f = 915 MHz, O-QPSK, 4.8 kbps	—	6.5	—	mA
		f = 915 MHz, FSK, 50 kbps	—	6.9	—	mA
		f = 915 MHz, O-QPSK, 250 kbps	—	9.1	—	mA
		f = 868 MHz, 2-GFSK, 2.4 kbps	—	6.4	—	mA
		f = 868 MHz, 2-GFSK, 38.4 kbps	—	6.4	—	mA
		f = 868 MHz, GMSK, 500 kbps	—	7.3	—	mA
		f = 868 MHz, O-QPSK, 100 kbps	—	7.4	—	mA
		f = 433 MHz, 2-GFSK, 100 kbps	—	6.9	—	mA
Current consumption in receive mode for BLE operation, active packet reception, VSCALE1, EM1P	$I_{RX_ACTIVE_BLE}$	f = 2.4 GHz, 2GFSK, 1 Mbit/s	—	9.0	—	mA
		f = 2.4 GHz, 2GFSK, 2 Mbit/s	—	10.2	—	mA
Current consumption in receive mode for proprietary Sub-GHz operation, listening for packet, VSCALE1, EM1P	$I_{RX_LISTEN_SUBG}$	f = 924 MHz, 4-GFSK, 400 kbps	—	7.3	—	mA
		f = 915 MHz, 2-GFSK, 2 Mbps	—	9.1	—	mA
		f = 915 MHz, O-QPSK, 4.8 kbps	—	6.5	—	mA
		f = 915 MHz, FSK, 50 kbps	—	6.9	—	mA
		f = 915 MHz, O-QPSK, 250 kbps	—	9.8	—	mA
		f = 868 MHz, 2-GFSK, 2.4 kbps	—	6.5	—	mA
		f = 868 MHz, 2-GFSK, 38.4 kbps	—	6.5	—	mA
		f = 868 MHz, GMSK, 500 kbps	—	7.4	—	mA
		f = 868 MHz, O-QPSK, 100 kbps	—	7.4	—	mA
		f = 433 MHz, 2-GFSK, 100 kbps	—	7.0	—	mA
Current consumption in receive mode for BLE operation, listening for packet, VSCALE1, EM1P	$I_{RX_LISTEN_BLE}$	f = 2.4 GHz, 2GFSK, 1 Mbit/s	—	8.9	—	mA
		f = 2.4 GHz, 2GFSK, 2 Mbit/s	—	10.1	—	mA
Current consumption in transmit mode for proprietary Sub-GHz operation, VSCALE2, EM1	I_{TX_SUBG}	f = 868 MHz, CW, 14 dBm PA, 0 dBm output power[1]	—	13.4	—	mA
		f = 868 MHz, CW, 14 dBm PA,10 dBm output power[1]	—	22.5	—	mA
		f = 868.3 MHz, CW, 14 dBm PA, 14 dBm output power[2]	—	42.0	—	mA
		f = 915 MHz, CW, 14 dBm PA,14 dBm output power[2]	—	41.8	—	mA

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Current consumption in transmit mode for BLE operation, VSCALE2, EM1	I_{TX_BLE}	f = 2.4 GHz, CW, 0 dBm output power[3]	—	19.9	—	mA
		f = 2.4 GHz, CW, 10 dBm output power[3]	—	37.8	—	mA

Note:
1. Using the +10 dBm matching network for 868/915/920 MHz Bands.
2. Using the +14 dBm matching network for 868/915/920 MHz Bands.
3. Using the +10 dBm matching network for BLE.

4.7 Energy Mode Wake-up and Entry Times

Unless otherwise specified, these times are measured using the HFRCO at 19 MHz, with the DPLL disabled.

Table 4.12. Energy Mode Wake-up and Entry Times

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Wake-up Time from EM1	t_{EM1_WU}	Code execution from flash	—	3	—	HCLKs
		Code execution from RAM	—	1.43	—	µs
Wake-up Time from EM2	t_{EM2_WU}	Code execution from flash, No Voltage Scaling	—	13.1	—	µs
		Code execution from RAM, No Voltage Scaling	—	5.3	—	µs
		Voltage scaling up one level[1]	—	37.7	—	µs
		Voltage scaling up two levels[2]	—	50.0	—	µs
Wake-up Time from EM3	t_{EM3_WU}	Code execution from flash, No Voltage Scaling	—	13.1	—	µs
		Code execution from RAM, No Voltage Scaling	—	5.3	—	µs
		Voltage scaling up one level[1]	—	37.7	—	µs
		Voltage scaling up two levels[2]	—	50.0	—	µs
Wake-up Time from EM4	t_{EM4_WU}	Code execution from flash	—	21.3	—	ms
Entry time to EM1	t_{EM1_ENT}	Code execution from flash	—	1.22	—	µs
Entry time to EM2	t_{EM2_ENT}	Code execution from flash	—	6.1	—	µs
Entry time to EM3	t_{EM3_ENT}	Code execution from flash	—	6.1	—	µs
Entry time to EM4	t_{EM4_ENT}	Code execution from flash	—	11.0	—	µs
Voltage scaling time in EM0[3]	t_{SCALE}	Up from VSCALE1 to VSCALE2	—	32	—	µs
		Down from VSCALE2 to VSCALE1	—	172	—	µs

Note:
1. Voltage scaling one level is between VSCALE0 and VSCALE1 or between VSCALE1 and VSCALE2.
2. Voltage scaling two levels is between VSCALE0 and VSCALE2.
3. During voltage scaling in EM0, RAM is inaccessible and processor will be halted until complete.

4.8 Flash Characteristics

Table 4.13. Flash Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Flash Supply voltage during write or erase	V_{FLASH}		1.71	—	3.8	V
Flash data retention[1]	RET_{FLASH}		10	—	—	years
Flash erase cycles before failure[1]	EC_{FLASH}		10,000	—	—	cycles
Program Time	t_{PROG}	one word (32-bits)	40.3	44.4	48.5	µs
		average per word over 128 words	9.9	11.0	12.0	µs
Page Erase Time[2]	t_{PERASE}		11.8	13.2	14.6	ms
Mass Erase Time[3] [4]	t_{MERASE}	1024 kB	94	103	117	ms
Program Current	I_{WRITE}	T_A = 25 °C	—	—	2.6	mA
Page Erase Current	I_{ERASE}	T_A = 25 °C	—	—	1.6	mA
Mass Erase Current	I_{MERASE}	T_A = 25 °C	—	—	1.7	mA

Note:

1. Flash data retention information is published in the Quarterly Quality and Reliability Report.
2. Page Erase time is measured from setting the ERASEPAGE bit in the MSC_WRITECMD register until the BUSY bit in the MSC-STATUS register is cleared to 0. Internal set-up and hold times are included.
3. Mass Erase is issued by the CPU and erases all of User space.
4. Mass Erase time is measured from setting the ERASEMAIN0 bit in the MSC_WRITECMD register until the BUSY bit in the MSC-STATUS register is cleared to 0. Internal set-up and hold times are included.

4.9 Sub-GHz RF Transceiver Characteristics

4.9.1 Sub-GHz RF Transmitter Characteristics

4.9.1.1 920 MHz Band +13 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +14 dBm using the 868/915/920 MHz MHz 14 dBm matching network as shown in the typical connections section. Emissions are measured at 13 dBm and 0 dBm. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 924 MHz.

Table 4.14. 920 MHz Band +13 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		922.3	—	928.1	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD connected to DC-DC output, 14 dBm devices, 14 dBm match[1][2][3]	12.9	14.1	15.0	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-17.1	—	dBm
Output power variation vs supply at $POUT_{MAX}$	$POUT_{VAR_V}$	2.2 V < $V_{VREGVDD}$ < 3.8 V, PAVDD connected to DC-DC output, T = 25 °C	—	0.01	—	dB
Output power variation vs temperature, peak to peak	$POUT_{VAR_T}$	T_A = -40 to +85 °C with PAVDD connected to DC-DC output	—	0.4	0.7	dB
		T_A = -40 to +125 °C with PAVDD connected to DC-DC output	—	0.5	0.9	dB
Output power variation vs RF frequency	$POUT_{VAR_F}$	PAVDD connected to DC-DC output, T = 25 °C	—	0.1	0.3	dB
Adjacent Channel Power 50 kbps 2GFSK[4]	$P_{CH_ADJ_50}$	P_{OUT} = 0 dBm (1 mW), 924 MHz, 200 kHz channel spacing	—	-43.1	-26	dBm
		P_{OUT} = 13 dBm (20 mW), 924 MHz, 200 kHz channel spacing	—	-29.9	-15	dBm
Adjacent Channel Power 100 kbps 2GFSK [5]	$P_{CH_ADJ_100}$	P_{OUT} = 0 dBm (1 mW), 924 MHz, 400 kHz channel spacing	—	-45.8	-26	dBm
		P_{OUT} = 13 dBm (20 mW), 924 MHz, 400 kHz channel spacing	—	-32.7	-15	dBm
Max spurious emissions, P_{OUT} = 0 dBm (1 mW), 916MHz[6]	$SPUR_{TX_ARIB_0}$	f ≤ 710 MHz, RBW = 100 kHz	—	-73.6	-36	dBm
		710 MHz < f ≤ 900 MHz, RBW = 1 MHz[7]	—	-66.4	-55	dBm
		900 MHz < f ≤ 915 MHz, RBW = 100 kHz	—	-74.2	-55	dBm
		915 MHz < f ≤ 930 MHz, RBW = 100 kHz, (except for |f-fc| ≤ (200+100*n) kHz)[7]	—	-51.2	-36	dBm
		930 MHz < f ≤ 1000 MHz, RBW = 100 kHz	—	-75.1	-55	dBm
		1000 MHz < f ≤ 1215 MHz, RBW = 1 MHz	—	-67.2	-45	dBm
		1215 MHz < f, RBW = 1 MHz	—	-50.5	-30	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Max spurious emissions, P_{OUT} = 13 dBm (20 mW), 924 MHz[8]	$SPUR_{TX_ARIB_13}$	f ≤ 710 MHz, RBW = 100 kHz	—	-65.7	-36	dBm
		710 MHz < f ≤ 900 MHz, RBW = 1 MHz	—	-65.7	-55	dBm
		900 MHz < f ≤ 915 MHz, RBW = 100 kHz	—	-60.6	-55	dBm
		915 MHz < f ≤ 930 MHz, RBW = 100 kHz, (except for |f-fc| ≤ (200+100*n) kHz)	—	-47.3	-36	dBm
		930 MHz < f ≤ 1000 MHz, RBW = 100 kHz	—	-61.6	-55	dBm
		1000 MHz < f ≤ 1215 MHz, RBW = 1 MHz	—	-53.1	-45	dBm
		1215 MHz < f, RBW = 1 MHz	—	-50.5	-30	dBm

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. The transmit power for the 922.3 to 928.1 Band MHz is normally limited to +13 dBm (20 mW). For best efficiency at 13 dBm the 14 dBm devices are recommended with the 14 dBm match.
3. The 14 dBm match is optimized for best efficiency at 14 dBm. The maximum output power can go up to the maximum rating. Emissions for this band are tested with the output power set to 13 dBm (20 mW) and 0 dBm (1mW).
4. Measured per ARIB T108, Section 3.3,f_c = 924 MHz, 922.3 to 928.1 frequency band, 50 kbps, 2GFSK, BT = 0.5, Δf = ± 25 kHz, PN9 sequence, 200 kHz channel spacing, n = 1.
5. Measured per ARIB T108, Section 3.3,f_c = 924 MHz, 922.3 to 928.1 frequency band, 100 kbps, 2GFSK, BT = 0.5, Δf = ± 25 kHz, PN9 sequence, 400 kHz channel spacing, n = 2.
6. Measured per ARIB T108, Part 2 Section 3.2,f_c = 916 MHz, 915.9 to 916.9 frequency band, 50 kbps, 2GFSK, BT = 0.5, Δf = ± 25 kHz, PN9 sequence, 200 kHz channel spacing, n = 1.
7. Measured per ARIB TELEC-T245 5th edition per zero span method.
8. Measured per ARIB T108, Part 2 Section 3.2,f_c = 924 MHz, 922.3 to 928.1 frequency band, 50 kbps, 2GFSK, BT = 0.5, Δf = ± 25 kHz, PN9 sequence, 200 kHz channel spacing, n = 1.

4.9.1.2 915 MHz Band +20 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +20 dBm using the 868/915/920 MHz +20 dBm matching network as shown in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = 1.8 V powered from DCDC. PAVDD = 3.3V. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 915 MHz.

Table 4.15. 915 MHz Band +20 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		902	—	928	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD = 3.3V, 20 dBm devices, +20 dBm match[1] [2] [3]	19.0	20.5	21.4	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-14.7	—	dBm
Output power variation vs supply at $POUT_{MAX}$	$POUT_{VAR_V}$	1.8 V < V_{PAVDD} < 3.8 V, T = 25 °C	—	4.7	—	dB
Output power variation vs temperature, peak to peak	$POUT_{VAR_T}$	T_A = -40 to +85 °C with PAVDD = 3.3 V	—	0.5	0.9	dB
		T_A = -40 to +125 °C with PAVDD = 3.3 V	—	0.8	1.3	dB
Output power variation vs RF frequency	$POUT_{VAR_F}$	PAVDD = 3.3 V, T_A = 25 °C	—	0.4	0.7	dB
Spurious emissions of harmonics, Conducted measurement, Test Frequency = 915 MHz	$SPUR_{HARM_FCC}$	In non-restricted bands, per FCC 47 CFR §15.247[4]	—	-52.5	-20	dBc
		In restricted bands, per FCC 47 CFR §15.205 & §15.209[5] [6]	—	-50.4	-44.5	dBm
Unwanted signal emissions over frequency domain, Conducted measurement, Test Frequency = 915 MHz	$SPUR_{OOB_FCC}$	In non-restricted bands, per FCC 47 CFR §15.247[4]	—	-54.4	-20	dBc
		In restricted bands (30-88 MHz),per FCC 47 CFR §15.205 & §15.209[5] [6]	—	-59.8	-55.2	dBm
		In restricted bands (88-216 MHz), per FCC 47 CFR §15.205 & §15.209[5] [6]	—	-60.4	-51.7	dBm
		In restricted bands (216-960 MHz), per FCC 47 CFR §15.205 & §15.209[5] [6]	—	-59.6	-49.2	dBm
		In restricted bands (>960 MHz), per FCC 47 CFR §15.205 & §15.209[5] [6]	—	-57.1	-41.2	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. The transmit power for the 902 MHz to 928 Band MHz is normally supports +20 dBm or higher when frequency hopping or DSSS is used. Only the +20 dBm devices are recommended with the +20 dBm match.
3. The 20 dBm match is optimized for best efficiency at maximum power. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to 20 dBm.
4. FCC Title 47 CFR Part 15 Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz.
5. FCC Title 47 CFR Part 15 Section 15.205 Restricted bands of operation.
6. FCC Title 47 CFR Part 15 Section 15.209 Radiated emission limits; general requirements.

4.9.1.3 915 MHz Band +14 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +14 dBm using the 868/915/920 MHz 14 dBm matching network as shown in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 915 MHz.

Table 4.16. 915 MHz Band +14 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		902	—	928	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD connected to DC-DC output, 14 dBm devices, 14 dBm match[1] [2]	12.9	14.2	15.3	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-17.1	—	dBm
Output power variation vs supply at $POUT_{MAX}$	$POUT_{VAR_V}$	2.2 V < $V_{VREGVDD}$ < 3.8 V, PAVDD connected to DC-DC output, T = 25 °C	—	0.01	0.03	dB
Output power variation vs temperature, peak to peak	$POUT_{VAR_T}$	T_A = -40 to +85 °C with PAVDD connected to DC-DC output	—	0.3	0.6	dB
		T_A = -40 to +125 °C with PAVDD connected to DC-DC output	—	0.5	0.8	dB
Output power variation vs RF frequency	$POUT_{VAR_F}$	PAVDD connected to DC-DC output, T = 25 °C	—	0.3	0.7	dB
Spurious emissions of harmonics, Conducted measurement, Test Frequency = 915 MHz	$SPUR_{HARM_FCC}$	In non-restricted bands, per FCC 47 CFR §15.247[3]	—	-62.8	-20	dBc
		In restricted bands, per FCC 47 CFR §15.205 & §15.209[4] [5]	—	-46.3	-41.2	dBm
Unwanted signal emissions over frequency domain, Conducted measurement, Test Frequency = 915 MHz	$SPUR_{OOB_FCC}$	In non-restricted bands, per FCC 47 CFR §15.247[3]	—	-53.5	-20	dBc
		In restricted bands (30-88 MHz),per FCC 47 CFR §15.205 & §15.209[4] [5]	—	-65.8	-55.2	dBm
		In restricted bands (88-216 MHz), per FCC 47 CFR §15.205 & §15.209[4] [5]	—	-66.6	-51.7	dBm
		In restricted bands (216-960 MHz), per FCC 47 CFR §15.205 & §15.209[4] [5]	—	-65.5	-49.2	dBm
		In restricted bands (>960 MHz), per FCC 47 CFR §15.205 & §15.209[4] [5]	—	-50.2	-41.2	dBm

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. The 14 dBm match is optimized for best efficiency at 14 dBm. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to 14 dBm.
3. FCC Title 47 CFR Part 15 Section 15.247 Operation within the bands 902-928 MHz, 2400-2483.5 MHz, and 5725-5850 MHz.
4. FCC Title 47 CFR Part 15 Section 15.205 Restricted bands of operation.
5. FCC Title 47 CFR Part 15 Section 15.209 Radiated emission limits; general requirements.

4.9.1.4 868 MHz Band +20 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +20 dBm using the 868/915/920 MHz +20 dBm matching network as shown in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = 1.8 V powered from DCDC. PAVDD = 3.3V. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 869.5 MHz.

Table 4.17. 868 MHz Band +20 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		869.4	—	869.65	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD = 3.3V, 20 dBm devices, +20 dBm match[1] [2]	18.6	20.5	21.6	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-14.6	—	dBm
Output power variation vs supply at $POUT_{MAX}$	$POUT_{VAR_V}$	1.8 V < V_{PAVDD} < 3.8 V, T = 25 °C	—	4.6	—	dB
Output power variation vs temperature, peak to peak	$POUT_{VAR_T}$	T_A = -40 to +85 °C, PAVDD = 3.3 V	—	0.4	0.8	dB
		T_A = -40 to +125 °C, PAVDD = 3.3 V	—	0.7	1.2	dB
Output power variation vs RF frequency	$POUT_{VAR_F}$	PAVDD = 3.3 V, T = 25 °C	—	0.02	0.06	dB
Spurious emissions of harmonics, +20 dBm match, P_{OUT} = +20 dBm, 869.5 MHz	$SPUR_{HARM_ETSI}$	(frequencies above 1 GHz)[3]	—	-39.3	-30	dBm
Unwanted emissions in spurious domain, Per ETSI EN 300-220-1[4],+20 dBm match, P_{OUT} = +20 dBm, 869.5 MHz	$SPUR_{OOB_ETSI}$	(47-74 MHz, 87.5-118 MHz, 174-230 MHz, and 470-862 MHz)[3]	—	-70.1	-54	dBm
		(other frequencies below 1 GHz)[3]	—	-66.6	-36	dBm
		(frequencies above 1 GHz)[3]	—	-61.2	-30	dBm
Error Vector Magnitude, per 802.15.4-2020	EVM	Signal is 100 kbps DSSS-OQPSK reference packet. Modulated according to 802.15.4-2020 in the 868MHz band, with pseudo-random packet data content. P_{OUT} = +20 dBm.	—	6.0	35	%

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. The 20 dBm match is optimized for best efficiency at 20 dBm. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to 20 dBm.
3. Spurious emission limits per EN 300-220-1 v3.1.1 5.9.2. Tested with 10% duty cycle per EN 300-220-2 v3.2.1, operational frequency band P.
4. Conducted measurement per EN 300-220-1 v3.1.1 5.9.3.3.1

4.9.1.5 868 MHz Band +14 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +14 dBm using the 868/915/920 MHz +14 dBm matching network as shown in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 868.3 MHz.

Table 4.18. 868 MHz Band +14 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		863	—	869.2	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD connected to DC-DC output, 14 dBm devices, 14 dBm match[1] [2]	13.1	14.3	15.2	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-16.8	—	dBm
Output power variation vs supply at $POUT_{MAX}$	$POUT_{VAR_V}$	2.2 V < $V_{VREGVDD}$ < 3.8 V, PAVDD connected to DC-DC output, T = 25 °C	—	0.01	—	dB
Output power variation vs temperature, peak to peak	$POUT_{VAR_T}$	T_A = -40 to +85 °C with PAVDD connected to DC-DC output	—	0.3	0.6	dB
		T_A = -40 to +125 °C with PAVDD connected to DC-DC output	—	0.4	0.8	dB
Output power variation vs RF frequency	$POUT_{VAR_F}$	PAVDD connected to DC-DC output, T = 25 °C	—	0.1	0.3	dB
Spurious emissions of harmonics, +14 dBm match, P_{OUT} = +14 dBm, 868.3 MHz	$SPUR_{HARM_ETSI}$	(frequencies above 1 GHz)[3]	—	-62.1	-59.3	dBm
Unwanted emissions in spurious domain, Per ETSI EN 300-220-1[4],+14 dBm match, P_{OUT} = +14 dBm, 868.3 MHz	$SPUR_{OOB_ETSI}$	(47-74 MHz, 87.5-118 MHz, 174-230 MHz, and 470-862 MHz)[3]	—	-78.9	-54	dBm
		(other frequencies below 1 GHz)[3]	—	-70.9	-36	dBm
		(frequencies above 1 GHz)[3]	—	-69.8	-30	dBm
Error Vector Magnitude, per IEEE 802.15.4-2020	EVM	Signal is 100 kbps DSSS O-QPSK reference packet. Modulated according to IEEE 802.15.4-2020 in the 868MHz band, with pseudo-random packet data content. P_{OUT} = +14 dBm.	—	6.0	35	%

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. The 14 dBm match is optimized for best efficiency at 14 dBm. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to 14 dBm.
3. Spurious emission limits per EN 300-220-1 v3.1.1 5.9.2
4. Conducted measurement per EN 300-220-1 v3.1.1 5.9.3.3.1

4.9.1.6 470 MHz Band +20 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +20 dBm using the 470 MHz Band +20 dBm matching network as shown in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = 1.8 V powered from DCDC. PAVDD = 3.3V. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 490 MHz.

Table 4.19. 470 MHz Band +20 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		470	—	510	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD = 3.3V, 20 dBm devices, +20 dBm match[1][2][3]	19.3	20.7	21.5	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-14.2	—	dBm
Output power variation vs supply, peak to peak	$POUT_{VAR_V}$	1.8 V < V_{PAVDD} < 3.8 V, T = 25 °C	—	4.4	—	dB
Output power variation vs temperature, peak to peak	$POUT_{VAR_T}$	T_A = -40 to +85 °C, PAVDD = 3.3 V	—	0.4	0.8	dB
		T_A = -40 to +125 °C, PAVDD = 3.3 V	—	0.6	1.01	dB
Output power variation vs RF frequency	$POUT_{VAR_F}$	T = 25 °C	—	0.3	0.7	dB
Harmonic emissions, +20 dBm Match, P_{OUT} = +20 dBm, 490 MHz	$SPUR_{HARM_CN}$	Per China SRW Requirement, Section 2.1, frequencies below 1GHz	—	-49.2	-36	dBm
		Per China SRW Requirement, Section 2.1, frequencies above 1GHz	—	-40.0	-30	dBm
Spurious emissions, +20 dBm Match, P_{OUT} = +20 dBm, 490 MHz	$SPUR_{OOB_CN}$	Per China SRW Requirement, Section 2.1 (other frequencies below 1GHz)	—	-54	-36	dBm
		Per China SRW Requirement, Section 2.1 (frequencies above 1GHz)	—	-65.7	-30	dBm

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. The +20 dBm match is optimized for best efficiency at +20 dBm. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to +20 dBm.
3. Specific regional requirements for this band normally limit the maximum Tx power in this band to +17 dBm or less. Only the 20 dBm part numbers are reccomended for this band.

4.9.1.7 433 MHz Band +14 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +14 dBm using the 433 MHz 14 dBm matching network as shown in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 433.92 MHz.

Table 4.20. 433 MHz Band +14 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		433	—	434.79	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD connected to DC-DC output, 14 dBm devices, 14 dBm match[1][2][3]	13.2	14.6	15.1	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-17.5	—	dBm
Output power variation vs supply, peak to peak, P_{OUT} = +14 dBm	$POUT_{VAR_V}$	2.2 V < $V_{VREGVDD}$ < 3.8 V, PAVDD connected to DC-DC output, T = 25 °C	—	0.01	0.02	dB
Output power variation vs temperature, peak to peak, P_{OUT} = +14 dBm	$POUT_{VAR_T}$	T_A = -40 to +85 °C with PAVDD connected to DC-DC output	—	0.4	0.8	dB
		T_A = -40 to +125 °C with PAVDD connected to DC-DC output	—	0.5	1.3	dB
Output power variation vs RF frequency, P_{OUT} = +14 dBm	$POUT_{VAR_F}$	T = 25 °C	—	0.05	0.12	dB
Unwanted emissions in spurious domain, Per ETSI EN 300-220-1[4],+14 dBm match, P_{OUT} = +14 dBm, 433.92 MHz	$SPUR_{OOB_ETSI}$	(47-74 MHz, 87.5-118 MHz, 174-230 MHz, and 470-862 MHz)[5]	—	-74.2	-54	dBm
		(other frequencies below 1 GHz)[5]	—	-57.1	-36	dBm
		(frequencies above 1 GHz)[5]	—	-50.2	-30	dBm
Spurious emissions of harmonics ETSI, Conducted measurement, +14 dBm match, P_{OUT} = +14 dBm, 433.92 MHz	$SPUR_{HARM_ETSI}$	(other frequencies below 1 GHz)[5]	—	-50.5	-36	dBm
		(frequencies above 1 GHz)[5]	—	-46.7	-30	dBm
Spurious emissions of harmonics FCC, Conducted measurement, +14 dBm match, P_{OUT} = +14 dBm, 433.0 MHz[6]	$SPUR_{HARM_FCC}$	Per FCC 47 CFR §15.205 & §15.209[7][8][9]	—	-46.7	-41.2	dBm
Spurious emissions out-of-band FCC, Conducted measurement, +14 dBm match, P_{OUT} = 14 dBm, 433.0 MHz[6]	$SPUR_{OOB_FCC}$	30-88 MHz, per FCC 47 CFR §15.205 & §15.209[7][8][9]	—	-67.9	-55.2	dBm
		88-216 MHz, per FCC 47 CFR §15.205 & §15.209[7][8][9]	—	-72.9	-51.7	dBm
		216-960 MHz, per FCC 47 CFR §15.205 & §15.209[7][8][9]	—	-53.4	-49.2	dBm
		>960 MHz, per FCC 47 CFR §15.205 & §15.209[7][8][9]	—	-74.3	-41.2	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. Using the +14 dBm matching network for the 433 MHz Band. The 14 dBm match is optimized for best efficiency at 14 dBm. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to 14 dBm.
3. Specific regional requirements for this band normally limit the maximum Tx power in this band to 14 dBm or less. Only the 14 dBm part numbers are reccomended for this band.
4. Conducted measurement per EN 300-220-1 v3.1.1 5.9.3.3.1
5. Spurious emission limits per EN 300-220-1 v3.1.1 5.9.2
6. FCC emissions are specificed at a power level of 14 dBm conducted. A lower power setting may be required to meet the FCC limit specified in µV at 3m.
7. FCC Title 47 CFR Part 15 Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.
8. FCC Title 47 CFR Part 15 Section 15.205 Restricted bands of operation.
9. FCC Title 47 CFR Part 15 Section 15.209 Radiated emission limits; general requirements.

4.9.1.8 315 MHz Band +10 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +14 dBm using the 315 MHz +10 dBm matching network as shown in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 315 MHz.

Table 4.21. 315 MHz Band +10 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		314	—	315	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD connected to DC-DC output, 14 dBm devices, 10dBm match[1][2][3]	11.6	12.5	13.3	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-14.2	—	dBm
Output power variation vs supply	$POUT_{VAR_V}$	2.2 V < $V_{VREGVDD}$ < 3.8 V, PAVDD connected to DC-DC output, T = 25 °C	—	0.01	—	dB
Output power variation vs temperature	$POUT_{VAR_T}$	T_A = -40 to +85 °C with PAVDD connected to DC-DC output	—	0.3	0.6	dB
		T_A = -40 to +125 °C with PAVDD connected to DC-DC output	—	0.4	0.7	dB
Output power variation vs RF frequency	$POUT_{VAR_F}$	T = 25 °C	—	0.12	0.3	dB
Spurious emissions of harmonics, 10 dBm match, P_{OUT} = -19.6 dBm, 315.0 MHz[4]	$SPUR_{HARM_FCC}$	Per FCC 47 CFR §15.205 & §15.209[5][6][7]	—	-54.5	-49.2	dBm
Spurious emissions out-of-band, +10dBm match, P_{OUT} = +10 dBm, 315.0 MHz[4]	$SPUR_{OOB_FCC}$	30-88 MHz, per FCC 47 CFR §15.205 & §15.209[5][6][7]	—	-69.5	-55.2	dBm
		88-216 MHz, per FCC 47 CFR §15.205 & §15.209[5][6][7]	—	-73.2	-51.7	dBm
		216-960 MHz, per FCC 47 CFR §15.205 & §15.209[5][6][7]	—	-62.5	-49.2	dBm
		>960 MHz, per FCC 47 CFR §15.205 & §15.209[5][6][7]	—	-64.1	-41.2	dBm

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. Using the +10 dBm matching network for the 315 MHz Band. The 10 dBm match is optimized for best efficiency at 10 dBm. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to 10 dBm.
3. The transmit power for the 314MHz to 316 Band MHz is normally limited to +10 dBm. Only 14 dBm part numbers are recommended for this band.
4. FCC emissions are specificed at a power level of 10 dBm conducted. A lower power setting may be required to meet the FCC limit specified in µV at 3m.
5. FCC Title 47 CFR Part 15 Section 15.231 Periodic operation in the band 40.66-40.70 MHz and above 70 MHz.
6. FCC Title 47 CFR Part 15 Section 15.205 Restricted bands of operation.
7. FCC Title 47 CFR Part 15 Section 15.209 Radiated emission limits; general requirements.

4.9.1.9 169 MHz Band +20 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +20 dBm using the 169 MHz +20 dBm matching network in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = 1.8 V powered from DCDC. PAVDD = 3.3V. Crystal frequency = 39 MHz. RFVDD and PAVDD paths filtered using ferrites. RF center frequency 169.4375 MHz. Conducted emissions.

Table 4.22. 169 MHz Band +20 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		169.4	—	169.475	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD = 3.3V, 20 dBm devices, +20 dBm match[123], Min / Max at 25C, 3.3V PAVDD	19.9	21.1	22.0	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-13.3	—	dBm
Output power variation vs supply, peak to peak	$POUT_{VAR_V}$	1.8 V < V_{PAVDD} < 3.8 V, T = 25 °C	—	4.5	—	dB
Output power variation vs temperature, peak to peak	$POUT_{VAR_T}$	T_A = -40 to +85 °C, PAVDD = 3.3 V	—	0.3	0.6	dB
		T_A = -40 to +125 °C, PAVDD = 3.3 V	—	0.4	0.8	dB
Unwanted emissions in spurious domain, Per ETSI EN 300-220-1[4], PAVDD = 3.3 V, P_{OUT} = 20 dBm, 169.4375 MHz	$SPUR_{OOB_ETSI}$	(47-74 MHz, 87.5-118 MHz, 174-230 MHz, and 470-862 MHz)[5]	—	-70.8	-54	dBm
		(other frequencies below 1 GHz)[5]	—	-70.5	-36	dBm
		(frequencies above 1 GHz)[5]	—	-73.5	-30	dBm
Spurious emissions harmonics, Per ETSI EN 300-220-1[4], PAVDD = 3.3 V, P_{OUT} = 20 dBm, 169.4375 MHz	$SPUR_{HARM_ETSI}$	(47-74 MHz, 87.5-118 MHz, 174-230 MHz, and 470-862 MHz)[5]	—	-89.3	-54	dBm
		(other frequencies below 1 GHz)[5]	—	-52.9	-36	dBm
		(frequencies above 1 GHz)[5]	—	-78.3	-30	dBm

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. Using the +20 dBm matching network for the 169 MHz Band. The 20 dBm match is optimized for best efficiency at 20 dBm. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to 20 dBm.
3. The transmit power for the 169.4 MHz to 169.475 Band MHz is normally limited to +27 dBm. Only 20 dBm part numbers are recommended for this band.
4. Conducted measurement per EN 300-220-1 v3.1.1 5.9.3.3.1
5. Spurious emission limits per EN 300-220-1 v3.1.1 5.9.2

4.9.1.10 169 MHz Band +10 dBm RF Transmitter Characteristics

This table is for devices with a output power rating of +10 dBm using the 169 MHz +10 dBm matching network in the typical connections section. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = 1.8 V powered from DCDC. PAVDD = 3.3V. Crystal frequency = 39 MHz. RFVDD and PAVDD paths filtered using ferrites. RF center frequency 169.7 MHz. Conducted emissions.

Table 4.23. 169 MHz Band +10 dBm RF Transmitter Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		169.5875	—	169.8125	MHz
Maximum TX Power	$POUT_{MAX}$	PAVDD = 3.3V, 14 dBm devices, +10 dBm match[1][2][3]	11.3	12.2	12.8	dBm
Minimum active TX Power	$POUT_{MIN}$		—	-12.5	—	dBm
Output power variation vs supply, peak to peak	$POUT_{VAR_V}$	2.2 V < $V_{VREGVDD}$ < 3.8 V, PAVDD connected to DC-DC output, T = 25 °C	—	0.01	—	dB
Output power variation vs temperature, peak to peak	$POUT_{VAR_T}$	T_A = -40 to +85 °C with PAVDD connected to DC-DC output	—	0.2	0.4	dB
		T_A = -40 to +125 °C with PAVDD connected to DC-DC output	—	0.3	0.5	dB
Unwanted emissions in spurious domain, Per ETSI EN 300-220-1[4], PAVDD = 3.3 V, P_{OUT} = 10 dBm, 169.7 MHz	$SPUR_{OOB_ETSI}$	(47-74 MHz, 87.5-118 MHz, 174-230 MHz, and 470-862 MHz)[5]	—	-74	-54	dBm
		(other frequencies below 1 GHz)[5]	—	-80.3	-36	dBm
		(frequencies above 1 GHz)[5]	—	-71.0	-30	dBm
Spurious emissions harmonics, Per ETSI EN 300-220-1[4], PAVDD = 3.3 V, P_{OUT} = 10 dBm, 169.7 MHz	$SPUR_{HARM_ETSI}$	(47-74 MHz, 87.5-118 MHz, 174-230 MHz, and 470-862 MHz)[5]	—	-89.5	-54	dBm
		(other frequencies below 1 GHz)[5]	—	-63.9	-36	dBm
		(frequencies above 1 GHz)[5]	—	-78.5	-30	dBm

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this datasheet can be found in the Max TX Power column of the Ordering Information Table.
2. Using the +10 dBm matching network for the 169 MHz Band. The 10 dBm match is optimized for best efficiency at 10 dBm. The maximum output power can go up to the maximum rating. Emissions are tested with the output power set to 10 dBm.
3. The transmit power for the 169.5875 MHz to 169.8125 Band MHz is normally limited to +10 dBm. Only 14 dBm part numbers are recommended for this band.
4. Conducted measurement per EN 300-220-1 v3.1.1 5.9.3.3.1
5. Spurious emission limits per EN 300-220-1 v3.1.1 5.9.2

4.9.2 RF Proprietary Receiver Characteristics

4.9.2.1 920 MHz Band RF Receiver Characteristics

Band is 920 to 928 MHz. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 924.0 MHz.

Table 4.24. 920 MHz Band RF Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		920	—	928	MHz
Rx Max Strong Signal Input Level for PER 10%	RX_{SAT}	Desired is reference 400 kbps 4FSK signal[1]	—	—	10.0	dBm
Sensitivity	SENS	Desired is reference 50 kbps 2FSK signal, Δf = ± 25 kHz, PER<10%[2]	—	-109.3	-107.2	dBm
		Desired is reference 100 kbps 2FSK signal, Δf = ± 50 kHz, PER<10%[3]	—	-106.4	-104.2	dBm
		Desired is reference 400 kbps 4FSK signal, Δf_o = ± 100 kHz, Δf_i = ± 33.3 kHz, PER<10%[1]	—	-98.1	-95.8	dBm
Adjacent channel rejection, Interferer is CW at ± 1 × channel spacing	ACR1	Desired is reference 50 kbps 2FSK signal[2] at 3dB above sensitivity level	—	45.0	—	dB
		Desired is reference 100 kbps 2FSK signal[3] at 3dB above sensitivity level	—	46.5	—	dB
		Desired is reference 400 kbps 4FSK signal[1] at 3dB above sensitivity level	—	40.0	—	dB
Alternate channel rejection, Interferer is CW at ± 2 × channel spacing	ACR2	Desired is reference 50 kbps 2FSK signal[2] at 3dB above sensitivity level	—	52.2	—	dB
		Desired is reference 100 kbps 2FSK signal[3] at 3dB above sensitivity level	—	58.0	—	dB
		Desired is reference 400 kbps 4FSK signal[1]	—	52.5	—	dB
Image rejection, Interferer is CW at image frequency	IR	Desired is reference 50 kbps 2FSK signal[2] at 3dB above sensitivity level	—	45.7	—	dB
		Desired is reference 100 kbps 2FSK signal[3] at 3dB above sensitivity level	—	46.7	—	dB
		Desired is reference 400 kbps 4FSK signal[1]	—	39.0	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Blocking selectivity, 10% PER. Desired is 100 kbps 2FSK signal at 3dB above sensitivity level	BLOCK	Interferer CW at Desired ± 1 MHz	—	60.5	—	dB
		Interferer CW at Desired ± 2 MHz	—	67.4	—	dB
		Interferer CW at Desired ± 10 MHz	—	78.7	—	dB
Intermod selectivity,10% PER. CW interferers at 400 kHz and 800 kHz offsets	IM	Desired is reference 100 kbps 2FSK signal[3] at 3dB above sensitivity level	—	45.0	—	dB
Upper limit of input power range over which RSSI resolution is maintained	$RSSI_{MAX}$		—	—	10	dBm
Lower limit of input power range over which RSSI resolution is maintained	$RSSI_{MIN}$		-113	—	—	dBm
RSSI resolution	$RSSI_{RES}$	Over $RSSI_{MIN}$ to $RSSI_{MAX}$ range	—	0.25	—	dB
Max spurious emissions during active receive mode, per ARIB STD-T108 Part 2, Section 3.3	$SPUR_{RX_ARIB}$	Below 710 MHz, RBW=100kHz	—	-87.3	-54.0	dBm
		710-900 MHz, RBW=1MHz	—	-75.5	-55.0	dBm
		900-915 MHz, RBW=100kHz	—	-86.9	-55.0	dBm
		915-930 MHz, RBW=100kHz	—	-87.2	-54.0	dBm
		930-1000 MHz, RBW=100kHz	—	-81.8	-55.0	dBm
		Above 1000 MHz, RBW=1MHz	—	-64.3	-47.0	dBm

Note:

1. Definition of reference signal is 400 kbps 4FSK, BT = 2, mi = 0.33, PER<10%, Channel Spacing = 600 kHz, Data Whitening, no FEC, Per IEEE 802.15.4g 920 MHz band, mode 4.
2. Definition of reference signal is 50 kbps 2FSK, BT = 2, mi = 1.0, PER<10%, Channel Spacing = 200 kHz, Data Whitening, no FEC.
3. Definition of reference signal is 100 kbps 2FSK, BT = 2, mi = 1.0, PER<10%, Channel Spacing = 400 kHz, Data Whitening, no FEC.

4.9.2.2 915 MHz Band RF Receiver Characteristics

Band is 902 to 928 MHz. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 915 MHz.

Table 4.25. 915 MHz Band RF Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		902	—	928	MHz
Rx Max Strong Signal Input Level for 0.1% BER	RX_{SAT}	Desired is reference 2 Mbps 2GFSK signal[1]	—	—	10.0	dBm
Sensitivity	SENS	Desired is reference 4.8 kbps OOK signal, PER<20%[2]	—	-112.4	—	dBm
		Desired is reference 50 kbps 2FSK signal, Δf = ± 25 kHz, PER<10%[3]	—	-109.3	—	dBm
		Desired is reference 50 kbps 2FSK signal, Δf = ± 25 kHz, PER<10% with FEC[4]	—	-114.1	—	dBm
		Desired is reference 150 kbps 2FSK signal, Δf = ± 37.5 kHz, PER<10%[5]	—	-106.8	—	dBm
		Desired is reference 2 Mbps 2GFSK signal, Δf = ± 500 kHz, BER<0.1%[1]	—	-96.0	—	dBm
		Desired is reference 4.8 kbps O-QPSK signal, spreading factor=8, PER<1%[6]	—	-124.8	—	dBm
		Desired is reference 250 kbps O-QPSK DSSS signal, PER<1%[7]	—	-102.6	—	dBm
		Desired is reference 120 kbps OOK signal[8], PER<20%	—	-101.8	—	dBm
Adjacent channel rejection, Interferer is CW at ± 1 × channel spacing	ACR1	Desired is reference 4.8 kbps OOK signal[2] at 3dB above sensitivity level	—	50.9	—	dB
		Desired is reference 50 kbps 2FSK signal[3] at 3dB above sensitivity level	—	45.2	—	dB
		Desired is reference 150 kbps 2FSK signal[5] at 3dB above sensitivity level	—	44.8	—	dB
		Desired is reference 250 kbps O-QPSK DSSS signal[7] at 3dB above sensitivity level	—	50.1	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Alternate channel rejection, Interferer is CW at ± 2 × channel spacing	ACR2	Desired is reference 4.8 kbps OOK signal[2] at 3dB above sensitivity level	—	64.4	—	dB
		Desired is reference 50 kbps 2FSK signal[3] at 3dB above sensitivity level	—	52.5	—	dB
		Desired is reference 150 kbps 2FSK signal[5] at 3dB above sensitivity level	—	58.7	—	dB
		Desired is reference 250 kbps O-QPSK DSSS signal[7] at 3dB above sensitivity level	—	53.4	—	dB
Image rejection, Interferer is CW at image frequency	IR	Desired is reference 4.8 kbps OOK signal[2] at 3dB above sensitivity level	—	43.3	—	dB
		Desired is reference 50 kbps 2FSK signal[3] at 3dB above sensitivity level	—	45.8	—	dB
		Desired is reference 150 kbps 2FSK signal[5] at 3dB above sensitivity level	—	45.5	—	dB
		Desired is reference 250 kbps O-QPSK DSSS signal[7] at 3dB above sensitivity level	—	51.5	—	dB
Intermod selectivity, PER < 10%. CW interferers at 400 kHz and 800 kHz offsets	IM	Desired is reference 50 kbps 2GFSK signal[3] at 3dB above sensitivity level	—	48.0	—	dB
Upper limit of input power range over which RSSI resolution is maintained	$RSSI_{MAX}$		—	—	10.0	dBm
Lower limit of input power range over which RSSI resolution is maintained	$RSSI_{MIN}$		-100.0	—	—	dBm
RSSI resolution	$RSSI_{RES}$	Over $RSSI_{MIN}$ to $RSSI_{MAX}$ range	—	0.25	—	dB
Max spurious emissions during active receive mode, per FCC Part 15.109(a)	$SPUR_{RX_FCC}$	216-960 MHz	—	-75.6	-49.2	dBm
		Above 960 MHz	—	-63.5	-41.2	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. The modulation bandwidth may not be suitable for regional regulatory requirements in this band. Crystal tolerance = 0 ppm.
2. Definition of reference signal is 4.8 kbps Manchester-encoded OOK, RX channel BW = 350 kHz, channel spacing = 500 kHz.
3. Definition of reference signal is 50 kbps 2FSK, BT = 2, mi = 1.0, PER<10%, Channel Spacing = 200 kHz, Data Whitening, no FEC.
4. Definition of reference signal is 50 kbps 2FSK, BT = 2, mi = 1.0, PER<10%, Channel Spacing = 200 kHz, Data Whitening, with FEC.
5. Definition of reference signal is 150 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 400 kHz, Data Whitening, no FEC.
6. Definition of reference signal is 4.8 kbps O-QPSK DSSS long-range PHY, 38.4 kcps chip rate, chipping code length 32, PER<1%. Crystal tolerance = 0 ppm.
7. Definition of reference signal is O-QPSK DSSS, Data rate = 250 kbps, 32-chip PN sequence mapping, <1% PER, Channel Spacing = 2 MHz, payload length = 20 octets. Crystal tolerance = 0 ppm.
8. Definition of reference signal is 120 kbps OOK, RX channel BW = 350 kHz, channel spacing = 500 kHz.

4.9.2.3 868 MHz Band RF Receiver Characteristics

Band is 868 to 870 MHz. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 868.3 MHz.

Table 4.26. 868 MHz Band RF Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		863	—	870	MHz
Rx Max Strong Signal Input Level for 0.1% BER	RX_{SAT}	Desired is reference 500 kbps 2GMSK signal[1]	—	—	10.0	dBm
Sensitivity	SENS	Desired is reference 2.4 kbps 2GFSK signal, Δf = ± 1.2 kHz, BER<0.1%[2]	—	-124.1	—	dBm
		Desired is reference 38.4 kbps 2GFSK signal, Δf = ± 20 kHz, BER<0.1%[3]	—	-112.3	—	dBm
		Desired is reference 50 kbps 2FSK signal, Δf = ± 12.5 kHz, PER<10%[4]	—	-110.4	—	dBm
		Desired is reference 100 kbps 2FSK signal, Δf = ± 25 kHz, PER<10%[5]	—	-108.0	—	dBm
		Desired is reference 500 kbps 2GMSK signal, Δf = ± 125 kHz[1], BER<0.1%[6]	—	-102.1	—	dBm
		Desired is reference 100 kbps O-QPSK DSSS signal, PER<1%[7]	—	-110.2	—	dBm
Adjacent channel rejection, Interferer is CW at ± 1 × channel spacing	ACR1	Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	-44.6	—	dBm
		Desired is reference 38.4 kbps 2GFSK signal[3] at 3dB above sensitivity level	—	44.6	—	dB
		Desired is reference 50 kbps 2FSK signal[4] at 3dB above sensitivity level	—	45.4	—	dB
		Desired is reference 100 kbps 2FSK signal[5] at 3dB above sensitivity level	—	44.7	—	dB
		Desired is reference 100 kbps O-QPSK DSSS signal [7] at 3dB above sensitivity level	—	56.8	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Alternate channel rejection, Interferer is CW at ± 2 × channel spacing	ACR2	Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	-45.3	—	dBm
		Desired is reference 38.4 kbps 2GFSK signal[3] at 3dB above sensitivity level	—	42.8	—	dB
		Desired is reference 50 kbps 2FSK signal[4] at 3dB above sensitivity level	—	45.3	—	dB
		Desired is reference 100 kbps 2FSK signal[5] at 3dB above sensitivity level	—	51.7	—	dB
		Desired is reference 100 kbps O-QPSK DSSS signal [7] at 3dB above sensitivity level	—	65.1	—	dB
Image rejection, Interferer is CW at image frequency	IR	Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	-49.5	—	dBm
		Desired is reference 38.4 kbps 2GFSK signal[3] at 3dB above sensitivity level	—	41.4	—	dB
		Desired is reference 50 kbps 2FSK signal[4] at 3dB above sensitivity level	—	46.6	—	dB
		Desired is reference 100 kbps 2FSK signal[5] at 3dB above sensitivity level	—	46.4	—	dB
		Desired is reference 100 kbps O-QPSK DSSS signal [7] at 3dB above sensitivity level	—	49.4	—	dB
Blocking selectivity, 0.1% BER. Desired is 2.4 kbps 2GFSK signal[2] at 3 dB above sensitivity level	BLOCK	Interferer CW at Desired ± 2 MHz	—	-15.6	—	dBm
		Interferer CW at Desired ± 10 MHz	—	-7.2	—	dBm
		Interferer CW at Desired ± 43.4 MHz	—	-5.1	—	dBm
Upper limit of input power range over which RSSI resolution is maintained	$RSSI_{MAX}$		—	—	10.0	dBm
Lower limit of input power range over which RSSI resolution is maintained	$RSSI_{MIN}$		-103.0	—	—	dBm
RSSI resolution	$RSSI_{RES}$	Over $RSSI_{MIN}$ to $RSSI_{MAX}$ range	—	0.25	—	dB
Max spurious emissions during active receive mode	$SPUR_{RX}$	30 MHz to 1 GHz	—	-76.7	-57.0	dBm
		1 GHz to 6 GHz	—	-58.8	-47.0	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. Definition of reference signal is 500 kbps 2GMSK, BT = 0.5, mi = 0.5, BER<0.1%, RX channel BW = 753.320 kHz. Crystal tolerance = 0 ppm.
2. Definition of reference signal is 2.4 kbps 2GFSK, BT = 0.5, mi = 1.0, BER<0.1%, RX channel BW = 10 kHz, channel spacing = 25 kHz.
3. Definition of reference signal is 38.4 kbps 2GFSK, BT = 0.5, mi = 1.04, BER<0.1%, RX channel BW = 74.809 kHz, channel spacing = 100 kHz. Crystal tolerance = 0 ppm.
4. Definition of reference signal is 50 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 100 kHz, Data Whitening, no FEC.
5. Definition of reference signal is 100 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 200 kHz, Data Whitening, no FEC.
6. The modulation bandwidth may not be suitable for regional regulatory requirements in this band. Crystal tolerance = 0 ppm.
7. Definition of reference signal is O-QPSK DSSS per IEEE802.15.4, Data rate = 100 kbps, 4 bit to 16 chip PN sequence mapping, PER<1%, Channel Spacing = 2 MHz, payload length=20 octets.

4.9.2.4 470 MHz Band RF Receiver Characteristics

Band is 470 to 510 MHz. Unless otherwise indicated, typical conditions are: T = 25 °C, VREGVDD = AVDD = IOVDD = 3.3 V, DVDD = RFVDD = External PA Supply. RFVDD and external PA supply paths filtered using ferrites. Crystal frequency = 39 MHz. RF center frequency 490 MHz.

Table 4.27. 470 MHz Band RF Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		470	—	510	MHz
Rx Max Strong Signal Input Level for 10% PER	RX_{SAT}	Desired is reference 100 kbps 2FSK signal[1]	—	—	10.0	dBm
Sensitivity	SENS	Desired is reference 2.4 kbps 2GFSK signal, Δf = ± 1.2 kHz, BER<0.1%[2]	—	-126.3	—	dBm
		Desired is reference 10 kbps 2GFSK signal, Δf = ± 25 kHz, BER<0.1%[3]	—	-117.7	—	dBm
		Desired is reference 50 kbps 2FSK signal, Δf = ± 25 kHz, PER<10%[4]	—	-111.3	—	dBm
		Desired is reference 100 kbps 2FSK signal, Δf = ± 25 kHz, PER<10%[1]	—	-110.5	—	dBm
		Desired is reference 4.8 kbps OQPSK signal, spreading factor=8, PER<1% [5]	—	-126.5	—	dBm
		Desired is reference 9.6 kbps OQPSK signal, spreading factor=8, PER<1% [6]	—	-123.1	—	dBm
Adjacent channel rejection, Interferer is CW at ± 1 × channel spacing	ACR1	Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	63.3	—	dB
		Desired is reference 50 kbps 2FSK signal[4] at 3dB above sensitivity level	—	50.3	—	dB
		Desired is reference 100 kbps 2FSK signal[1] at 3dB above sensitivity level	—	49.1	—	dB
Alternate channel rejection, Interferer is CW at ± 2 × channel spacing	ACR2	Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	62.9	—	dB
		Desired is reference 50 kbps 2FSK signal[4] at 3dB above sensitivity level	—	57.8	—	dB
		Desired is reference 100 kbps 2FSK signal[1] at 3dB above sensitivity level	—	56.8	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Image rejection, Interferer is CW at image frequency	IR	Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	54.8	—	dB
		Desired is reference 50 kbps 2FSK signal[4] at 3dB above sensitivity level	—	50.2	—	dB
		Desired is reference 100 kbps 2FSK signal[1] at 3dB above sensitivity level	—	49.8	—	dB
Blocking selectivity, 0.1% BER. Desired is 2.4 kbps 2GFSK signal[2] at 3 dB above sensitivity level	BLOCK	Interferer CW at Desired ± 1 MHz	—	82.8	—	dB
		Interferer CW at Desired ± 2 MHz	—	89.4	—	dB
		Interferer CW at Desired ± 10 MHz	—	95.8	—	dB
Upper limit of input power range over which RSSI resolution is maintained	$RSSI_{MAX}$		—	—	10.0	dBm
Lower limit of input power range over which RSSI resolution is maintained	$RSSI_{MIN}$		-111.0	—	—	dBm
RSSI resolution	$RSSI_{RES}$	Over $RSSI_{MIN}$ to $RSSI_{MAX}$ range	—	0.25	—	dB
Max spurious emissions during active receive mode	$SPUR_{RX}$	30 MHz to 1 GHz	—	-73.0	-47.0	dBm
		1 GHz to 10th Harmonic	—	-64.3	-47.0	dBm

Note:

1. Definition of reference signal is 100 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 200 kHz.
2. Definition of reference signal is 2.4 kbps 2GFSK, BT = 0.5, mi = 1.0, BER<0.1%, RX channel BW = 4.798 kHz, Channel Spacing = 12.5 kHz. Crystal tolerance = 0 ppm.
3. Definition of reference signal is 10 kbps 2GFSK, BT = 0.5, mi = 5.0, BER<0.1%, RX channel BW = 99.2 kHz. Crystal tolerance = 0 ppm.
4. Definition of reference signal is 50 kbps 2FSK, BT = 2, mi = 1.0, PER<10%, Channel Spacing = 200 kHz.
5. Definition of reference signal is 4.8 kbps O-QPSK DSSS long-range PHY, 38.4 kcps chip rate, spreading factor 8, chipping code length 32, 1/2 rate with K=7 per IEEE802.15.4g, PER<1%, crystal tolerance ± 2.5 ppm.
6. Definition of reference signal is 9.6 kbps O-QPSK DSSS long-range PHY, 76.8 kcps chip rate, spreading factor 8, chipping code length 32, 1/2 rate with K=7 per IEEE802.15.4g, PER<1%, crystal tolerance ± 10 ppm.

4.9.2.5 433 MHz Band RF Receiver Characteristics

Band is 433.05 MHz to 434.79 MHz. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 433.92 MHz.

Table 4.28. 433 MHz Band RF Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		433	—	434.79	MHz
Rx Max Strong Signal Input Level for 0.1% BER	RX_{SAT}	Desired is reference 100 kbps 2GFSK signal, BER<0.1%[1]	—	—	10.0	dBm
Sensitivity	SENS	Desired is reference 2.4 kbps 2GFSK signal, Δf = ± 1.2 kHz, BER<0.1%[2]	—	-126.8	—	dBm
		Desired is reference 4.8 kbps OOK signal, PER<20%[3]	—	-114.1	—	dBm
		Desired is reference 100 kbps 2GFSK signal, Δf = ± 50 kHz, BER<0.1%[1]	—	-110.6	—	dBm
		Desired is reference 50 kbps 2GFSK signal, Δf = ± 25 kHz, BER<0.1%[4]	—	-113.7	—	dBm
		Desired is reference 50 kbps 4GFSK signal, Δf_o = ± 25 kHz, Δf_i = ± 8.33 kHz, PER<1%[5]	—	-112.1	—	dBm
		Desired is reference 460 MHz 4.8 kbps 2FSK signal, Δf = ± 2.4 kHz, PER<10%[6]	—	-122.3	—	dBm
Adjacent channel rejection, Interferer is CW at ± 1 × channel spacing	ACR1	Desired is reference 4.8 kbps OOK signal[3] at 3dB above sensitivity level	—	57.1	—	dB
		Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	63.8	—	dB
Alternate channel rejection, Interferer is CW at ± 2 × channel spacing	ACR2	Desired is reference 4.8 kbps OOK signal[3] at 3dB above sensitivity level	—	67.6	—	dB
		Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	63.8	—	dB
Image rejection, Interferer is CW at image frequency	IR	Desired is reference 4.8 kbps OOK signal[3] at 3dB above sensitivity level	—	49.6	—	dB
		Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	73.8	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Blocking selectivity, 0.1% BER. Desired is 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	BLOCK	Interferer CW at Desired ± 1 MHz	—	83.8	—	dB
		Interferer CW at Desired ± 2 MHz	—	89.8	—	dB
		Interferer CW at Desired ± 10 MHz	—	95.9	—	dB
Intermod selectivity, 0.1% BER. CW interferers at 12.5 kHz and 25 kHz offsets	IM	Desired is reference 2.4 kbps 2GFSK signal[2] at 3dB above sensitivity level	—	56.0	—	dB
Upper limit of input power range over which RSSI resolution is maintained	$RSSI_{MAX}$		—	—	10.0	dBm
Lower limit of input power range over which RSSI resolution is maintained	$RSSI_{MIN}$		-111.0	—	—	dBm
RSSI resolution	$RSSI_{RES}$	Over $RSSI_{MIN}$ to $RSSI_{MAX}$ range	—	0.25	—	dB
Max spurious emissions during active receive mode, per FCC Part 15.109(a)	$SPUR_{RX_FCC}$	216-960 MHz	—	-74.5	-49.2	dBm
		Above 960 MHz	—	-71.5	-41.2	dBm
Max spurious emissions during active receive mode, per ETSI 300-220 Section 8.6	$SPUR_{RX_ETSI}$	Below 1000 MHz	—	-75.0	-57.0	dBm
		Above 1000 MHz	—	-55.2	-47.0	dBm
Max spurious emissions during active receive mode, per ARIB STD T67 Section 3.3(5)	$SPUR_{RX_ARIB}$	Below 710 MHz, RBW=100kHz	—	-86.0	-54.0	dBm

Note:

1. Definition of reference signal is 100 kbps 2GFSK, BT = 0.5, mi = 1.0, BER<0.1%, RX channel BW = 200 kHz, Crystal tolerance = 0 ppm.
2. Definition of reference signal is 2.4 kbps 2GFSK, BT = 0.5, mi = 1.0, BER<0.1%, Channel Spacing = 12.5 kHz, RX channel BW = 4.8 kHz.
3. Definition of reference signal is 4.8 kbps Manchester-encoded OOK, RX channel BW = 350 kHz, channel spacing = 500 kHz.
4. Definition of reference signal is 50 kbps 2GFSK, BT = 0.5, mi = 1.0, BER<0.1%, RX channel BW = 100 kHz, Crystal tolerance = 0 ppm.
5. Definition of reference signal is 50 kbps 4GFSK, BT = 1.0, mi = 0.66, PER<1%, RX channel BW = 74.98 kHz, Crystal tolerance = 0 ppm.
6. Definition of reference signal is 4.8 kbps 2FSK, BT = 2, mi = 1.0, PER<10%, Channel Spacing = 12.5 kHz, Data Whitening, no FEC, 460 MHz center frequency. Per IEEE 802.15.4g 450 MHz band, mode 2.

4.9.2.6 315 MHz Band RF Receiver Characteristics

Band is 314 to 316 MHz. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 315 MHz.

Table 4.29. 315 MHz Band RF Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		314	—	316	MHz
Rx Max Strong Signal Input Level for 20% PER	RX_{SAT}	Desired is reference 38.4 kbps 2GFSK signal[1]	—	—	10.0	dBm
Sensitivity	SENS	Desired is reference 38.4 kbps 2GFSK signal, Δf = ± 20 kHz, BER<0.1%[1]	—	-114.4	—	dBm
		Desired is reference 40 kbps OOK signal, PER<20%[2]	—	-106.5	—	dBm
		Desired is reference 4.8 kbps OOK signal, PER<20%[3]	—	-114.0	—	dBm
Blocking selectivity, 0.1% BER. Desired is 38.4 kbps 2GFSK signal[1] at 3 dB above sensitivity level	BLOCK	Interferer CW at Desired ± 1 MHz	—	71.4	—	dB
		Interferer CW at Desired ± 2 MHz	—	79.5	—	dB
		Interferer CW at Desired ± 10 MHz	—	81.3	—	dB
Upper limit of input power range over which RSSI resolution is maintained	$RSSI_{MAX}$		—	—	10.0	dBm
Lower limit of input power range over which RSSI resolution is maintained	$RSSI_{MIN}$		-115.0	—	—	dBm
RSSI resolution	$RSSI_{RES}$	Over $RSSI_{MIN}$ to $RSSI_{MAX}$ range	—	0.25	—	dB
Max spurious emissions during active receive mode, per FCC Part 15.109(a)	$SPUR_{RX_FCC}$	216-960 MHz	—	-74.0	-49.2	dBm
		Above 960MHz	—	-58.5	-41.2	dBm

Note:

1. Definition of reference signal is 38.4 kbps 2GFSK, BT = 0.5, mi = 1.05, BER<0.1%, Channel Spacing = 100 kHz, RX channel BW = 74.809 kHz. Crystal tolerance = 0 ppm.
2. Definition of reference signal is 40 kbps Manchester-encoded OOK, BW = 350 kHz.
3. Definition of reference signal is 4.8 kbps Manchester-encoded OOK, BW = 350 kHz.

4.9.2.7 169 MHz Band RF Receiver Characteristics

Band is 169.4 to to 169.8125 MHz. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 169.4MHz.

Table 4.30. 169 MHz Band RF Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		169.4	—	169.812	MHz
Rx Max Strong Signal Input Level for 0.1% BER	RX_{SAT}	Desired is reference 9.6 kbps 4FSK signal[1]	—	—	10.0	dBm
Sensitivity	SENS	Desired is reference 2.4 kbps 2GFSK signal, Δf = ± 1.2 kHz, BER<0.1%[2]	—	-126.7	—	dBm
		Desired is reference 2.4 kbps 2FSK signal, Δf = ± 2.4 kHz, PER<10%[3]	—	-121.1	—	dBm
		Desired is reference 4.8 kbps 2FSK signal, Δf = ± 1.2 kHz, PER<10%[4]	—	-125.0	—	dBm
		Desired is reference 9.6 kbps 4FSK signal, Δf_o = ± 2.4 kHz, Δf_i = ± 800 Hz, PER<10%[1]	—	-118.5	—	dBm
Adjacent channel rejection, Interferer is CW at ± 1 × channel spacing	ACR1	Desired is reference 2.4 kbps 2GFSK (Δf = ± 1.2 kHz) signal[2] at 3 dB above sensitivity level	—	-37.6	—	dBm
		Desired is reference 2.4 kbps 2FSK (Δf = ± 2.4 kHz) signal[3] at 3 dB above sensitivity level	—	34.0	—	dB
		Desired is reference 4.8 kbps 2FSK signal[4] at 3 dB above sensitivity level	—	61.1	—	dB
		Desired is reference 9.6 kbps 4FSK signal[1] at 3 dB above sensitivity level	—	51.3	—	dB
Alternate channel rejection, Interferer is CW at ± 2 × channel spacing	ACR2	Desired is reference 2.4 kbps 2GFSK (Δf = ± 1.2 kHz) signal[2] at 3 dB above sensitivity level	—	-34.0	—	dBm
		Desired is reference 2.4 kbps 2FSK (Δf = ± 2.4 kHz) signal[3] at 3 dB above sensitivity level	—	63.7	—	dB
		Desired is reference 4.8 kbps 2FSK signal[4] at 3 dB above sensitivity level	—	66.1	—	dB
		Desired is reference 9.6 kbps 4FSK signal[1] at 3 dB above sensitivity level	—	62.7	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Image rejection, Interferer is CW at image frequency	IR	Desired is reference 2.4 kbps 2GFSK (Δf = ± 1.2 kHz) signal[2] at 3 dB above sensitivity level	—	-39.0	—	dBm
		Desired is reference 2.4 kbps 2FSK (Δf = ± 2.4 kHz) signal[3] at 3 dB above sensitivity level	—	61.8	—	dB
		Desired is reference 4.8 kbps 2FSK signal[4] at 3 dB above sensitivity level	—	63.6	—	dB
		Desired is reference 9.6 kbps 4FSK signal[1] at 3 dB above sensitivity level	—	55.1	—	dB
Blocking selectivity, 0.1% BER. Desired is 2.4 kbps 2GFSK signal[3] at 3 dB above sensitivity level	BLOCK	Interferer CW at Desired ± 2 MHz	—	-11.2	—	dBm
		Interferer CW at Desired ± 10 MHz	—	-9.6	—	dBm
		Interferer CW at Desired ± 15 MHz	—	-9.3	—	dBm
Upper limit of input power range over which RSSI resolution is maintained	$RSSI_{MAX}$		—	—	10.0	dBm
Lower limit of input power range over which RSSI resolution is maintained	$RSSI_{MIN}$		-125.0	—	—	dBm
RSSI resolution	$RSSI_{RES}$	Over $RSSI_{MIN}$ to $RSSI_{MAX}$ range	—	0.25	—	dB
Max spurious emissions during active receive mode	$SPUR_{RX}$	30 MHz to 1 GHz	—	-72.5	-57.0	dBm
		1 GHz to 6 GHz	—	-62.7	-47.0	dBm

Note:

1. Definition of reference signal is 9.6 kbps 4FSK, BT = 2, mi = 0.33, PER<10%, Channel Spacing = 12.5 kHz, RX channel BW = 13.666 kHz. Per IEEE802.15.4g 169 MHz band, mode 3.
2. Definition of reference signal is 2.4 kbps 2GFSK, BT = 0.5, mi = 1.0, BER<0.1%, Channel Spacing = 12.5 kHz, RX channel BW = 4.8 kHz. Crystal tolerance = 0 ppm.
3. Definition of reference signal is 2.4 kbps 2FSK, BT = 2, mi = 2.0, PER<10%, Channel Spacing = 12.5 kHz. Per IEEE802.15.4g 169 MHz band, mode 2.
4. Definition of reference signal is 4.8 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 12.5 kHz. Per IEEE802.15.4g 169 MHz band, mode 1.

4.9.3 RF Wi-SUN FSK Receiver Characteristics

Wi-SUN FSK Modulations are defined in Wi-SUN Alliance PHY Working Group (PHYWG TPS) Wi-SUN PHY Technical Specification - Amendment 1VA8 June 2021. The PHY modulations in this table use BT = 2 and are indicated by (T, M, C) where T is the Phy Mode ID Type, and M is the Mode from PHY WG TPS Tables 2, 3, and 4. Also, C is the Channel Plan ID from PHY WG TPS Tables 6 and 7. The PHYWG TPS also references IEEE 802.15.4-2020 section 19 especially. Measurements use packet length of 250 octets when data rate is 50 kbps or higher, and 20 octets packet length when lower than 50 kbps.

The following table gives information about the different Wi-SUN FSK configurations that are supported by this device family. This section is meant to be informative, in case of any contradiction the Wi-SUN PHY TPS takes precedence.

Table 4.31. FSK Modulation for Wi-SUN, BT = 2, 2 level FSK, with Data Whitening

Old FSK # 1V08 PHY Op Mode[1]	Wi-SUN PHY (Type[2], Mode[3], ChanPlanID[4])	PhyModeID decimal[5]	Data Rate (kbps)	Operating Band (MHz)	Modulation Index[6]	Channel Bandwidth[7] (kHz)	Channel Spacing (kHz)	FEC Enabled[9]
#1a	(0, 1, 36)	1	50	866	0.5	65	100	No
#1b	(0, 2, 1)	2	50	914	1	100	200	No
#1b	(0, 2, 21)	2	50	923	1	100	200	No
#2a	(0, 3, 37)	3	100	866	0.5	110	200	No
#2a	(0, 3, 1)	3	100	914	0.5	110	200	No
#2b	(0, 4, 22)	4	100	923	1	200	400	No
#3	(0, 5, 37)	5	150	866	0.5	165	200[8]	No
#3	(0, 5, 2)	5	150	914	0.5	165	400	No
#3	(0, 5, 22)	5	150	923	0.5	165	400	No
#4a	(0, 6, 2)	6	200	914	0.5	220	400	No
#4b	(0, 7, 23)	7	200	923	1	400	600	No
#5	(0, 8, 3)	8	300	914	0.5	330	600	No
#5	(0, 8, 23)	8	300	923	0.5	330	600	No
#1a	(1, 1, 36)	17	50	866	0.5	65	100	NRNSC
#1b	(1, 2, 1)	18	50	914	1	100	200	NRNSC
#1b	(1, 2, 21)	18	50	923	1	100	200	NRNSC
#2a	(1, 3, 37)	19	100	866	0.5	110	200	NRNSC
#2a	(1, 3, 1)	19	100	914	0.5	110	200	NRNSC
#2b	(1, 4, 22)	20	100	923	1	200	400	NRNSC
#3	(1, 5, 37)	21	150	866	0.5	165	200[8]	NRNSC
#3	(1, 5, 2)	21	150	914	0.5	165	400	NRNSC
#3	(1, 5, 22)	21	150	923	0.5	165	400	NRNSC
#4a	(1, 6, 2)	22	200	914	0.5	220	400	NRNSC
#4b	(1, 7, 23)	23	200	923	1	400	600	NRNSC
#5	(1, 8, 3)	24	300	914	0.5	330	600	NRNSC
#5	(1, 8, 23)	24	300	923	0.5	330	600	NRNSC

Old FSK # 1V08 PHY Op Mode[1]	Wi-SUN PHY (Type[2], Mode[3], ChanPlanID[4])	PhyModeID decimal[5]	Data Rate (kbps)	Operating Band (MHz)	Modulation Index[6]	Channel Bandwidth[7] (kHz)	Channel Spacing (kHz)	FEC Enabled[9]

Note:

1. Wi-SUN FSK Phy Operating Mode # from PHYWG TPS 1V08 November 2018, Table 2.
2. Wi-SUN PHY Type follows PHYWG TPS 1VA8, Table 3.
3. Wi-SUN PHY Mode follows PHYWG TPS 1VA8, Table 4.
4. Wi-SUN FSK Operating Frequency channel plan follows PHYWG TPS 1VA8, Tables 6 and 7.
5. Wi-SUN FSK Phy Mode ID is from Wi-SUN Standard PHYWG TPS 1VA8, Tables 2, 3, and 4. See also Table 16 first and second column.
6. Viterbi DeMod is enabled when modulation index (mi) is less than 1.0, and disabled when mi is 1.0 or higher.
7. Approximation of the modulation signal occupied channel bandwidth for information purpose.
8. Europe Region uses smaller channel spacing
9. Modulations use interleaving only with FEC. Also, when FEC is used it must be NRNSC.

4.9.3.1 920 MHz Band RF Wi-SUN FSK Receiver Characteristics

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = PAVDD = AVDD = 3.3 V, DVDD = IOVDD = RFVDD = 1.8 V from DC-DC regulator output, supply filtering as shown in the typical connections section, crystal frequency = 39 MHz ± 1 ppm.

Table 4.32. 920 MHz Band RF Wi-SUN FSK Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range[1]	F_{RANGE}		922.3	923.x	928.1	MHz
Rx Max Strong Signal Input Level for 10% PER.	RX_{SAT}	#5 = (1, 8, 23)[2], 300 kbps, mi = 0.5, with FEC[3]	—	—	10.0	dBm
Rx Sensitivity for 10% Packet Error Rate (PER) with no interferer	SENS	#2b = (0, 4, 22)[2], 100 kbps, mi = 1.0, no FEC[4]	—	-106.4	-104.2	dBm
		#1b = (1, 2, 21)[2], 50 kbps, mi = 1.0, with FEC[5]	—	-114.0	—	dBm
		#2b = (1, 4, 22)[2], 100 kbps, mi = 1.0, with FEC[6]	—	-110.5	-108.2	dBm
		#3 = (1, 5, 22)[2], 150 kbps, mi = 0.5, with FEC[7]	—	-108.8	—	dBm
		#4b = (1, 7, 23)[2], 200 kbps, mi = 1.0, with FEC[8]	—	-107.5	—	dBm
		#5 = (1, 8, 23)[2], 300 kbps, mi = 0.5, with FEC[3]	—	-105.8	-103.3	dBm
Adjacent Channel Rejection U/D ratio for 10% PER according to IEEE 802.15.4-2020 section 19.6.8 with Desired signal at 3 dB above required sensitivity. Undesired signal is CW at ± 1 × channel spacing. Requires IR Calibration.	ACR1	#2b = (0, 4, 22)[2], 100 kbps, mi = 1.0, no FEC[4]	—	46.5	—	dB
		#1b = (1, 2, 21)[2], 50 kbps, mi = 1.0, with FEC[5]	—	49.2	—	dB
		#2b = (1, 4, 22)[2], 100 kbps, mi = 1.0, with FEC[6]	—	49.7	—	dB
		#3 = (1, 5, 22)[2], 150 kbps, mi = 0.5, with FEC[7]	—	47.1	—	dB
		#4b = (1, 7, 23)[2], 200 kbps, mi = 1.0, with FEC[8]	—	50.6	—	dB
		#5 = (1, 8, 23)[2], 300 kbps, mi = 0.5, with FEC[3]	—	49.3	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Alternate Channel Rejection U/D ratio for 10% PER according to IEEE 802.15.4-2020 section 19.6.8 with Desired signal at 3 dB above required sensitivity. Undesired signal is CW at ± 2 × channel spacing. Requires IR Calibration.	ACR2	#2b = (0, 4, 22)[2], 100 kbps, mi = 1.0, no FEC[4]	—	58.0	—	dB
		#1b = (1, 2, 21)[2], 50 kbps, mi = 1.0, with FEC[5]	—	53.0	—	dB
		#2b = (1, 4, 22)[2], 100 kbps, mi = 1.0, with FEC[6]	—	62.3	—	dB
		#3 = (1, 5, 22)[2], 150 kbps, mi = 0.5, with FEC[7]	—	60.7	—	dB
		#4b = (1, 7, 23)[2], 200 kbps, mi = 1.0, with FEC[8]	—	61.8	—	dB
		#5 = (1, 8, 23)[2], 300 kbps, mi = 0.5, with FEC[3]	—	61.7	—	dB
Image Rejection U/D ratio for 10% PER. Undesired signal is CW at the RX image frequency. Desired signal is 3dB above required sensitivity level according to IEEE 802.15.4-2020 section 19.6.7.	IR	#2b = (0, 4, 22)[2], 100 kbps, mi = 1.0, no FEC[4]	—	46.7	—	dB
		#1b = (1, 2, 21)[2], 50 kbps, mi = 1.0, with FEC[5]	—	49.7	—	dB
		#2b = (1, 4, 22)[2], 100 kbps, mi = 1.0, with FEC[6]	—	49.9	—	dB
		#3 = (1, 5, 22)[2], 150 kbps, mi = 0.5, with FEC[7]	—	47.8	—	dB
		#4b = (1, 7, 23)[2], 200 kbps, mi = 1.0, with FEC[8]	—	50.7	—	dB
		#5 = (1, 8, 23)[2], 300 kbps, mi = 0.5, with FEC[3]	—	48.7	—	dB
Blocking Selectivity U/D ratio for 10% PER. Desired signal at 3 dB above required sensitivity level according to IEEE 802.15.4-2020 section 19.6.7. Undesired signal is CW at ± 10 MHz frequency offset.	$BLOCK_{10M}$	#2b = (0, 4, 22)[2], 100 kbps, mi = 1.0, no FEC[4]	—	78.7	—	dB
		#2b = (1, 4, 22)[2], 100 kbps, mi = 1.0, with FEC[6]	—	82.1	—	dB
Co-Channel Rejection U/D ratio. Set Desired signal to 3 dB above required sensitivity level according to IEEE 805.15.4-2020 section 19.6.7. Undesired signal is CW with level adjusted to make PER = 10%.	CoChR	#2b = (0, 4, 22)[2], 100 kbps, mi = 1.0, no FEC[4]	—	-2.6	—	dB
		#1b = (1, 2, 21)[2], 50 kbps, mi = 1.0, with FEC[5]	—	-1.7	—	dB
		#2b = (1, 4, 22)[2], 100 kbps, mi = 1.0, with FEC[6]	—	-2.0	—	dB
		#3 = (1, 5, 22)[2], 150 kbps, mi = 0.5, with FEC[7]	—	-6.3	—	dB
		#4b = (1, 7, 23)[2], 200 kbps, mi = 1.0, with FEC[8]	—	-1.7	—	dB
		#5 = (1, 8, 23)[2], 300 kbps, mi = 0.5, with FEC[3]	—	-6.3	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Rx Energy Detection Magnitude Error, and AGC, averaged over 8 symbol periods of PRBS data.[9]	$AGC_{PreamME}$	#1b, 50 kbps, mi = 1.0	—	1.99	—	dB
		#2b, 100 kbps, mi = 1.0	—	1.75	—	dB
		#3, 150 kbps, mi = 0.5	—	2.05	—	dB
		#4b, 200 kbps, mi = 1.0	—	1.84	—	dB
		#5, 300 kbps, mi = 0.5	—	1.55	—	dB
Frequency Error Sensitivity. Receiver signal level for 10% PER with the desired signal's frequency offset by the given F_{Err}.	$SENS_{FE}$	#2b = (0, 4, 22)[2], 100 kbps, mi = 1.0, no FEC[4]. F_{Err} = ± 110 ppm	—	-105.1	—	dBm
		#1b = (1, 2, 21)[2], 50 kbps, mi = 1.0, with FEC[5]. F_{Err} = ± 70 ppm	—	-106.0	—	dBm
		#2b = (1, 4, 22)[2], 100 kbps, mi = 1.0, with FEC[6]. F_{Err} = ± 110 ppm	—	-105.2	—	dBm
		#3 = (1, 5, 22)[2], 150 kbps, mi = 0.5, with FEC[7]. F_{Err} = ± 90 ppm	—	-106.2	—	dBm
		#4b = (1, 7, 23)[2], 200 kbps, mi = 1.0, with FEC[8]. F_{Err} = ± 90 ppm	—	-107.5	—	dBm
		#5 = (1, 8, 23)[2], 300 kbps, mi = 0.5, with FEC[3]. F_{Err} = ± 100 ppm	—	-105.7	—	dBm
Receive Signal Strength Indicator in dB for the given input signal condition as measured by the receiver with AGC active.	RSSI	at SENS #2b = (1, 4, 22)[2]	—	-110.7	—	dBm
		3 dB above SENS #2b = (1, 4, 22)[2]	—	-107.1	—	dBm
		10 dB above SENS #2b = (1, 4, 22)[2]	—	-100.4	—	dBm
		at -91 dBm, #2b = (1, 4, 22)[2]	—	-91.0	—	dBm
		at -91 dBm and ACR1 #2b = (1, 4, 22)[2]	—	-91.3	—	dBm
		at -40 dBm no interferer #2b = (1, 4, 22)[2]	—	-40.5	—	dBm
		at -91 dBm with a co-channel CW interferer level adjusted for 10% PER #2b = (1, 4, 22)[2]	—	-90.9	—	dBm
		at $SENS_{FE}$ #2b = (1, 4, 22)[2]; F_{Err} = ± 110 ppm	—	-103.5	—	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. Test Frequency F for Typ conditions varies slightly according to the PHY Channel Plan ID: F = 923.6 MHz for 21, F = 923.7 MHz for 22, and F = 923.8 MHz for 23.
2. The indexes provided inside the parenthesis for each Test Conditions description are (T, M, C) and these define the PHY being tested according to Wi-SUN PHYWG TPS amendment 1VA9 with T = Type ID in Table 3, M = Mode ID in Table 4, and C = Channel Plan ID in Tables 6 and 7. 4.9.3 RF Wi-SUN FSK Receiver Characteristics summarizes the options listed in this document.
3. Reference signal is 300 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 600 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #5
4. Reference signal is 100 kbps 2FSK, BT = 2, mi =1.0, PER<10%, Channel Spacing = 400 kHz, Data Whitening, without FEC. Per Wi-SUN FAN PHY 1.0 standard mode #2b
5. Reference signal is 50 kbps 2FSK, BT = 2, mi =1.0, PER<10%, Channel Spacing = 200 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #1b
6. Reference signal is 100 kbps 2FSK, BT = 2, mi =1.0, PER<10%, Channel Spacing = 400 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #2b
7. Reference signal is 150 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 400 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #3
8. Reference signal is 100 kbps 2FSK, BT = 2, mi =1.0, PER<10%, Channel Spacing = 600 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #4b
9. Using Preamble Field signal (section 19.2.3.1 of IEEE 802.15.4-2020), sweep Antenna input level in 2 dB steps starting from 10 dB above required sensitivity to 50 dB above required sensitivity of 802.15.4-2020 section 19.6.7 . At each 2 dB step, record the input signal level at the 50 Ω Antenna port along with the signal level measured by the receiver averaged over 8 symbol fields of PRBS data. The Magnitude Error is the absolute value of the difference between these two at the 2 dB step with the worst Error. AGC_PreamME = Max(|Avg(Rx_meas) - Rx_applied|).

4.9.3.2 915 MHz Band RF Wi-SUN FSK Receiver Characteristics

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = PAVDD = AVDD = 3.3 V, DVDD = IOVDD = RFVDD = 1.8 V from DC-DC regulator output, supply filtering as shown in the typical connections section, crystal frequency = 39 MHz ± 1 ppm.

Table 4.33. 915 MHz Band RF Wi-SUN FSK Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		902	914	928	MHz
Rx Max Strong Signal Input Level for 10% PER.	RX_{SAT}	#5 = (1, 8, 3)[1], 300 kbps, mi = 0.5, with FEC[2]	—	—	10.0	dBm
Rx Sensitivity for 10% Packet Error Rate (PER) with no interferer	SENS	#1b = (0, 2, 1)[1], 50 kbps, mi = 1.0, no FEC[3]	—	-109.3	—	dBm
		#1b = (1, 2, 1)[1], 50 kbps, mi = 1.0, with FEC[4]	—	-114.1	—	dBm
		#2a = (1, 3, 1)[1], 100 kbps, mi = 0.5, with FEC[5]	—	-110.4	—	dBm
		#3 = (1, 5, 2)[1], 150 kbps, mi = 0.5, with FEC[6]	—	-108.7	—	dBm
		#4a = (1, 6, 2)[1], 200 kbps, mi = 0.5, with FEC[7]	—	-107.5	—	dBm
		#5 = (1, 8, 3)[1], 300 kbps, mi = 0.5, with FEC[2]	—	-105.8	—	dBm
Adjacent Channel Rejection U/D ratio for 10% PER according to IEEE 802.15.4-2020 section 19.6.8 with Desired signal at 3 dB above required sensitivity. Undesired signal is CW at ± 1 × channel spacing. Requires IR Calibration.	ACR1	#1b = (0, 2, 1)[1], 50 kbps, mi = 1.0, no FEC[3]	—	45.2	—	dB
		#1b = (1, 2, 1)[1], 50 kbps, mi = 1.0, with FEC[4]	—	49.4	—	dB
		#2a = (1, 3, 1)[1], 100 kbps, mi = 0.5, with FEC[5]	—	46.3	—	dB
		#3 = (1, 5, 2)[1], 150 kbps, mi = 0.5, with FEC[6]	—	48.0	—	dB
		#4a = (1, 6, 2)[1], 200 kbps, mi = 0.5, with FEC[7]	—	48.3	—	dB
		#5 = (1, 8, 3)[1], 300 kbps, mi = 0.5, with FEC[2]	—	49.4	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Alternate Channel Rejection U/D ratio for 10% PER according to IEEE 802.15.4-2020 section 19.6.8 with Desired signal at 3 dB above required sensitivity. Undesired signal is CW at ± 2 × channel spacing. Requires IR Calibration.	ACR2	#1b = (0, 2, 1)[1], 50 kbps, mi = 1.0, no FEC[3]	—	52.5	—	dB
		#1b = (1, 2, 1)[1], 50 kbps, mi = 1.0, with FEC[4]	—	53.6	—	dB
		#2a = (1, 3, 1)[1], 100 kbps, mi = 0.5, with FEC[5]	—	51.7	—	dB
		#3 = (1, 5, 2)[1], 150 kbps, mi = 0.5, with FEC[6]	—	60.7	—	dB
		#4a = (1, 6, 2)[1], 200 kbps, mi = 0.5, with FEC[7]	—	59.4	—	dB
		#5 = (1, 8, 3)[1], 300 kbps, mi = 0.5, with FEC[2]	—	61.7	—	dB
Image Rejection U/D ratio for 10% PER. Undesired signal is CW at the RX image frequency. Desired signal is 3dB above required sensitivity level according to IEEE 802.15.4-2020 section 19.6.7.	IR	#1b = (0, 2, 1)[1], 50 kbps, mi = 1.0, no FEC[3]	—	45.8	—	dB
		#1b = (1, 2, 1)[1], 50 kbps, mi = 1.0, with FEC[4]	—	49.8	—	dB
		#2a = (1, 3, 1)[1], 100 kbps, mi = 0.5, with FEC[5]	—	47.7	—	dB
		#3 = (1, 5, 2)[1], 150 kbps, mi = 0.5, with FEC[6]	—	48.3	—	dB
		#4a = (1, 6, 2)[1], 200 kbps, mi = 0.5, with FEC[7]	—	48.5	—	dB
		#5 = (1, 8, 3)[1], 300 kbps, mi = 0.5, with FEC[2]	—	48.8	—	dB
Blocking Selectivity U/D ratio for 10% PER. Desired signal at 3 dB above required sensitivity level according to IEEE 802.15.4-2020 section 19.6.7. Undesired signal is CW at ± 10 MHz frequency offset.	$BLOCK_{10M}$	#1b = (0, 2, 1)[1], 50 kbps, mi = 1.0, no FEC[3]	—	81.5	—	dB
		#1b = (1, 2, 1)[1], 50 kbps, mi = 1.0, with FEC[4]	—	85.6	—	dB
Co-Channel Rejection U/D ratio. Set Desired signal to 3 dB above required sensitivity level according to IEEE 805.15.4-2020 section 19.6.7. Undesired signal is CW with level adjusted to make PER = 10%.	CoChR	#1b = (0, 2, 1)[1], 50 kbps, mi = 1.0, no FEC[3]	—	-3.1	—	dB
		#1b = (1, 2, 1)[1], 50 kbps, mi = 1.0, with FEC[4]	—	-1.7	—	dB
		#2a = (1, 3, 1)[1], 100 kbps, mi = 0.5, with FEC[5]	—	-5.9	—	dB
		#3 = (1, 5, 2)[1], 150 kbps, mi = 0.5, with FEC[6]	—	-6.3	—	dB
		#4a = (1, 6, 2)[1], 200 kbps, mi = 0.5, with FEC[7]	—	-6.3	—	dB
		#5 = (1, 8, 3)[1], 300 kbps, mi = 0.5, with FEC[2]	—	-6.3	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Rx Energy Detection Magnitude Error, and AGC, averaged over 8 symbol periods of PRBS data.[8]	$AGC_{PreamME}$	#1b, 50 kbps, mi = 1.0	—	1.99	—	dB
		#2a, 100 kbps, mi = 0.5	—	1.71	—	dB
		#3, 150 kbps, mi = 0.5	—	2.06	—	dB
		#4a, 200 kbps, mi = 0.5	—	1.36	—	dB
		#5, 300 kbps, mi = 0.5	—	1.62	—	dB
Frequency Error Sensitivity. Receiver signal level for 10% PER with the desired signal's frequency offset by the given F_{Err}.	$SENS_{FE}$	#1b = (0, 2, 1)[1], 50 kbps, mi = 1.0, no FEC[3]. F_{Err} = ± 60 ppm	—	-108.5	—	dBm
		#1b = (1, 2, 1)[1], 50 kbps, mi = 1.0, with FEC[4]. F_{Err} = ± 60 ppm	—	-108.6	—	dBm
		#2a = (1, 3, 1)[1], 100 kbps, mi = 0.5, with FEC[5]. F_{Err} = ± 60 ppm	—	-107.4	—	dBm
		#3 = (1, 5, 2)[1], 150 kbps, mi = 0.5, with FEC[6]. F_{Err} = ± 90 ppm	—	-106.2	—	dBm
		#4a = (1, 6, 2)[1], 200 kbps, mi = 0.5, with FEC[7]. F_{Err} = ± 110 ppm	—	-105.5	—	dBm
		#5 = (1, 8, 3)[1], 300 kbps, mi = 0.5, with FEC[2]. F_{Err} = ± 110 ppm	—	-105.6	—	dBm
Receive Signal Strength Indicator in dB for the given input signal condition as measured by the receiver with AGC active.	RSSI	at SENS #3 = (1, 5, 2)[1]	—	-108.3	—	dBm
		3 dB above SENS #3 = (1, 5, 2)[1]	—	-105.1	—	dBm
		10 dB above SENS #3 = (1, 5, 2)[1]	—	-98.2	—	dBm
		at -89 dBm, #3 = (1, 5, 2)[1]	—	-88.5	—	dBm
		at -89 dBm and ACR1 #3 = (1, 5, 2)[1]	—	-88.7	—	dBm
		at -40 dBm no interferer, #3 = (1, 5, 2)[1]	—	-39.1	—	dBm
		at -89 dBm with a co-channel CW interferer level adjusted for 10% PER #3 = (1, 5, 2)[1]	—	-88.8	—	dBm
		at $SENS_{FE}$ #3 = (1, 5, 2)[1]; F_{Err} = ± 90 ppm	—	-104.7	—	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. The indexes provided inside the parenthesis for each Test Conditions description are (T, M, C) and these define the PHY being tested according to Wi-SUN PHYWG TPS amendment 1VA9 with T = Type ID in Table 3, M = Mode ID in Table 4, and C = Channel Plan ID in Tables 6 and 7. 4.9.3 RF Wi-SUN FSK Receiver Characteristics summarizes the options listed in this document.
2. Reference signal is 300 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 600 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #5
3. Reference signal is 50 kbps 2FSK, BT = 2, mi =1.0, PER<10%, Channel Spacing = 200 kHz, Data Whitening, without FEC. Per Wi-SUN FAN PHY 1.0 standard mode #1b
4. Reference signal is 50 kbps 2FSK, BT = 2, mi =1.0, PER<10%, Channel Spacing = 200 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #1b
5. Reference signal is 100 kbps 2FSK, BT = 2, mi =0.5, PER<10%, Channel Spacing = 200 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #2a
6. Reference signal is 150 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 400 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #3
7. Reference signal is 200 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 400 kHz, Data Whitening, without FEC. Per Wi-SUN FAN PHY 1.0 standard mode #4a
8. Using Preamble Field signal (section 19.2.3.1 of IEEE 802.15.4-2020), sweep Antenna input level in 2 dB steps starting from 10 dB above required sensitivity to 50 dB above required sensitivity of 802.15.4-2020 section 19.6.7 . At each 2 dB step, record the input signal level at the 50 Ω Antenna port along with the signal level measured by the receiver averaged over 8 symbol fields of PRBS data. The Magnitude Error is the absolute value of the difference between these two at the 2 dB step with the worst Error. AGC_PreamME = Max(|Avg(Rx_meas) - Rx_applied|).

4.9.3.3 868 MHz Band RF Wi-SUN FSK Receiver Characteristics

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = PAVDD = AVDD = 3.3 V, DVDD = IOVDD = RFVDD = 1.8 V from DC-DC regulator output, supply filtering as shown in the typical connections section, crystal frequency = 39 MHz ± 1 ppm.

Table 4.34. 868 MHz Band RF Wi-SUN FSK Receiver Characteristics

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		863	866.5	876	MHz
Rx Max Strong Signal Input Level for 10% PER.	RX_{SAT}	#3 = (1, 5, 37)[1], 150 kbps, mi = 0.5, with FEC[2]	—	—	10.0	dBm
Rx Sensitivity for 10% Packet Error Rate (PER) with no interferer	SENS	#1a = (0, 1, 36)[1], 50 kbps, mi = 0.5, no FEC[3]	—	-110.4	—	dBm
		#2a = (0, 3, 37)[1], 100 kbps, mi = 0.5, no FEC[4]	—	-108.0	—	dBm
		#1a = (1, 1, 36)[1], 50 kbps, mi = 0.5, with FEC[5]	—	-113.7	—	dBm
		#2a = (1, 3, 37)[1], 100 kbps, mi = 0.5, with FEC[6]	—	-110.1	—	dBm
		#3 = (1, 5, 37)[1], 150 kbps, mi = 0.5, with FEC[2]	—	-108.4	—	dBm
Adjacent Channel Rejection U/D ratio for 10% PER according to IEEE 802.15.4-2020 section 19.6.8 with Desired signal at 3 dB above required sensitivity. Undesired signal is CW at ± 1 × channel spacing. Requires IR Calibration.	ACR1	#1a = (0, 1, 36)[1], 50 kbps, mi = 0.5, no FEC[3]	—	45.4	—	dB
		#2a = (0, 3, 37)[1], 100 kbps, mi = 0.5, no FEC[4]	—	44.7	—	dB
		#1a = (1, 1, 36)[1], 50 kbps, mi = 0.5, with FEC[5]	—	48.6	—	dB
		#2a = (1, 3, 37)[1], 100 kbps, mi = 0.5, with FEC[6]	—	46.8	—	dB
		#3 = (1, 5, 37)[1], 150 kbps, mi = 0.5, with FEC[2]	—	44.9	—	dB
Alternate Channel Rejection U/D ratio for 10% PER according to IEEE 802.15.4-2020 section 19.6.8 with Desired signal at 3 dB above required sensitivity. Undesired signal is CW at ± 2 × channel spacing. Requires IR Calibration.	ACR2	#1a = (0, 1, 36)[1], 50 kbps, mi = 0.5, no FEC[3]	—	45.3	—	dB
		#2a = (0, 3, 37)[1], 100 kbps, mi = 0.5, no FEC[4]	—	51.7	—	dB
		#1a = (1, 1, 36)[1], 50 kbps, mi = 0.5, with FEC[5]	—	48.6	—	dB
		#2a = (1, 3, 37)[1], 100 kbps, mi = 0.5, with FEC[6]	—	52.1	—	dB
		#3 = (1, 5, 37)[1], 150 kbps, mi = 0.5, with FEC[2]	—	48.6	—	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Image Rejection U/D ratio for 10% PER. Undesired signal is CW at the RX image frequency. Desired signal is 3dB above required sensitivity level according to IEEE 802.15.4-2020 section 19.6.7.	IR	#1a = (0, 1, 36)[1], 50 kbps, mi = 0.5, no FEC[3]	—	46.6	—	dB
		#2a = (0, 3, 37)[1], 100 kbps, mi = 0.5, no FEC[4]	—	46.4	—	dB
		#1a = (1, 1, 36)[1], 50 kbps, mi = 0.5, with FEC[5]	—	49.7	—	dB
		#2a = (1, 3, 37)[1], 100 kbps, mi = 0.5, with FEC[6]	—	48.6	—	dB
		#3 = (1, 5, 37)[1], 150 kbps, mi = 0.5, with FEC[2]	—	49.2	—	dB
Blocking Selectivity U/D ratio for 10% PER. Desired signal at 3 dB above required sensitivity level according to IEEE 802.15.4-2020 section 19.6.7. Undesired signal is CW at ± 10 MHz frequency offset.	$BLOCK_{10M}$	#1a = (0, 1, 36)[1], 50 kbps, mi = 0.5, no FEC[3]	—	82.7	—	dB
		#1a = (1, 1, 36)[1], 50 kbps, mi = 0.5, with FEC[5]	—	85.8	—	dB
Co-Channel Rejection U/D ratio. Set Desired signal to 3 dB above required sensitivity level according to IEEE 805.15.4-2020 section 19.6.7. Undesired signal is CW with level adjusted to make PER = 10%.	CoChR	#1a = (0, 1, 36)[1], 50 kbps, mi = 0.5, no FEC[3]	—	-7.6	—	dB
		#2a = (0, 3, 37)[1], 100 kbps, mi = 0.5, no FEC[4]	—	-8.3	—	dB
		#1a = (1, 1, 36)[1], 50 kbps, mi = 0.5, with FEC[5]	—	-3.9	—	dB
		#2a = (1, 3, 37)[1], 100 kbps, mi = 0.5, with FEC[6]	—	-6.0	—	dB
		#3 = (1, 5, 37)[1], 150 kbps, mi = 0.5, with FEC[2]	—	-6.3	—	dB
Rx Energy Detection Magnitude Error, and AGC, averaged over 8 symbol periods of PRBS data.[7]	$AGC_{PreamME}$	#1a, 50 kbps, mi = 0.5	—	1.92	—	dB
		#2a, 100 kbps, mi = 0.5	—	1.31	—	dB
		#3, 150 kbps, mi = 0.5	—	1.71	—	dB
Frequency Error Sensitivity. Receiver signal level for 10% PER with the desired signal's frequency offset by the given F_{Err}.	$SENS_{FE}$	#1a = (0, 1, 36)[1], 50 kbps, mi = 0.5, no FEC[3]. F_{Err} = ± 50 ppm	—	-107.2	—	dBm
		#2a = (0, 3, 37)[1], 100 kbps, mi = 0.5, no FEC[4]. F_{Err} = ± 50 ppm	—	-107.3	—	dBm
		#1a = (1, 1, 36)[1], 50 kbps, mi = 0.5, with FEC[5]. F_{Err} = ± 60 ppm	—	-107.7	—	dBm
		#2a = (1, 3, 37)[1], 100 kbps, mi = 0.5, with FEC[6]. F_{Err} = ± 60 ppm	—	-107.7	—	dBm
		#3 = (1, 5, 37)[1], 150 kbps, mi = 0.5, with FEC[2]. F_{Err} = ± 90 ppm	—	-106.3	—	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Receive Signal Strength Indicator in dB for the given input signal condition as measured by the receiver with AGC active.	RSSI	at SENS #2a = (1, 3, 37)[1]	—	-110.3	—	dBm
		3 dB above SENS #2a = (1, 3, 37)[1]	—	-107.2	—	dBm
		10 dB above SENS #2a = (1, 3, 37)[1]	—	-100.9	—	dBm
		at -91 dBm, #2a = (1, 3, 37)[1]	—	-91.0	—	dBm
		at -91 dBm and ACR1 #2a = (1, 3, 37)[1]	—	-91.2	—	dBm
		at -40 dBm no interferer #2a = (1, 3, 37)[1]	—	-40.7	—	dBm
		at -91 dBm with a co-channel CW interferer level adjusted for 10% PER #2a = (1, 3, 37)[1]	—	-91.2	—	dBm
		at $SENS_{FE}$ #2a = (1, 3, 37)[1]; F_{Err} = ± 60 ppm	—	-107.2	—	dBm

Note:

1. The indexes provided inside the parenthesis for each Test Conditions description are (T, M, C) and these define the PHY being tested according to Wi-SUN PHYWG TPS amendment 1VA9 with T = Type ID in Table 3, M = Mode ID in Table 4, and C = Channel Plan ID in Tables 6 and 7. 4.9.3 RF Wi-SUN FSK Receiver Characteristics summarizes the options listed in this document.
2. Reference signal is 150 kbps 2FSK, BT = 2, mi = 0.5, PER<10%, Channel Spacing = 200 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #3
3. Reference signal is 50 kbps 2FSK, BT = 2, mi =0.5, PER<10%, Channel Spacing = 100 kHz, Data Whitening, without FEC. Per Wi-SUN FAN PHY 1.0 standard mode #1a
4. Reference signal is 100 kbps 2FSK, BT = 2, mi =0.5, PER<10%, Channel Spacing = 200 kHz, Data Whitening, without FEC. Per Wi-SUN FAN PHY 1.0 standard mode #2a
5. Reference signal is 50 kbps 2FSK, BT = 2, mi =0.5, PER<10%, Channel Spacing = 100 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #1a
6. Reference signal is 100 kbps 2FSK, BT = 2, mi =0.5, PER<10%, Channel Spacing = 200 kHz, Data Whitening, with FEC. Per Wi-SUN FAN PHY 1.0 standard mode #2a
7. Using Preamble Field signal (section 19.2.3.1 of IEEE 802.15.4-2020), sweep Antenna input level in 2 dB steps starting from 10 dB above required sensitivity to 50 dB above required sensitivity of 802.15.4-2020 section 19.6.7 . At each 2 dB step, record the input signal level at the 50 Ω Antenna port along with the signal level measured by the receiver averaged over 8 symbol fields of PRBS data. The Magnitude Error is the absolute value of the difference between these two at the 2 dB step with the worst Error. AGC_PreamME = Max(|Avg(Rx_meas) - Rx_applied|).

4.9.4 Amazon Sidewalk RF Receiver Characteristics

4.9.4.1 915 MHz Band Receiver Characteristics for Amazon Sidewalk

Band is 902 to 928 MHz. Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RFVDD and external PA supply paths filtered using ferrites. RF center frequency 915 MHz.

Table 4.35. 915 MHz Band Receiver Characteristics for Amazon Sidewalk

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		902	—	928	MHz
Sensitivity	SENS	Desired is reference 50 kbps 2GFSK signal, Δf = ± 25 kHz, PER<1%, no FEC [1]	—	-108.6	—	dBm
Adjacent channel rejection, Interferer is CW at ± 1 × channel spacing	ACR1	Desired is reference 50 kbps 2GFSK signal, PER<1%, no FEC [1] at 3dB above sensitivity level[2].	—	44.9	—	dB
Alternate channel rejection, Interferer is CW at ± 2 × channel spacing	ACR2	Desired is reference 50 kbps 2GFSK signal, PER<1%, no FEC [1] at 3dB above sensitivity level[2].	—	52.1	—	dB
Image rejection, Interferer is CW at image frequency	IR	Desired is reference 50 kbps 2GFSK signal, no FEC [1] at 3dB above sensitivity level[2].	—	45.1	—	dB
Blocking Selectivity U/D ratio for 1% PER. Desired signal at 3 dB above required sensitivity[2]. Undesired signal is CW at ± 1 MHz frequency offset.	$BLOCK_{1M}$	PER<1%, 50 kbps 2GFSK, no FEC [1]	—	64.7	—	dB
Blocking Selectivity U/D ratio. Desired signal at 3 dB above required sensitivity[2]. Undesired signal is CW at ± 2 MHz frequency offset.	$BLOCK_{2M}$	PER<1%, 50 kbps 2GFSK, no FEC [1]	—	72.0	—	dB
Blocking Selectivity U/D ratio. Desired signal at 3 dB above required sensitivity[2]. Undesired signal is CW at ± 10 MHz frequency offset.	$BLOCK_{10M}$	PER<1%, 50 kbps 2GFSK, no FEC [1]	—	81.0	—	dB

Note:

1. Definition of reference signal is 50 kbps 2GFSK, BT=1, mi=1.0, Δf = ± 25 kHz, Channel Spacing = 200 kHz, 128 Byte Packet Length, no FEC.
2. Required sensitivity is -91dBm.

4.10 2.4 GHz BLE RF Transceiver Characteristics

4.10.1 2.4 GHz BLE RF Transmitter Characteristics

4.10.1.1 RF Transmitter General Characteristics for the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RF center frequency 2.45 GHz.

Table 4.36. RF Transmitter General Characteristics for the 2.4 GHz Band

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF test frequency range	F_{RANGE}		2400	—	2483.5	MHz
Maximum TX power[1]	$POUT_{MAX}$	10 dBm PA	—	11.4	—	dBm
Minimum active TX power	$POUT_{MIN}$	10 dBm PA	—	-21.0	—	dBm
Output power variation vs PAVDD supply voltage variation, frequency = 2450 MHz	$POUT_{VAR_V}$	10 dbm PA output power with PAVDD voltage swept from 1.8 V to 3.0 V	—	0.03	—	dB
Output power variation vs RF frequency	$POUT_{VAR_F}$	10 dBm PA, 10 dBm	—	0.3	—	dB
Spurious emissions of harmonics in restricted bands per FCC Part 15.205/15.209	$SPUR_{HRM_FCC_R}$	Continuous transmission of CW carrier, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz.	—	-52.2	—	dBm
Spurious emissions out-of-band (above 2.483 GHz or below 2.4 GHz) in restricted bands, per FCC part 15.205/15.209	$SPUR_{OOB_FCC_R}$	Restricted bands 30-88 MHz, Continuous transmission of CW carrier, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-70.3	—	dBm
		Restricted bands 88 - 216 MHz, Continuous transmission of CW carrier, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-68.7	—	dBm
		Restricted bands 216 - 960 MHz, Continuous transmission of CW carrier, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-61.8	—	dBm
		Restricted bands > 960 MHz, Continuous transmission of CW carrier, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-50.1	—	dBm
Spurious emissions out-of-band in non-restricted bands per FCC Part 15.247	$SPUR_{OOB_FCC_NR}$	Frequencies above 2.483 GHz or below 2.4 GHz, continuous transmission CW carrier, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-45.2	—	dBc

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Spurious emissions out-of-band, per ETSI 300.328	$SPUR_{ETSI328}$	[2400-BW to 2400], [2483.5 to 2483.5+BW] P_{out} = $POUT_{MAX}$, Test Frequency = 2402 & 2480 MHz	—	-31.3	-10	dBm
		[2400-2BW to 2400-BW], [2483.5+BW to 2483.5+2BW], P_{out} = $POUT_{MAX}$, Test Frequency = 2402 & 2480 MHz	—	-35.4	-20	dBm
		47-74 MHz, 87.5-118 MHz, 174-230 MHz, 470-862 MHz, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-65.7	-54	dBm
		30-47 MHz, 74-87.5 MHz, 118-174 MHz, 230-470 MHz, 862-1000 MHz , P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-61.3	-36	dBm
		1G-12.75 GHz, excluding bands listed above, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-41.8	-30	dBm
Spurious emissions per ETSI EN300.440	$SPUR_{ETSI440}$	47-74 MHz,87.5-108 MHz, 174-230 MHz, 470-862 MHz, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-65.5	-54	dBm
		25-1000 MHz, excluding above frequencies. P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-61.9	-36	dBm
		1G-14G, P_{out} = $POUT_{MAX}$, Test Frequency = 2450 MHz	—	-39.9	-30	dBm

Note:

1. Supported transmit power levels are determined by the ordering part number (OPN). Transmit power ratings for all devices covered in this data sheet can be found in the Max TX Power column of the Ordering Information Table.

4.10.1.2 RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RF center frequency 2.45 GHz.

Table 4.37. RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Transmit 6 dB bandwidth	TXBW	P_{out} = 10 dBm	—	814	—	kHz
Power spectral density limit	PSD_{LIMIT}	P_{out} = 10 dBm, Per FCC part 15.247 at 10 dBm	—	-10.5	—	dBm/ 3kHz
		Per ETSI 300.328 at 10 dBm/1 MHz	—	9.9	—	dBm
Occupied channel bandwidth per ETSI EN300.328	$OCP_{ETSI328}$	P_{out} = 10 dBm 99% BW at highest and lowest channels in band	—	1	—	MHz
In-band spurious emissions, with allowed exceptions[1]	$SPUR_{INB}$	P_{out} = 10 dBm, Inband spurs at ± 2 MHz	—	-38.2	—	dBm
		P_{out} = 10 dBm Inband spurs at ± 3 MHz	—	-42.9	—	dBm

Note:

1. Per Bluetooth Core_5.3, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.10.1.3 RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RF center frequency 2.45 GHz.

Table 4.38. RF Transmitter Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Transmit 6 dB bandwidth	TXBW	P_{out} = 10 dBm	—	1432	—	kHz
Power spectral density limit	PSD_{LIMIT}	P_{out} = 10 dBm, Per FCC part 15.247 at 10 dBm	—	-8.7	—	dBm/ 3kHz
		Per ETSI 300.328 at 10 dBm/1 MHz	—	9.9	—	dBm
Occupied channel bandwidth per ETSI EN300.328	$OCP_{ETSI328}$	P_{out} = 10 dBm 99% BW at highest and lowest channels in band	—	2.1	—	MHz
In-band spurious emissions, with allowed exceptions[1]	$SPUR_{INB}$	P_{out} = 10 dBm, Inband spurs at ± 4 MHz	—	-43.4	—	dBm
		P_{out} = 10 dBm Inband spurs at ± 6 MHz	—	-48.6	—	dBm

Note:

1. Per Bluetooth Core_5.3, Vol.6 Part A, Section 3.2.2, exceptions are allowed in up to three bands of 1 MHz width, centered on a frequency which is an integer multiple of 1 MHz. These exceptions shall have an absolute value of -20 dBm or less.

4.10.2 2.4 GHz BLE RF Receiver Characteristics

4.10.2.1 RF Receiver General Characteristics for the 2.4 GHz Band

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RF center frequency 2.45 GHz.

Table 4.39. RF Receiver General Characteristics for the 2.4 GHz Band

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF tuning frequency range	F_{RANGE}		2400	—	2483.5	MHz
Receive mode maximum spurious emission	$SPUR_{RX}$	30 MHz to 1 GHz	—	-90.2	—	dBm
		1 GHz to 12 GHz	—	-50.7	—	dBm
Max spurious emissions during active receive mode, per FCC Part 15.109(a)	$SPUR_{RX_FCC}$	216 MHz to 960 MHz, conducted measurement	—	-93.1	—	dBm
		Above 960 MHz, conducted measurement.	—	-51.1	—	dBm

4.10.2.2 RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RF center frequency 2.45 GHz, Packet length is 255 bytes.

Table 4.40. RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 1 Mbps Data Rate

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Rx Max Strong Signal Input Level for 0.1% BER	RX_{SAT}	Signal is reference signal, packet length is 255 bytes[1]	—	—	10	dBm
Sensitivity	SENS	Signal is reference signal, 37 byte payload[2]	—	-95.6	—	dBm
		Signal is reference signal, 255 byte payload[1]	—	-94.2	—	dBm
		With non-ideal signals, 255 byte payload[3] [1]	—	-93.9	—	dBm
Signal to co-channel interferer	C/I_{CC}	(see notes), 255 byte payload[1] [4]	—	9.1	—	dB
N ± 1 Adjacent channel selectivity	C/I_1	Interferer is reference signal at +1 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-5.5	—	dB
		Interferer is reference signal at -1 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-4.9	—	dB
N ± 2 Alternate channel selectivity	C/I_2	Interferer is reference signal at +2 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-37.9	—	dB
		Interferer is reference signal at -2 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-39.4	—	dB
N ± 3 Alternate channel selectivity	C/I_3	Interferer is reference signal at +3 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-45.6	—	dB
		Interferer is reference signal at -3 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-45.3	—	dB
Selectivity to image frequency	C/I_{IM}	Interferer is reference signal at image frequency with 1 MHz precision, 255 byte payload[1] [6]	—	-17.2	—	dB
Selectivity to image frequency ± 1 MHz	C/I_{IM_1}	Interferer is reference signal at image frequency +1 MHz with 1 MHz precision, 255 byte payload[1] [6]	—	-37.9	—	dB
		Interferer is reference signal at image frequency -1 MHz with 1 MHz precision, 255 byte payload[1] [6]	—	-5.5	—	dB
Intermodulation performance	IM	n = 3, 255 byte payload[7]	—	-19.3	—	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. 0.017% Bit Error Rate.
2. 0.1% Bit Error Rate.
3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1
4. Desired signal -67 dBm.
5. Desired frequency 2402 MHz ≤ Fc ≤ 2480 MHz.
6. With allowed exceptions.
7. As specified in Bluetooth Core specification version 5.1, Vol 6, Part A, Section 4.4

4.10.2.3 RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

Unless otherwise indicated, typical conditions are: T_A = 25 °C, VREGVDD = 3.3 V, AVDD = DVDD = IOVDD = RFVDD = PAVDD = 1.8 V powered from DCDC. Crystal frequency = 39 MHz. RF center frequency 2.45 GHz, Packet length is 255 bytes.

Table 4.41. RF Receiver Characteristics for Bluetooth Low Energy in the 2.4 GHz Band 2 Mbps Data Rate

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Rx Max Strong Signal Input Level for 0.1% BER	RX_{SAT}	Signal is reference signal, packet length is 255 bytes[1]	—	—	10	dBm
Sensitivity	SENS	Signal is reference signal, 37 byte payload[2]	—	-92.7	—	dBm
		Signal is reference signal, 255 byte payload[1]	—	-91.3	—	dBm
		With non-ideal signals, 255 byte payload[3] [1]	—	-91.1	—	dBm
Signal to co-channel interferer	C/I_{CC}	(see notes), 255 byte payload[1] [4]	—	9.0	—	dB
N ± 1 Adjacent channel selectivity	C/I_1	Interferer is reference signal at +2 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-5.4	—	dB
		Interferer is reference signal at -2 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-5.6	—	dB
N ± 2 Alternate channel selectivity	C/I_2	Interferer is reference signal at +4 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-34.8	—	dB
		Interferer is reference signal at -4 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-43.1	—	dB
N ± 3 Alternate channel selectivity	C/I_3	Interferer is reference signal at +6 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-47.3	—	dB
		Interferer is reference signal at -6 MHz offset, 255 byte payload[1] [5] [4] [6]	—	-48.3	—	dB
Selectivity to image frequency	C/I_{IM}	Interferer is reference signal at image frequency with 1 MHz precision, 255 byte payload[1] [6]	—	-17.4	—	dB
Selectivity to image frequency ± 1 MHz	C/I_{IM_1}	Interferer is reference signal at image frequency +2 MHz with 1 MHz precision, 255 byte payload[1] [6]	—	-34.8	—	dB
		Interferer is reference signal at image frequency -2 MHz with 1 MHz precision, 255 byte payload[1] [6]	—	-5.4	—	dB
Intermodulation performance	IM	n = 3, 255 byte payload[7]	—	-22.6	—	dBm

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit

Note:

1. 0.017% Bit Error Rate.
2. 0.1% Bit Error Rate.
3. With non-ideal signals as specified in Bluetooth Test Specification RF-PHY.TS.5.0.1 section 4.7.1
4. Desired signal -67 dBm.
5. Desired frequency 2402 MHz ≤ Fc ≤ 2480 MHz.
6. With allowed exceptions.
7. As specified in Bluetooth Core specification version 5.1, Vol 6, Part A, Section 4.4

4.11 Frequency Synthesizer

Table 4.42. Frequency Synthesizer

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RF synthesizer frequency range	f_{RANGE}	2400 - 2483.5 MHz	2400	—	2483.5	MHz
		742 - 970 MHz	742	—	970	MHz
		557 - 727 MHz	557	—	727	MHz
		372 - 557 MHz	372	—	557	MHz
		223 - 372 MHz	223	—	372	MHz
		110 - 223 MHz	110	—	223	MHz
LO tuning frequency resolution with 39.0 MHz crystal	f_{RES}	2400 - 2483.5 MHz	—	—	74.4	Hz
		742 - 970 MHz	—	—	24.8	Hz
		557 - 727 MHz	—	—	18.6	Hz
		372 - 557 MHz	—	—	14.9	Hz
		223 - 372 MHz	—	—	10.6	Hz
		110 - 223 MHz	—	—	6.2	Hz
Frequency deviation resolution with 39.0 MHz crystal	df_{RES}	2400 - 2483.5 MHz	—	—	74.4	Hz
		742 - 970 MHz	—	—	24.8	Hz
		557 - 727 MHz	—	—	18.6	Hz
		372 - 557 MHz	—	—	14.9	Hz
		223 - 372 MHz	—	—	10.6	Hz
		110 - 223 MHz	—	—	6.2	Hz
Maximum frequency deviation with 39.0 MHz crystal	df_{MAX}	2400 - 2483.5 MHz	—	—	1850	kHz
		742 - 970 MHz	—	—	617	kHz
		557 - 727 MHz	—	—	463	kHz
		372 - 557 MHz	—	—	308	kHz
		223 - 372 MHz	—	—	185	kHz
		110 - 223 MHz	—	—	116	kHz

4.12 Oscillators

4.12.1 High Frequency Crystal Oscillator

Unless otherwise indicated, typical conditions are: AVDD = DVDD = 3.3 V. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation, operating supply voltage range, and operating temperature range.

Table 4.43. High Frequency Crystal Oscillator

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Crystal Frequency	F_{HFXO}	see note[1]	38.0	39.0	40.0	MHz
Supported range of crystal load capacitance[2]	C_{L_HFXO}	39.0 MHz[3]	—	10	—	pF
Supported crystal maximum equivalent series resistance (ESR)	ESR_{HFXO}	39.0 MHz[4]	—	—	60	Ω
Supply Current	I_{HFXO}		—	498	—	µA
Startup Time[5]	$T_{STARTUP}$	39.0 MHz, C_L = 10 pF[3]	—	178	—	µs
On-chip tuning cap step size[6]	SS_{HFXO}		—	0.04	—	pF

Note:

1. All sub-GHz RF measurements made using a 39 MHz crystal. Other crystal frequencies supported, but RF performance may vary.
2. Total load capacitance as seen by the crystal.
3. RF performance characteristics have been determined using crystals with a maximum ESR of 35 Ω and C_L of 10 pF.
4. The crystal should have a maximum ESR less than or equal to this maximum rating.
5. Startup time does not include time implemented by programmable TIMEOUTSTEADY delay.
6. The tuning step size is the effective step size when incrementing both of the tuning capacitors by one count. The step size for the each of the individual tuning capacitors is twice this value.

4.12.2 Low Frequency Crystal Oscillator

Table 4.44. Low Frequency Crystal Oscillator

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Crystal Frequency	F_{LFXO}		—	32.768	—	kHz
Supported Crystal equivalent series resistance (ESR)	ESR_{LFXO}	GAIN = 0	—	—	80	kΩ
		GAIN = 1 to 3	—	—	100	kΩ
Supported range of crystal load capacitance [1]	C_{L_LFXO}	GAIN = 0	4	—	6	pF
		GAIN = 1	6	—	10	pF
		GAIN = 2 (see note[2])	10	—	12.5	pF
		GAIN = 3 (see note[2])	12.5	—	18	pF
Current consumption	I_{CL12p5}	ESR = 70 kΩ, C_L = 12.5 pF, GAIN[3] = 2, AGC[4] = 1	—	260	—	nA
Startup Time	$T_{STARTUP}$	ESR = 70 kΩ, C_L = 7 pF, GAIN[3] = 1, AGC[4] = 1	—	74	—	ms
On-chip tuning cap step size	SS_{LFXO}		—	0.26	—	pF
On-chip tuning capacitor value at minimum setting[5]	C_{LFXO_MIN}	CAPTUNE = 0	—	4	—	pF
On-chip tuning capacitor value at maximum setting[5]	C_{LFXO_MAX}	CAPTUNE = 0x4F	—	24.5	—	pF

Note:

1. Total load capacitance seen by the crystal
2. Crystals with a load capacitance of greater than 12 pF require external load capacitors.
3. In LFXO_CAL Register
4. In LFXO_CFG Register
5. The effective load capacitance seen by the crystal will be $C_{LFXO}/2$. This is because each XTAL pin has a tuning cap and the two caps will be seen in series by the crystal

4.12.3 High Frequency RC Oscillator (HFRCO)

Unless otherwise indicated, typical conditions are: AVDD = DVDD = 3.3 V. T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation, operating supply voltage range, and operating temperature range.

Table 4.45. High Frequency RC Oscillator (HFRCO)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Frequency Accuracy	F_{HFRCO_ACC}	For all production calibrated frequencies	-3	—	3	%
Current consumption on all supplies[1]	I_{HFRCO}	F_{HFRCO} = 4 MHz	—	28	—	µA
		F_{HFRCO} = 5 MHz[2]	—	29	—	µA
		F_{HFRCO} = 7 MHz	—	59	—	µA
		F_{HFRCO} = 10 MHz[2]	—	63	—	µA
		F_{HFRCO} = 13 MHz	—	77	—	µA
		F_{HFRCO} = 16 MHz	—	87	—	µA
		F_{HFRCO} = 19 MHz	—	90	—	µA
		F_{HFRCO} = 20 MHz[2]	—	107	—	µA
		F_{HFRCO} = 26 MHz	—	116	—	µA
		F_{HFRCO} = 32 MHz	—	139	—	µA
		F_{HFRCO} = 38 MHz[3]	—	170	—	µA
		F_{HFRCO} = 40 MHz[2]	—	172	—	µA
		F_{HFRCO} = 48 MHz[3]	—	207	—	µA
		F_{HFRCO} = 56 MHz[3]	—	228	—	µA
		F_{HFRCO} = 64 MHz[3]	—	269	—	µA
		F_{HFRCO} = 80 MHz[3]	—	285	—	µA
Clock Out current for HFRCODPLL[4]	$I_{CLKOUT_HFRCODPLL}$	FORCEEN bit of HFRCO0_CTRL = 1	—	3.0	—	µA/MHz
Clock Out current for HFRCOEM23[4]	$I_{CLKOUT_HFRCOEM23}$	FORCEEN bit of HFRCOEM23_CTRL = 1	—	1.6	—	µA/MHz
Startup Time[5]	$T_{STARTUP}$	FREQRANGE = 0 to 7	—	1.2	—	µs
		FREQRANGE = 8 to 15	—	0.6	—	µs

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Band Frequency Limits[6]	f_{HFRCO_BAND}	FREQRANGE = 0	3.71	—	5.24	MHz
		FREQRANGE = 1	4.39	—	6.26	MHz
		FREQRANGE = 2	5.25	—	7.55	MHz
		FREQRANGE = 3	6.22	—	9.01	MHz
		FREQRANGE = 4	7.88	—	11.6	MHz
		FREQRANGE = 5	9.9	—	14.6	MHz
		FREQRANGE = 6	11.5	—	17	MHz
		FREQRANGE = 7	14.1	—	20.9	MHz
		FREQRANGE = 8	16.4	—	24.7	MHz
		FREQRANGE = 9	19.8	—	30.4	MHz
		FREQRANGE = 10	22.7	—	34.9	MHz
		FREQRANGE = 11	28.6	—	44.4	MHz
		FREQRANGE = 12	33	—	51.1	MHz
		FREQRANGE = 13	42.2	—	64.6	MHz
		FREQRANGE = 14	48.8	—	74.8	MHz
		FREQRANGE = 15	57.6	—	87.4	MHz

Note:

1. Does not include additional clock tree current. See specifications for additional current when selected as a clock source for a particular clock multiplexer.
2. This frequency is calibrated for the HFRCOEM23 only.
3. This frequency is calibrated for the HFRCODPLL (HFRCO0) only.
4. When the HFRCO is enabled for characterization using the FORCEEN bit, the total current will be the HFRCO core current plus the specified CLKOUT current. When the HFRCO is enabled on demand, the clock current may be different.
5. Hardware delay ensures settling to within ± 0.5%. Hardware also enforces this delay on a band change.
6. The frequency band limits represent the lowest and highest frequency which each band can achieve over the operating range.

4.12.4 Fast Start_Up RC Oscillator (FSRCO)

Table 4.46. Fast Start_Up RC Oscillator (FSRCO)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
FSRCO frequency	F_{FSRCO}		17.2	20	21.2	MHz

4.12.5 Low Frequency RC Oscillator (LFRCO)

Table 4.47. Low Frequency RC Oscillator (LFRCO)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Nominal oscillation frequency	F_{LFRCO}		—	32.768	—	kHz
Frequency accuracy	F_{LFRCO_ACC}		-3	—	3	%
Frequency calibration step	F_{TRIM_STEP}	Typical trim step at mid-scale	—	0.33	—	%
Startup time	$t_{STARTUP}$		—	231	—	µs
Current consumption	I_{LFRCO}		—	177	—	nA

4.12.6 Ultra Low Frequency RC Oscillator

Table 4.48. Ultra Low Frequency RC Oscillator

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Oscillation Frequency	F_{ULFRCO}		0.944	1.0	1.095	kHz

4.13 GPIO Pins

Table 4.49. GPIO Pins

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Leakage current	I_{LEAK_IO}	MODEx = DISABLED, IOVDD = 1.71 V	—	1.9	—	nA
		MODEx = DISABLED, IOVDD = 3.3 V	—	2.5	—	nA
		MODEx = DISABLED, IOVDD = 3.8 V, T_A = 125 °C, Pins PA00, PB00, and PB01	—	—	250	nA
		MODEx = DISABLED, IOVDD = 3.8 V, T_A = 125 °C, all other GPIO	—	—	200	nA
Input low voltage[1]	V_{IL}	Any GPIO pin	—	—	0.3 * IOVDD	V
		RESETn	—	—	0.3 * DVDD	V
Input high voltage[1]	V_{IH}	Any GPIO pin	0.7 * IOVDD	—	—	V
		RESETn	0.7 * DVDD	—	—	V
Hysteresis of input voltage	V_{HYS}	Any GPIO pin	0.05 * IOVDD	—	—	V
		RESETn	0.05 * DVDD	—	—	V
Output high voltage	V_{OH}	Sourcing 20mA, IOVDD = 3.3 V	0.8 * IOVDD	—	—	V
		Sourcing 8mA, IOVDD = 1.71 V	0.6 * IOVDD	—	—	V
Output low voltage	V_{OL}	Sinking 20mA, IOVDD = 3.3 V	—	—	0.2 * IOVDD	V
		Sinking 8mA, IOVDD = 1.71 V	—	—	0.4 * IOVDD	V
GPIO rise time	T_{GPIO_RISE}	IOVDD = 3.3 V, C_{load} = 50pF, SLEWRATE = 4, 10% to 90%	—	8.4	—	ns
		IOVDD = 1.7 V, C_{load} = 50pF, SLEWRATE = 4, 10% to 90%	—	13	—	ns
GPIO fall time	T_{GPIO_FALL}	IOVDD = 3.3 V, C_{load} = 50pF, SLEWRATE = 4, 90% to 10%	—	7.1	—	ns
		IOVDD = 1.7 V, C_{load} = 50pF, SLEWRATE = 4, 90% to 10%	—	11.9	—	ns
Pull up/down resistance[2]	R_{PULL}	Any GPIO pin. Pull-up to IOVDD: MODEn = DISABLE DOUT=1. Pull-down to VSS: MODEn = WIREDORPULLDOWN DOUT = 0.	33	44	55	kΩ
		RESETn pin. Pull-up to DVDD	33	44	55	kΩ
Maximum filtered glitch width	T_{GF}	MODE = INPUT, DOUT = 1	—	27	—	ns

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
RESETn low time to ensure pin reset	T_{RESET}		100	—	—	ns

Note:

1. GPIO input thresholds are proportional to the IOVDD pin. RESETn input thresholds are proportional to DVDD.
2. GPIO pull-ups connect to IOVDD supply, pull-downs connect to VSS. RESETn pull-up connects to DVDD.

4.14 Analog to Digital Converter (IADC)

Specified at 1 Msps, ADCCLK = 10 MHz, OSR = 2, unless otherwise indicated.

Table 4.50. Analog to Digital Converter (IADC)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Main analog supply	V_{AVDD}	Normal mode	1.71	—	3.8	V
Maximum Input Range[1]	V_{IN_MAX}	Maximum allowable input voltage	0	—	AVDD	V
Full-Scale Voltage	V_{FS}	Voltage required for Full-Scale measurement	—	V_{REF} / Gain	—	V
Input Measurement Range	V_{IN}	Differential Mode - Plus and Minus inputs	$-V_{FS}$	—	$+V_{FS}$	V
		Single Ended Mode - One input tied to ground	0	—	V_{FS}	V
Input Sampling Capacitance	Cs	Analog Gain = 1x	—	1.8	—	pF
		Analog Gain = 2x	—	3.6	—	pF
		Analog Gain = 3x	—	5.4	—	pF
		Analog Gain = 4x	—	7.2	—	pF
		Analog Gain = 0.5x	—	0.9	—	pF
ADC clock frequency	f_{ADC_CLK}	Normal mode, Gain = 1x or 0.5x	—	—	10	MHz
		Normal mode, Gain = 2x	—	—	5	MHz
		Normal mode, Gain = 3x or 4x	—	—	2.5	MHz
Input sampling frequency	f_S	Normal Mode	—	$f_{ADC_CLK}/4$	—	MHz
Throughput rate	f_{SAMPLE}	Normal mode, f_{ADC_CLK} = 10 MHz, OSR = 2	—	—	1	Msps
		Normal mode, f_{ADC_CLK} = 10 MHz, OSR = 32	—	—	76.9	ksps
Current from all supplies, Continuous operation	I_{ADC_CONT}	Normal Mode, 1 Msps, OSR = 2, f_{ADC_CLK} = 10 MHz	—	305	385	µA
Current in Standby mode. ADC is not functional but can wake up in 1us.	I_{STBY}	Normal mode	—	17	—	µA
ADC Startup Time	$t_{startup}$	From power down state	—	5	—	µs
		From standby state	—	1	—	µs
Normal Mode ADC Resolution[2]	Resolution	OSR = 2	—	12	—	bits
		OSR = 32	—	16	—	bits
Differential Nonlinearity	DNL	Normal mode. Differential Input. OSR = 2 (No missing codes)	-1	+/- 0.25	1.5	LSB12
Integral Nonlinearity	INL	Normal mode. Differential Input, OSR = 2	-2.5	+/- 0.65	2.5	LSB12

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Effective number of bits[3]	ENOB	Normal Mode, Differential Input. Gain = 1x, OSR = 2, f_{IN} = 10 kHz, Internal VREF = 1.21V	10.7	11.7	—	bits
		Normal Mode, Differential Input. Gain = 1x, OSR = 32, f_{IN} = 2.5 kHz, Internal VREF = 1.21 V.	—	13.5	—	bits
		Normal Mode, Differential Input. Gain = 1x, OSR = 32, f_{IN} = 2.5 kHz, External VREF = 1.25 V.	—	14.3	—	bits
Signal to Noise + Distortion Ratio Normal Mode[3]	SNDR	Differential Input. Gain=1x, OSR = 2, f_{IN} = 10 kHz, Internal VREF = 1.21V	66	72.3	—	dB
		Differential Input. Gain=2x, OSR = 2, f_{IN} = 10 kHz, Internal VREF = 1.21V	—	72.3	—	dB
		Differential Input. Gain=4x, OSR = 2, f_{IN} = 10 kHz, Internal VREF = 1.21V	—	68.8	—	dB
		Differential Input. Gain=0.5x, OSR = 2, f_{IN} = 10 kHz, Internal VREF = 1.21V	—	72.5	—	dB
		Differential Input. Gain = 1x, OSR = 64, f_{IN} = 1.25 kHz, Internal VREF = 1.21 V	—	83.9	—	dB
Total Harmonic Distortion	THD	Normal mode, Differential Input. Gain = 1x, OSR = 2, f_{IN} = 10 kHz, Internal VREF = 1.21 V	—	-80.8	-70	dB
Spurious-Free Dynamic Range	SFDR	Normal mode, Differential Input. Gain = 1x, OSR = 2, f_{IN} = 10 kHz, Internal VREF = 1.21 V	72	86.5	—	dB
Common Mode Rejection Ratio	CMRR	Normal mode. DC to 100 Hz	—	87.0	—	dB
		Normal mode. AC high frequency.	—	68.6	—	dB
Power Supply Rejection Ratio	PSRR	Normal mode. DC to 100 Hz	—	80.4	—	dB
		Normal mode. AC high frequency, using internal VBGR	—	33.4	—	dB
		Normal mode. AC high frequency, using VREF pad	—	65.2	—	dB
External reference voltage range[1]	V_{EVREF}		1.0	—	AVDD	V
Offset Error, Normal mode	OFFSET	GAIN = 1 and 0.5, Differential Input	-3	0.27	3	LSB12
		GAIN = 2, Differential Input	-4	0.27	4	LSB12
		GAIN = 3, Differential Input	-4	0.25	4	LSB12
		GAIN = 4, Differential Input	-4	0.29	4	LSB12

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Gain Error, Normal mode	GE	GAIN = 1 and 0.5, using external VREF, direct mode, f_{ADC_CLK} = 10 MHz	-0.3	0.069	0.3	%
		GAIN = 2, using external VREF, direct mode, f_{ADC_CLK} = 5 MHz	-0.4	0.151	0.4	%
		GAIN = 3, using external VREF, direct mode, f_{ADC_CLK} = 2.5 MHz	-0.7	0.186	0.7	%
		GAIN = 4, using external VREF, direct mode, f_{ADC_CLK} = 2.5 MHz	-1.1	0.227	1.1	%
		Internal VREF [4], all GAIN settings	-1.5	0.023	1.5	%
Internal Reference voltage	V_{IVREF}		—	1.21	—	V

Note:

1. When inputs are routed to external GPIO pins, the maximum pin voltage is limited to the lower of the IOVDD and AVDD supplies.
2. ADC output resolution depends on the OSR and digital averaging settings. With no digital averaging, ADC output resolution is 12 bits at OSR = 2, 13 bits at OSR = 4, 14 bits at OSR = 8, 15 bits at OSR = 16, 16 bits at OSR = 32 and 17 bits at OSR = 64. Digital averaging has a similar impact on ADC output resolution. See the product reference manual for additional details.
3. The relationship between ENOB and SNDR is specified according to the equation: ENOB = (SNDR - 1.76) / 6.02.
4. Includes error from internal VREF drift.

4.15 Analog Comparator (ACMP)

Table 4.51. Analog Comparator (ACMP)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
ACMP Supply current	I_{ACMP}	BIAS = 0 [1], HYST = DISABLED (100 °C max)	—	65	—	nA
		BIAS = 1 [1], HYST = DISABLED	—	265	—	nA
		BIAS = 2 [1], HYST = DISABLED	—	671	—	nA
		BIAS = 3 [1], HYST = DISABLED	—	2.5	—	µA
		BIAS = 4, HYST = DISABLED	—	5.4	—	µA
		BIAS = 5, HYST = DISABLED	—	10.9	—	µA
		BIAS = 6, HYST = DISABLED	—	28	—	µA
		BIAS = 7, HYST = DISABLED	—	51	100	µA
ACMP Supply current with Hysteresis	I_{ACMP_WHYS}	BIAS = 0 [1], HYST = SYM30MV (100 °C max)	—	84	—	nA
		BIAS = 1 [1], HYST = SYM30MV	—	363	—	nA
		BIAS = 2 [1], HYST = SYM30MV	—	929	—	nA
		BIAS = 3 [1], HYST = SYM30MV	—	3.5	—	µA
		BIAS = 4, HYST = SYM30MV	—	7.3	—	µA
		BIAS = 5, HYST = SYM30MV	—	15.4	—	µA
		BIAS = 6, HYST = SYM30MV	—	39	—	µA
		BIAS = 7, HYST = SYM30MV	—	72	—	µA
Current consumption from VREFDIV in continuous mode	$I_{VREFDIV}$	NEGSEL = VREFDIVAVDD	—	3.5	—	µA
		NEGSEL = VREFDIV1V25	—	4.3	—	µA
		NEGSEL = VREFDIV2V5	—	7.0	—	µA
Current consumption from VREFDIV in sample/hold mode	$I_{VREFDIV_SH}$	NEGSEL = VREFDIV2V5LP	—	77	—	nA
		NEGSEL = VREFDIV1V25LP	—	73	—	nA
		NEGSEL = VREFDIVAVDDLP	—	72	—	nA
Current consumption from VSENSEDIV in continuous mode	$I_{VSENSEDIV}$	NEGSEL = VSENSE01DIV4	—	1.8	—	µA
Current consumption from VSENSEDIV in sample/hold mode	$I_{VSENSEDIV_SH}$	NEGSEL = VSENSE01DIV4LP	—	59	—	nA
Hysteresis (BIAS = 0)	V_{HYST_0}	HYST = SYM10MV[2]	—	21	—	mV
		HYST = SYM20MV[2]	—	39	—	mV
		HYST = SYM30MV[2]	—	55	—	mV
Reference Voltage	$V_{ACMPREF}$	Internal 1.25 V Reference	1.19	1.25	1.31	V
		Internal 2.5 V Reference	2.34	2.5	2.75	V

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Input offset voltage	V_{OFFSET}	BIAS = 0, VCM = 0.15 to AVDD - 0.15 V	-25	—	25	mV
		BIAS = 2, VCM = 0.15 to AVDD - 0.15 V	-25	—	25	mV
		BIAS = 4, VCM = 0.15 to AVDD - 0.15 V	-25	—	25	mV
		BIAS = 7, VCM = 0.15 to AVDD - 0.15 V	-30	—	30	mV
Input Range	V_{IN}	Input Voltage Range	0	—	AVDD	V
Comparator delay with 100 mV overdrive	T_{DELAY}	BIAS = 0, (100 °C max)	—	10	—	µs
		BIAS = 1	—	2.8	—	µs
		BIAS = 2	—	1.3	—	µs
		BIAS = 3	—	0.53	—	µs
		BIAS = 4	—	218	—	ns
		BIAS = 5	—	123	—	ns
		BIAS = 6	—	73	—	ns
		BIAS = 7	—	58	—	ns
Capacitive Sense Oscillator Resistance[3]	$R_{CSRESSEL}$	CSRESSEL = 0	—	14	—	kΩ
		CSRESSEL = 1	—	24	—	kΩ
		CSRESSEL = 2	—	43	—	kΩ
		CSRESSEL = 3	—	60	—	kΩ
		CSRESSEL = 4	—	80	—	kΩ
		CSRESSEL = 5	—	99	—	kΩ
		CSRESSEL = 6	—	120	—	kΩ

Note:

1. When using the 1.25 V or 2.5 V VREF in continuous mode (VREFDIV1V25 or VREFDIV2V5) and BIAS < 4, an additional 1 µA of supply current is required.
2. V_{CM} = 1.25 V
3. Capacitive Sense has been deprecated and is not recommended for use.

4.16 Digital to Analog Converter (VDAC)

Table 4.52. Digital to Analog Converter (VDAC)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Output voltage	V_{DACOUT}		0	—	VREF	V
Output Current	I_{DACOUT}		-10	—	10	mA
DAC clock frequency	f_{DAC}		—	—	1	MHz
Sample rate	SR_{DAC}	$f_{DAC} = f_{DAC(max)}$	—	—	500	ksps
Resolution	$N_{RESOLUTION}$		—	12	—	bits
Load Capacitance[1]	C_{LOAD}	High Power and Lower Power Modes	—	—	50	pF
		High Capacitance Load Mode	25	—	—	nF
Load Resistance	R_{LOAD}		5	—	—	kΩ
Current consumption, Dynamic, 500 ksps, 1 channel active[2]	$I_{DAC_1_500}$	High Power Mode	—	253	—	µA
		Low Power Mode	—	154	—	µA
Current consumption, Dynamic, 500 ksps, 2 channels active[2]	$I_{DAC_2_500}$	High Power Mode	—	430	—	µA
		Low Power Mode	—	225	—	µA
Current consumption, Static, 1 channel active[3]	$I_{DAC_1_STAT}$	High Power Mode	—	77	—	µA
		Low Power Mode	—	31	—	µA
		High Capacitance Mode	—	42	—	µA
Current consumption, Static, 2 channels active[3]	$I_{DAC_2_STAT}$	High Power Mode	—	258	400	µA
		Low Power Mode	—	53	65	µA
		High Capacitance Mode	—	74	—	µA
Startup time	$t_{DACSTARTUP}$	Enable to 90% full scale output, settling to 10 LSB	—	4.5	4.9	µs
Settling time	$t_{DACSETTLE}$	High Power Mode, 25% to 75% of full scale, settling to 10 LSB	—	1.1	1.6	µs
		Low Power Mode, 25% to 75% of full scale, settling to 1%	—	2.7	—	µs
Output impedance	R_{OUT}	Main Output, High Power Mode	—	2.2	—	Ω
		Main Output, Low Power Mode	—	3.3	—	Ω
Power supply rejection ratio[4]	PSRR	Vout = 50% full scale, DC output	—	72	—	dB
Signal to noise and distortion ratio	$SNDR_{DAC}$	High Power mode, 500 ksps, internal 2.5 V reference, 1 kHz sine wave input, BW limited to 250 kHz	65.8	67.2	—	dB
		High Power mode, 500 ksps, internal 2.5 V reference, 1 kHz sine wave input, BW limited to 22 kHz	68.0	70.6	—	dB
Total Harmonic Distortion	THD	High Power Mode, internal 2.5 V reference, 1 kHz sine wave input	—	-72.5	-68.7	dB

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Integral Non-Linearity	INL_{DAC}	High Power Mode, Across full temperature range	-5	+/-1	5	LSB
Differential Non-Linearity[5]	DNL_{DAC}	High Power Mode, Across full temperature range	-1	+/-0.5	1.3	LSB
Offset error[6]	V_{OFFSET}	High Power mode	-15	—	15	mV
		Low Power Mode	-25	—	25	mV
		High Capacitance Load mode	-35	—	35	mV
Gain error[6]	V_{GAIN}	1.25 V internal reference	1.5	—	1.5	%
		2.5 V internal reference	-2	—	2	%
		External Reference	-0.6	—	0.6	%
External Reference Voltage[7]	V_{EXTREF}		1.1	—	V_AVDD	V

Note:

1. Main outputs only.
2. Dynamic current specifications are for VDAC circuitry operating at max clock frequency with the output updated at the specified sampling rate using DMA transfers. Output is a 1 kHz sine wave from 10% to 90% full scale. Specified current does not include current required to drive the external load. Measurement includes all current from AVDD and DVDD supplies.
3. Static current specifications are for VDAC circuitry operating after a one-time update to a static output at 50% full scale, with the VDAC APB clock disabled. Specified current does not include current required to drive the external load. Measurement includes all current from AVDD and DVDD supplies.
4. PSRR calculated as 20 * $\log_{10}(\Delta VDD / \Delta V_{OUT})$.
5. Entire range is monotonic and has no missing codes.
6. Gain is calculated by measuring the slope from 10% to 90% of full scale. Offset is calculated by comparing actual VDAC output at 10% of full scale to ideal VDAC output at 10% of full scale with the measured gain.
7. External reference voltage on VREFP pin or PA00 when used for VREFP

4.17 LCD

Table 4.53. LCD

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
LCD Temperature Range	T_{RANGE}		-40	—	105	°C
Frame rate	f_{LCDFR}		30	—	100	Hz
LCD supply range[1] [2]	V_{LCDIN}		1.71	—	3.8	V
LCD output voltage range[2]	V_{LCD}	Step-down mode with external LCD capacitor	2.4	—	MIN(3.6, V_{LCDIN} - 0.1)	V
		Charge pump mode with external LCD capacitor	2.4	—	MIN(3.6, 1.9 * V_{LCDIN})	V
Contrast control step size	$STEP_{CONTRAST}$	Charge pump or Step-down mode	—	50	—	mV
Contrast control step accuracy[3]	$ACC_{CONTRAST}$		—	+/-1.5	—	%

Note:

1. V_{LCDIN} is selectable between the AVDD or DVDD supply pins, depending on EMU_PWRCTRL_ANASW.
2. V_{LCDIN} and V_{LCD} should be a maximum of 2 V above $V_{IOVDD}$to avoid additional leakage through the GPIO pins used for LCD functions.
3. Step size accuracy is measured relative to the typical step size, and typ value represents one standard deviation.

4.18 Temperature Sensor

Table 4.54. Temperature Sensor

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Temperature sensor range[1]	T_{RANGE}		-40	—	125	°C
Temperature sensor resolution	$T_{RESOLUTION}$		—	0.25	—	°C
Measurement noise (RMS)	T_{NOISE}	Single measurement	—	0.6	—	°C
		16-sample average (TEMPAVGNUM = 0)	—	0.17	—	°C
		64-sample average (TEMPAVGNUM = 1)	—	0.12	—	°C
Temperature offset	T_{OFF}	Mean error of uncorrected output across full temperature range	—	3.1	—	°C
Temperature sensor accuracy[2] [3]	T_{ACC}	Direct output accuracy after mean error (T_{OFF}) removed	—	+/-3	—	°C
		After linearization in software, no calibration	—	+/-2	—	°C
		After linearization in software, with single-temperature calibration at 25 °C[4]	—	+/-1.5	—	°C
Measurement interval	t_{MEAS}		—	250	—	ms

Note:

1. The sensor reports absolute die temperature in Kelvin (K). All specifications are in °C to match the units of the specified product temperature range.
2. Error is measured as the deviation of the mean temperature reading from the expected die temperature. Accuracy numbers represent statistical minimum and maximum using ± 4 standard deviations of measured error.
3. The raw output of the temperature sensor is a predictable curve. It can be linearized with a polynomial function for additional accuracy.
4. Assuming calibration accuracy of ± 0.25 °C.

4.19 Brown Out Detectors

4.19.1 DVDD BOD

BOD thresholds on DVDD in EM0 and EM1 only, unless otherwise noted. Typical conditions are at T_A = 25 °C. Minimum and maximum values in this table represent the worst conditions across process variation, operating supply voltage range, and operating temperature range.

Table 4.55. DVDD BOD

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
BOD threshold	V_{DVDD_BOD}	Supply Rising	—	1.67	1.71	V
		Supply Falling	1.62	1.65	—	V
BOD response time	$t_{DVDD_BOD_DELAY}$	Supply dropping at 100 mV/µs slew rate[1]	—	0.95	—	µs
BOD hysteresis	$V_{DVDD_BOD_HYST}$		—	22	—	mV

Note:
1. If the supply slew rate exceeds the specified slew rate, the BOD may trip later than expected (at a threshold below the minimum specified threshold), or the BOD may not trip at all (e.g., if the supply ramps down and then back up at a very fast rate)

4.19.2 LE DVDD BOD

BOD thresholds on DVDD pin for low energy modes EM2 to EM4, unless otherwise noted.

Table 4.56. LE DVDD BOD

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
BOD threshold	$V_{DVDD_LE_BOD}$	Supply Falling	1.5	—	1.71	V
BOD response time	$t_{DVDD_LE_BOD_DELAY}$	Supply dropping at 2 mV/µs slew rate[1]	—	50	—	µs
BOD hysteresis	$V_{DVDD_LE_BOD_HYST}$		—	20	—	mV

Note:
1. If the supply slew rate exceeds the specified slew rate, the BOD may trip later than expected (at a threshold below the minimum specified threshold), or the BOD may not trip at all (e.g., if the supply ramps down and then back up at a very fast rate)

4.19.3 AVDD and IOVDD BODs

BOD thresholds for AVDD BOD and IOVDD BOD. Available in all energy modes.

Table 4.57. AVDD and IOVDD BODs

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
BOD threshold	V_{BOD}	Supply falling	1.45	—	1.71	V
BOD response time	t_{BOD_DELAY}	Supply dropping at 2 mV/µs slew rate[1]	—	50	—	µs
BOD hysteresis	V_{BOD_HYST}		—	20	—	mV

Note:

1. If the supply slew rate exceeds the specified slew rate, the BOD may trip later than expected (at a threshold below the minimum specified threshold), or the BOD may not trip at all (e.g., if the supply ramps down and then back up at a very fast rate)

4.20 Pulse Counter

Table 4.58. Pulse Counter

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Input frequency	F_{IN}	Asynchronous Single and Quadrature Modes	—	—	1.0	MHz
		Sampled Modes with Debounce filter set to 0.	—	—	8	kHz
Setup time in asynchronous external clock mode	$t_{SU_S1N_S0N}$	S1N (data) to S0N (clock)	50	—	—	ns
Hold time in asynchronous external clock mode	$t_{HD_S0N_S1N}$	S0N (clock) to S1N (data)	50	—	—	ns

4.21 USART SPI Main Timing

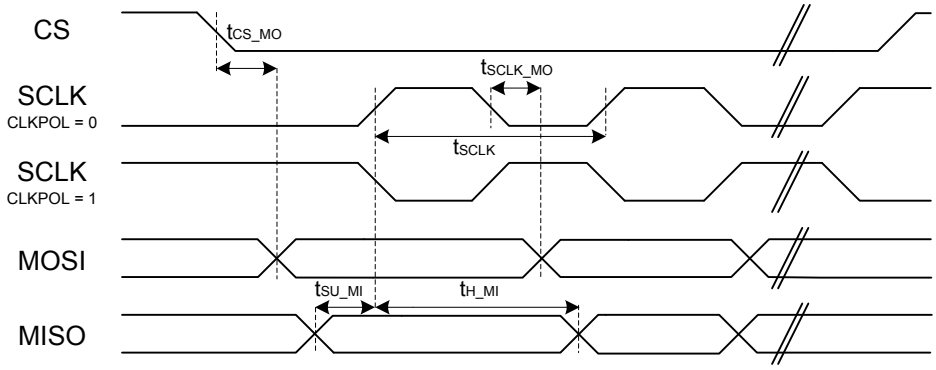

Figure 4.2. SPI Main Timing (SMSDELAY = 0)

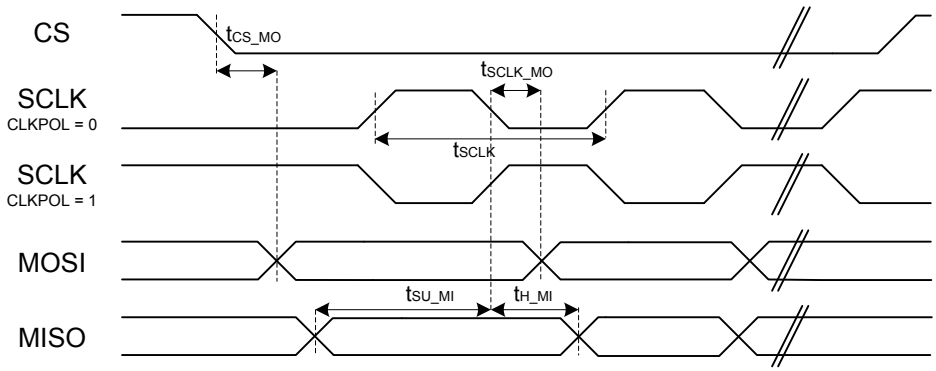

Figure 4.3. SPI Main Timing (SMSDELAY = 1)

4.21.1 USART SPI Main Timing, Voltage Scaling = VSCALE2

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.59. USART SPI Main Timing, Voltage Scaling = VSCALE2

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK period[1 2 3]	t_{SCLK}		2*t_{PCLK}	—	—	ns
CS to MOSI[1 2]	t_{CS_MO}		-21	—	23.5	ns
SCLK to MOSI[1 2]	t_{SCLK_MO}		-10	—	17	ns
MISO setup time[1 2]	t_{SU_MI}	IOVDD = 1.62 V	41.5	—	—	ns
		IOVDD = 3.3 V	31.5	—	—	ns
MISO hold time[1 2]	t_{H_MI}		-9.0	—	—	ns

Note:
1. Applies for both CLKPHA = 0 and CLKPHA = 1.
2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
3. t_{PCLK} is one period of the selected PCLK.

4.21.2 USART SPI Main Timing, Voltage Scaling = VSCALE1

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.60. USART SPI Main Timing, Voltage Scaling = VSCALE1

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK period[1 2 3]	t_{SCLK}		2*t_{PCLK}	—	—	ns
CS to MOSI[1 2]	t_{CS_MO}		-32.5	—	35.5	ns
SCLK to MOSI[1 2]	t_{SCLK_MO}		-9.5	—	32	ns
MISO setup time[1 2]	t_{SU_MI}	IOVDD = 1.62 V	52	—	—	ns
		IOVDD = 3.3 V	43.5	—	—	ns
MISO hold time[1 2]	t_{H_MI}		-9.5	—	—	ns

Note:
1. Applies for both CLKPHA = 0 and CLKPHA = 1.
2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply.
3. t_{PCLK} is one period of the selected PCLK.

4.22 USART SPI Secondary Timing

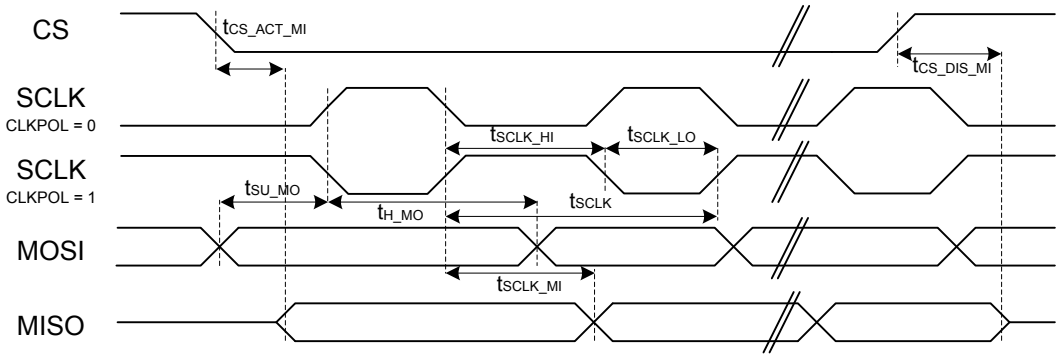

Figure 4.4. SPI Secondary Timing (SSSEARLY = 0)

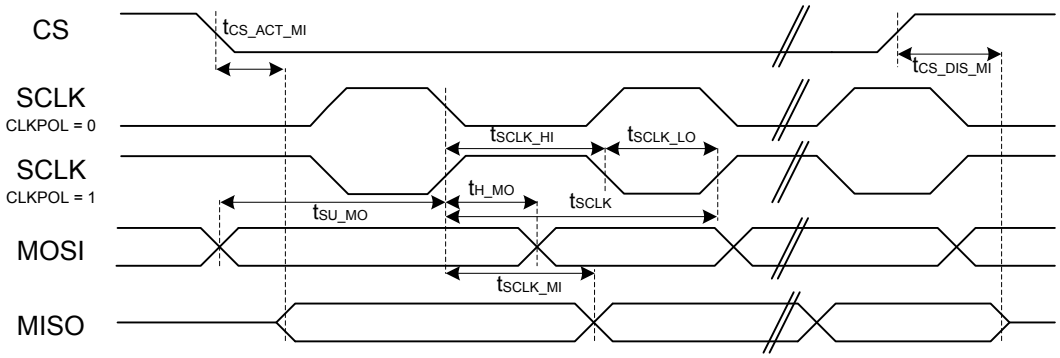

Figure 4.5. SPI Secondary Timing (SSSEARLY = 1)

4.22.1 USART SPI Secondary Timing, Voltage Scaling = VSCALE2

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.61. USART SPI Secondary Timing, Voltage Scaling = VSCALE2

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK period[1 2 3]	t_{SCLK}		6*t_{PCLK}	—	—	ns
SCLK high time[1 2 3]	t_{SCLK_HI}		2.5*t_{PCLK}	—	—	ns
SCLK low time[1 2 3]	t_{SCLK_LO}		2.5*t_{PCLK}	—	—	ns
CS active to MISO[1 2]	$t_{CS_ACT_MI}$		20	—	67.5	ns
CS disable to MISO[1 2]	$t_{CS_DIS_MI}$		20	—	60	ns
MOSI setup time[1 2]	t_{SU_MO}		7	—	—	ns
MOSI hold time[1 2 3]	t_{H_MO}		10	—	—	ns
SCLK to MISO[1 2 3]	t_{SCLK_MI}		15 + 1.5*t_{PCLK}	—	34 + 2.5*t_{PCLK}	ns

Note:
1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).
3. t_{PCLK} is one period of the selected PCLK.

4.22.2 USART SPI Secondary Timing, Voltage Scaling = VSCALE1

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.62. USART SPI Secondary Timing, Voltage Scaling = VSCALE1

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK period[1 2 3]	t_{SCLK}		6*t_{PCLK}	—	—	ns
SCLK high time[1 2 3]	t_{SCLK_HI}		2.5*t_{PCLK}	—	—	ns
SCLK low time[1 2 3]	t_{SCLK_LO}		2.5*t_{PCLK}	—	—	ns
CS active to MISO[1 2]	$t_{CS_ACT_MI}$		25.5	—	93	ns
CS disable to MISO[1 2]	$t_{CS_DIS_MI}$		26	—	83.5	ns
MOSI setup time[1 2]	t_{SU_MO}		11	—	—	ns
MOSI hold time[1 2 3]	t_{H_MO}		17.5	—	—	ns
SCLK to MISO[1 2 3]	t_{SCLK_MI}		19 + 1.5*t_{PCLK}	—	47 + 2.5*t_{PCLK}	ns

Note:
1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
2. Measurement done with 8 pF output loading at 10% and 90% of the I/O supply (figure shows 50%).
3. t_{PCLK} is one period of the selected PCLK.

4.23 EUSART SPI Main Timing

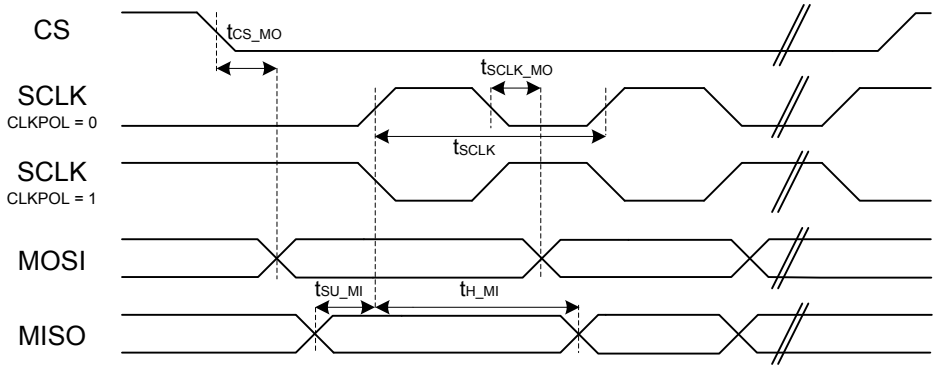

Figure 4.6. SPI Main Timing

4.23.1 EUSART SPI Main Timing, Voltage Scaling = VSCALE2

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.63. EUSART SPI Main Timing, Voltage Scaling = VSCALE2

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK period[1 2 3]	t_{SCLK}		t_{CLK}	—	—	ns
CS to MOSI[1 2]	t_{CS_MO}		-12	—	7	ns
SCLK to MOSI[1 2]	t_{SCLK_MO}		-4	—	8	ns
MISO setup time [1 2]	t_{SU_MI}		5.5	—	—	ns
MISO hold time[1 2]	t_{H_MI}		5	—	—	ns

Note:

1. Applies for both CLKPHA = 0 and CLKPHA = 1.
2. Measurement done with 15 pF output loading at 10% and 90% of V_{DD}.
3. t_{CLK} is one period of the selected peripheral clock: EM01GRPCCLK for EUSART1/2, EUSART0CLK for EUSART0.

4.23.2 EUSART SPI Main Timing, Voltage Scaling = VSCALE1

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.64. EUSART SPI Main Timing, Voltage Scaling = VSCALE1

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK period[1 2 3]	t_{SCLK}		t_{CLK}	—	—	ns
CS to MOSI[1 2]	t_{CS_MO}		-21	—	14	ns
SCLK to MOSI[1 2]	t_{SCLK_MO}		-8	—	14	ns
MISO setup time [1 2]	t_{SU_MI}		9.5	—	—	ns
MISO hold time[1 2]	t_{H_MI}		8	—	—	ns

Note:

1. Applies for both CLKPHA = 0 and CLKPHA = 1.
2. Measurement done with 15 pF output loading at 10% and 90% of V_{DD}.
3. t_{CLK} is one period of the selected peripheral clock: EM01GRPCCLK for EUSART1/2, EUSART0CLK for EUSART0.

4.24 EUSART SPI Secondary Timing

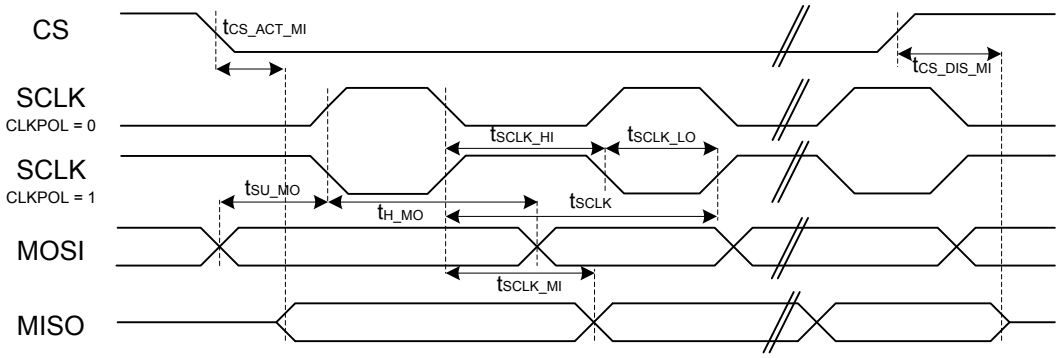

Figure 4.7. SPI Secondary Timing

4.24.1 EUSART SPI Secondary Timing, Voltage Scaling = VSCALE2

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.65. EUSART SPI Secondary Timing, Voltage Scaling = VSCALE2

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK high time[1] [2]	t_{SCLK_HI}		50	—	—	ns
SCLK low time[1] [2]	t_{SCLK_LO}		50	—	—	ns
CS active to MISO[1] [2]	$t_{CS_ACT_MI}$		5	—	43	ns
CS disable to MISO[1] [2]	$t_{CS_DIS_MI}$		5	—	28	ns
MOSI setup time[1] [2]	t_{SU_MO}		5	—	—	ns
MOSI hold time[1] [2]	t_{H_MO}		6.5	—	—	ns
SCLK to MISO[1] [2]	t_{SCLK_MI}	IOVDD = 1.8 V	8.5	—	41	ns
		IOVDD = 3.3 V	8.5	—	30.5	ns

Note:

1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
2. Measurement done with 15 pF output loading at 10% and 90% of V_{DD} (figure shows 50% of V_{DD}).

4.24.2 EUSART SPI Secondary Timing, Voltage Scaling = VSCALE1

Timing specifications are for all SPI signals routed to the same DBUS (DBUSAB or DBUSCD) on consecutive pins. All GPIO set to slew rate = 6.

Table 4.66. EUSART SPI Secondary Timing, Voltage Scaling = VSCALE1

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK high time[1 2]	t_{SCLK_HI}		50	—	—	ns
SCLK low time[1 2]	t_{SCLK_LO}		50	—	—	ns
CS active to MISO[1 2]	$t_{CS_ACT_MI}$		6	—	61.5	ns
CS disable to MISO[1 2]	$t_{CS_DIS_MI}$		6	—	43.5	ns
MOSI setup time[1 2]	t_{SU_MO}		9	—	—	ns
MOSI hold time[1 2]	t_{H_MO}		12.5	—	—	ns
SCLK to MISO[1 2]	t_{SCLK_MI}	IOVDD = 1.8 V	10.5	—	50.5	ns
		IOVDD = 3.3 V	10.5	—	42.5	ns

Note:
1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
2. Measurement done with 15 pF output loading at 10% and 90% of V_{DD} (figure shows 50% of V_{DD}).

4.24.3 EUSART SPI Secondary Timing, Voltage Scaling = VSCALE0

Timing specifications at VSCALE0 apply to EUSART0 only, routed to DBUSAB on consecutive pins. All GPIO set to slew rate = 6.

Table 4.67. EUSART SPI Secondary Timing, Voltage Scaling = VSCALE0

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCLK high time[1 2]	t_{SCLK_HI}		100	—	—	ns
SCLK low time[1 2]	t_{SCLK_LO}		100	—	—	ns
CS active to MISO[1 2]	$t_{CS_ACT_MI}$		8	—	105	ns
CS disable to MISO[1 2]	$t_{CS_DIS_MI}$		7.5	—	70.5	ns
MOSI setup time[1 2]	t_{SU_MO}		9.5	—	—	ns
MOSI hold time[1 2]	t_{H_MO}		35	—	—	ns
SCLK to MISO[1 2]	t_{SCLK_MI}	IOVDD = 1.8 V	11.5	—	89.5	ns
		IOVDD = 3.3 V	11.5	—	81	ns

Note:
1. Applies for both CLKPHA = 0 and CLKPHA = 1 (figure only shows CLKPHA = 0).
2. Measurement done with 15 pF output loading at 10% and 90% of V_{DD} (figure shows 50% of V_{DD}).

4.25 I2C Electrical Specifications

4.25.1 I2C Standard-mode (Sm)

CLHR set to 0 in the I2Cn_CTRL register.

Table 4.68. I2C Standard-mode (Sm)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCL clock frequency[1]	f_{SCL}		0	—	100	kHz
SCL clock low time	t_{LOW}		4.7	—	—	µs
SCL clock high time	t_{HIGH}		4	—	—	µs
SDA set-up time	t_{SU_DAT}		250	—	—	ns
SDA hold time	t_{HD_DAT}		0	—	—	ns
Repeated START condition set-up time	t_{SU_STA}		4.7	—	—	µs
Repeated START condition hold time	t_{HD_STA}		4.0	—	—	µs
STOP condition set-up time	t_{SU_STO}		4.0	—	—	µs
Bus free time between a STOP and START condition	t_{BUF}		4.7	—	—	µs

Note:

1. The maximum SCL clock frequency listed is assuming that an arbitrary clock frequency is available. The maximum attainable SCL clock frequency may be slightly less using the HFXO or HFRCO due to the limited frequencies available. The CLKDIV should be set to a value that keeps the SCL clock frequency below the max value listed.

4.25.2 I2C Fast-mode (Fm)

CLHR set to 1 in the I2Cn_CTRL register.

Table 4.69. I2C Fast-mode (Fm)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCL clock frequency[1]	f_{SCL}		0	—	400	kHz
SCL clock low time	t_{LOW}		1.3	—	—	µs
SCL clock high time	t_{HIGH}		0.6	—	—	µs
SDA set-up time	t_{SU_DAT}		100	—	—	ns
SDA hold time	t_{HD_DAT}		0	—	—	ns
Repeated START condition set-up time	t_{SU_STA}		0.6	—	—	µs
Repeated START condition hold time	t_{HD_STA}		0.6	—	—	µs
STOP condition set-up time	t_{SU_STO}		0.6	—	—	µs
Bus free time between a STOP and START condition	t_{BUF}		1.3	—	—	µs

Note:

1. The maximum SCL clock frequency listed is assuming that an arbitrary clock frequency is available. The maximum attainable SCL clock frequency may be slightly less using the HFXO or HFRCO due to the limited frequencies available. The CLKDIV should be set to a value that keeps the SCL clock frequency below the max value listed.

4.25.3 I2C Fast-mode Plus (Fm+)

CLHR set to 1 in the I2Cn_CTRL register.

Table 4.70. I2C Fast-mode Plus (Fm+)

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
SCL clock frequency[1]	f_{SCL}		0	—	1000	kHz
SCL clock low time	t_{LOW}		0.5	—	—	µs
SCL clock high time	t_{HIGH}		0.26	—	—	µs
SDA set-up time	t_{SU_DAT}		50	—	—	ns
SDA hold time	t_{HD_DAT}		0	—	—	ns
Repeated START condition set-up time	t_{SU_STA}		0.26	—	—	µs
Repeated START condition hold time	t_{HD_STA}		0.26	—	—	µs
STOP condition set-up time	t_{SU_STO}		0.26	—	—	µs
Bus free time between a STOP and START condition	t_{BUF}		0.5	—	—	µs

Note:

1. The maximum SCL clock frequency listed is assuming that an arbitrary clock frequency is available. The maximum attainable SCL clock frequency may be slightly less using the HFXO or HFRCO due to the limited frequencies available. The CLKDIV should be set to a value that keeps the SCL clock frequency below the max value listed.

4.26 Boot Timing

Secure boot impacts the recovery time from all sources of device reset. In addition to the root code authentication process, which cannot be disabled or bypassed, the root code can authenticate a bootloader, and the bootloader can authenticate the application. In projects that include only an application and no bootloader, the root code can authenticate the application directly. The duration of each authentication operation depends on two factors: the computation of the associated image hash, which is proportional to the size of the image, and the verification of the image signature, which is independent of image size.

The duration for the root code to authenticate the bootloader will depend on the SE firmware version as well as on the size of the bootloader.

The duration for the bootloader to authenticate the application can depend on the size of the application.

The configurations below assume that the associated bootloader and application code images do not contain a bootloader certificate or an application certificate. Authenticating a bootloader certificate or an application certificate will extend the boot time by an additional 6 to 7 ms.

The table below provides the durations from the termination of reset until the completion of the secure boot process (start of main() function in the application image) under various conditions.

Conditions:

- SE firmware version 2.2.1
- Gecko Bootloader size 10.4 KB

Timing is expected to be similar for subsequent SE firmware versions. Refer to SE firmware release notes for any significant changes.

Table 4.71. Boot Timing

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Boot time	t_{BOOT}	Secure boot application check disabled, no bootloader	—	28.7	—	ms
		Secure boot application check disabled, second stage bootloader check enabled[1], 50 kB application size	—	37.4	—	ms
		Secure boot application check enabled, second stage bootloader check enabled[1], 50 kB application size	—	48.0	—	ms
		Secure boot application check enabled, second stage bootloader check enabled[1], 150 kB application size	—	50.7	—	ms
		Secure boot application check enabled, second stage bootloader check enabled[1], 350 kB application size	—	56.1	—	ms

Note:

1. Timing is measured with the specified bootloader size. Actual bootloader size will impact the boot timing slightly, with a similar µs / kB ratio as application size.

4.27 Crypto Operation Timing for SE Manager API

Values in this table represent timing from SE Manager API call to return. The Cortex-M33 HCLK frequency is 39.0 MHz. The timing specifications below are measured at the SE Manager function call API. Each duration in the table contains some portion that is influenced by SE Manager build compilation and Cortex-M33 operating frequency and some portion that is influenced by the Hardware Secure Engine's firmware version and its operating speed (typically 80 MHz). The contributions of the Cortex-M33 properties to the overall specification timing are most pronounced for the shorter operations such as AES and hash when operating on small payloads. The overhead of command processing at the mailbox interface can also dominate the timing for shorter operations.

Conditions:

- SE firmware version 2.2.1
- GSDK version 3.2

Timing is expected to be similar for subsequent SE firmware versions. Refer to SE firmware release notes for any significant changes.

Table 4.72. Crypto Operation Timing for SE Manager API

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
AES-128 timing	t_{AES128}	AES-128 CCM encryption, PT 1 kB	—	575	—	µs
		AES-128 CCM encryption, PT 32 kB	—	1756	—	µs
		AES-128 CTR encryption, PT 1 kB	—	480	—	µs
		AES-128 CTR encryption, PT 32 kB	—	1048	—	µs
		AES-128 GCM encryption, PT 1 kB	—	527	—	µs
		AES-128 GCM encryption, PT 32 kB	—	1094	—	µs
AES-256 timing	t_{AES256}	AES-256 CCM encryption, PT 1 kB	—	588	—	µs
		AES-256 CCM encryption, PT 32 kB	—	2179	—	µs
		AES-256 CTR encryption, PT 1 kB	—	486	—	µs
		AES-256 CTR encryption, PT 32 kB	—	1260	—	µs
		AES-256 GCM encryption, PT 1 kB	—	534	—	µs
		AES-256 GCM encryption, PT 32 kB	—	1305	—	µs
ECC P-256 timing	t_{ECC_P256}	ECC key generation, P-256	—	5.6	—	ms
		ECC signing, P-256	—	5.9	—	ms
		ECC verification, P-256	—	6.2	—	ms
ECC P-521 timing[1]	t_{ECC_P521}	ECC key generation, P-521	—	30.5	—	ms
		ECC signing, P-521	—	31	—	ms
		ECC verification, P-521	—	36.5	—	ms
ECC P-25519 timing	t_{ECC_P25519}	ECC key generation, P-25519	—	4.5	—	ms
		ECC signing, P-25519	—	8.9	—	ms
		ECC verification, P-25519	—	6.2	—	ms
ECDH compute secret timing	t_{ECDH}	ECDH compute secret, P-521[1]	—	30.4	—	ms
		ECDH compute secret, P-25519	—	4.5	—	ms
		ECDH compute secret, P-256	—	5.7	—	ms

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
ECJPAKE client timing	$t_{ECJPAKE_C}$	ECJPAKE client write round one	—	21.6	—	ms
		ECJPAKE client read round one	—	11.8	—	ms
		ECJPAKE client write round two	—	15.2	—	ms
		ECJPAKE client read round two	—	6.4	—	ms
		ECJPAKE client derive secret	—	8.8	—	ms
ECJPAKE server timing	$t_{ECJPAKE_S}$	ECJPAKE server write round one	—	21.5	—	ms
		ECJPAKE server read round one	—	11.7	—	ms
		ECJPAKE server write round two	—	15.3	—	ms
		ECJPAKE server read round two	—	6.4	—	ms
		ECJPAKE server derive secret	—	8.8	—	ms
POLY-1305 timing[1]	$t_{POLY1305}$	POLY-1305, PT 1 kB	—	519	—	µs
		POLY-1305, PT 32 kB	—	1184	—	µs
SHA-256 timing	t_{SHA256}	SHA-256, PT 1 kB	—	308	—	µs
		SHA-256, PT 32 kB	—	734	—	µs
SHA-512 timing[1]	t_{SHA512}	SHA-512, PT 1 kB	—	305	—	µs
		SHA-512, PT 32 kB	—	622	—	µs

Note:

1. Option is only available on OPNs with Secure Vault High feature set.

4.28 Crypto Operation Average Current for SE Manager API

Values in this table represent current consumed by security core during the operation, and represent additions to the current consumed by the Cortex-M33 application CPU due to the Hardware Secure Engine CPU and its associated crypto accelerators. The current measurements below represent the average value of the current for the duration of the crypto operation. Instantaneous peak currents may be higher.

Conditions:

- SE firmware version 2.2.1
- GSDK version 3.2

Current consumption is expected to be similar for subsequent SE firmware versions. Refer to SE firmware release notes for any significant changes.

Table 4.73. Crypto Operation Average Current for SE Manager API

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
AES-128 current	I_{AES128}	AES-128 CCM encryption, PT 1 kB	—	1.1	—	mA
		AES-128 CCM encryption, PT 32 kB	—	3.8	—	mA
		AES-128 CTR encryption, PT 1 kB	—	2.0	—	mA
		AES-128 CTR encryption, PT 32 kB	—	3.7	—	mA
		AES-128 GCM encryption, PT 1 kB	—	1.0	—	mA
		AES-128 GCM encryption, PT 32 kB	—	3.7	—	mA
AES-256 current	I_{AES256}	AES-256 CCM encryption, PT 1 kB	—	1.2	—	mA
		AES-256 CCM encryption, PT 32 kB	—	3.9	—	mA
		AES-256 CTR encryption, PT 1 kB	—	1.0	—	mA
		AES-256 CTR encryption, PT 32 kB	—	3.8	—	mA
		AES-256 GCM encryption, PT 1 kB	—	1.0	—	mA
		AES-256 GCM encryption, PT 32 kB	—	3.9	—	mA
ECC P-256 current	$I_{ECCP256}$	ECC key generation, P-256	—	1.8	—	mA
		ECC signing, P-256	—	1.8	—	mA
		ECC verification, P-256	—	1.9	—	mA
ECC P-521 current[1]	$I_{ECCP521}$	ECC key generation, P-521	—	2.0	—	mA
		ECC signing, P-521	—	2.0	—	mA
		ECC verification, P-521	—	2.0	—	mA
ECC P-25519 current	$I_{ECCP25519}$	ECC key generation, P-25519	—	1.8	—	mA
		ECC signing, P-25519	—	1.8	—	mA
		ECC verification, P-25519	—	1.8	—	mA
ECDH compute secret current	I_{ECDH}	ECDH compute secret, P-521[1]	—	2.0	—	mA
		ECDH compute secret, P-25519	—	1.7	—	mA
		ECDH compute secret, P-256	—	1.8	—	mA

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
ECJPAKE client current	$I_{ECJPAKE_C}$	ECJPAKE client write round one	—	1.9	—	mA
		ECJPAKE client read round one	—	1.9	—	mA
		ECJPAKE client write round two	—	1.9	—	mA
		ECJPAKE client read round two	—	1.9	—	mA
		ECJPAKE client derive secret	—	1.9	—	mA
ECJPAKE server current	$I_{ECJPAKE_S}$	ECJPAKE server write round one	—	1.9	—	mA
		ECJPAKE server read round one	—	1.9	—	mA
		ECJPAKE server write round two	—	1.9	—	mA
		ECJPAKE server read round two	—	1.9	—	mA
		ECJPAKE server derive secret	—	1.9	—	mA
POLY-1305 current[1]	$I_{POLY1305}$	POLY-1305, PT 1 kB	—	0.8	—	mA
		POLY-1305, PT 32 kB	—	1.7	—	mA
SHA-256 current	I_{SHA256}	SHA-256, PT 1 kB	—	0.9	—	mA
		SHA-256, PT 32 kB	—	2.5	—	mA
SHA-512 current[1]	I_{SHA512}	SHA-512, PT 1 kB	—	0.9	—	mA
		SHA-512, PT 32 kB	—	2.1	—	mA

Note:

1. Option is only available on OPNs with Secure Vault High feature set.

4.29 Matrix Vector Processor

All measurements are in comparison to EM1 baseline current at given VSCALE and Clock settings. Matrix dimensions are X = 24 x 32, Y = 32 x 24 and Z = 24 x 24.

Table 4.74. Matrix Vector Processor

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
MVP Enable Current	I_{EN}	VSCALE1, HFXO @ 39 MHz	—	16.7	—	µA
		VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	41.6	—	µA
Matrix Multiplication Duration using MVP Hardware	$T_{MVP_MULTIPLY}$	16-bit complex numbers, fully banked memory, VSCALE1, HFXO @ 39 MHz	—	503.9	—	µs
		16-bit complex numbers, fully banked memory, VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	252.0	—	µs
		16-bit complex numbers, inter-leaved memory, VSCALE1, HFXO @ 39 MHz	—	596.4	—	µs
		16-bit complex numbers, inter-leaved memory, VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	298.2	—	µs
Matrix Multiplication Duration using Software	$T_{SW_MULTIPLY}$	16-bit complex numbers, inter-leaved memory, VSCALE1, HFXO @ 39 MHz	—	41.0	—	ms
		16-bit complex numbers, inter-leaved memory, VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	20.5	—	ms
		32-bit complex numbers, inter-leaved memory, VSCALE1, HFXO @ 39 MHz	—	19.3	—	ms
		32-bit complex numbers, inter-leaved memory, VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	9.6	—	ms
Matrix Multiplication Current using MVP Hardware	$I_{MVP_MULTIPLY}$	16-bit complex numbers, fully banked memory, VSCALE1, HFXO @ 39 MHz	—	60.9	—	µA/MHz
		16-bit complex numbers, fully banked memory, VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	61.6	—	µA/MHz
		16-bit complex numbers, inter-leaved memory, VSCALE1, HFXO @ 39 MHz	—	50.8	—	µA/MHz
		16-bit complex numbers, inter-leaved memory, VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	50.9	—	µA/MHz

Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Matrix Multiplication Current using Software	$I_{SW_MULTIPLY}$	16-bit complex numbers, interleaved memory, VSCALE1, HFXO @ 39 MHz	—	42.2	—	µA/MHz
		16-bit complex numbers, interleaved memory, VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	44.3	—	µA/MHz
		32-bit complex numbers, interleaved memory, VSCALE1, HFXO @ 39 MHz	—	32.5	—	µA/MHz
		32-bit complex numbers, interleaved memory, VSCALE2, HFRCO w/ DPLL @ 78 MHz	—	34.1	—	µA/MHz

4.30 Typical Performance Curves

Typical performance curves indicate typical characterized performance under the stated conditions.

4.30.1 Supply Current

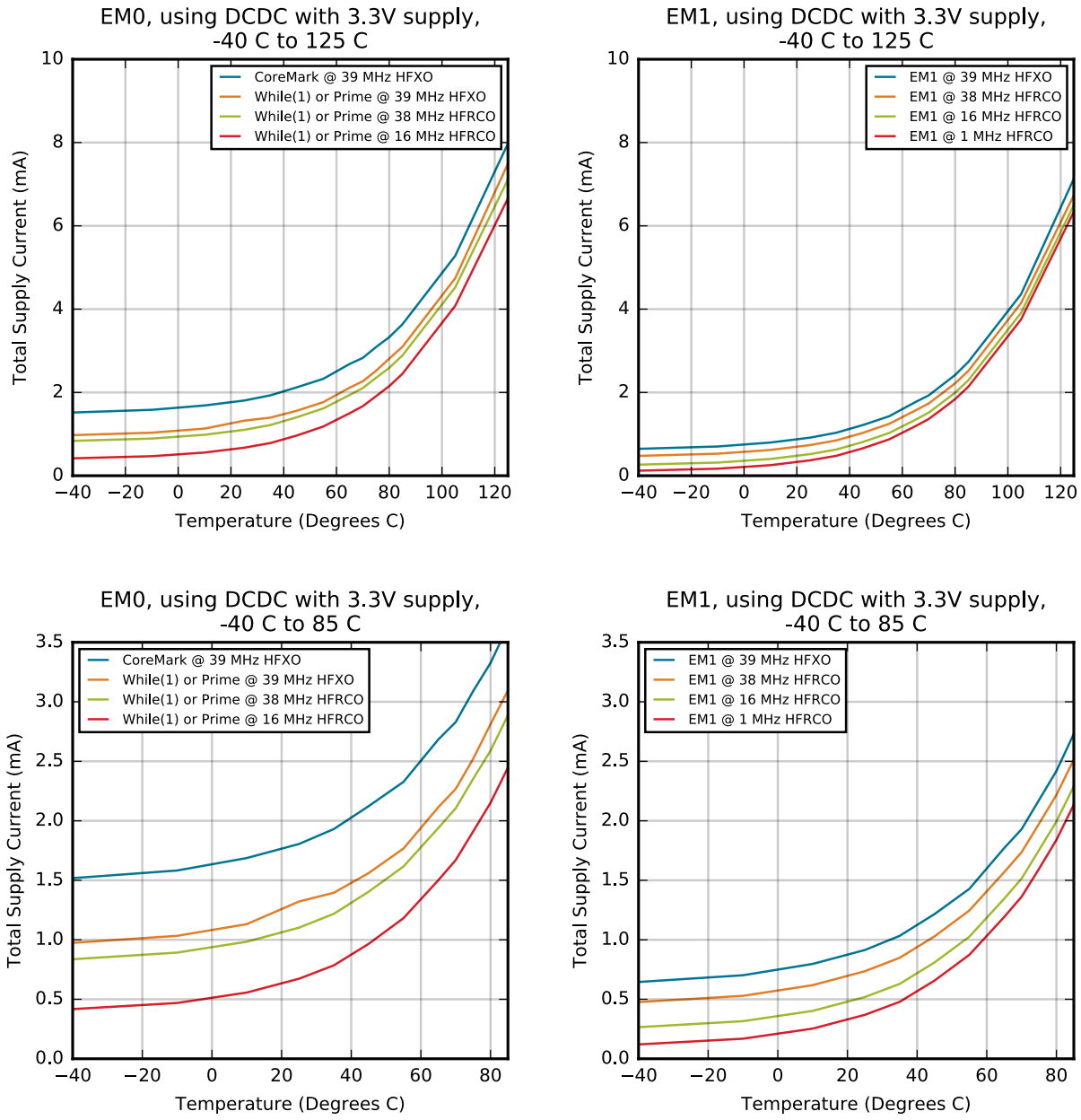

Figure 4.8. EM0 and EM1 Typical Supply Current vs. Temperature

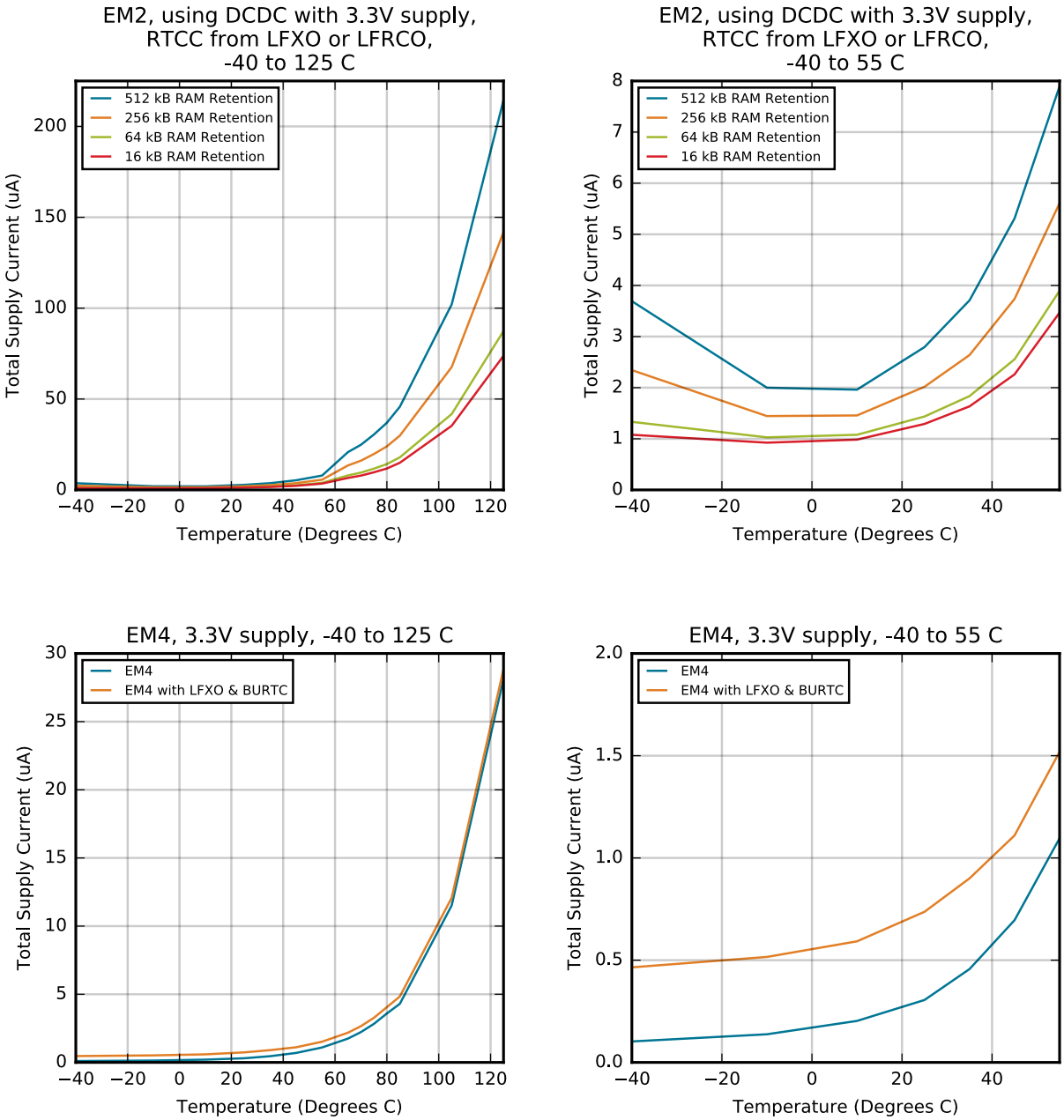

Figure 4.9. EM2 and EM4 Typical Supply Current vs. Temperature

4.30.2 RF Characteristics

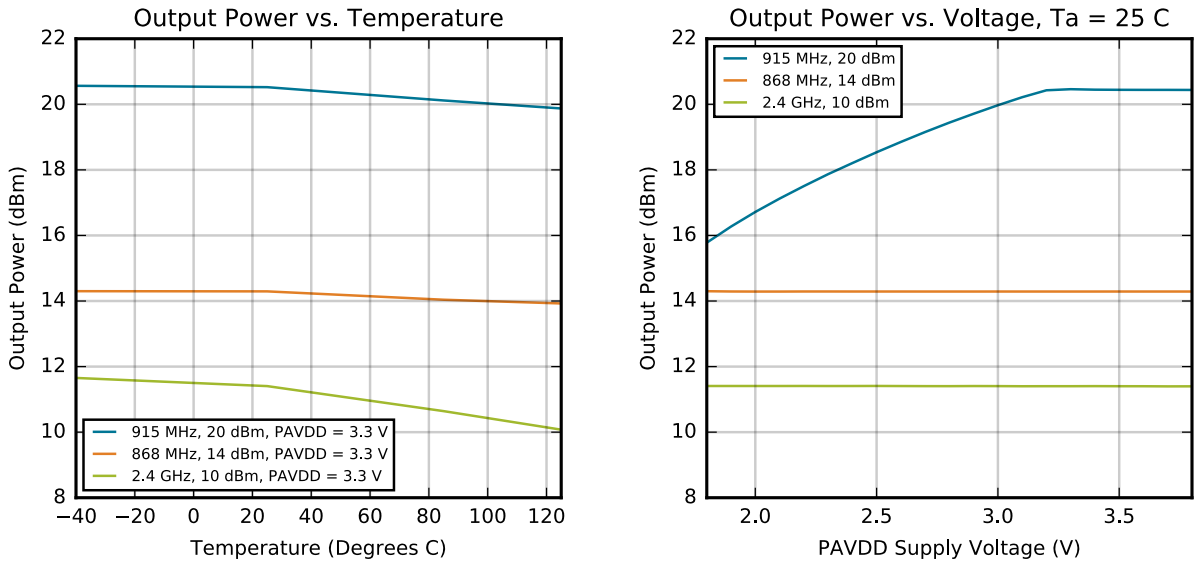

Figure 4.10. Transmitter Output Power vs. Temperature and Supply

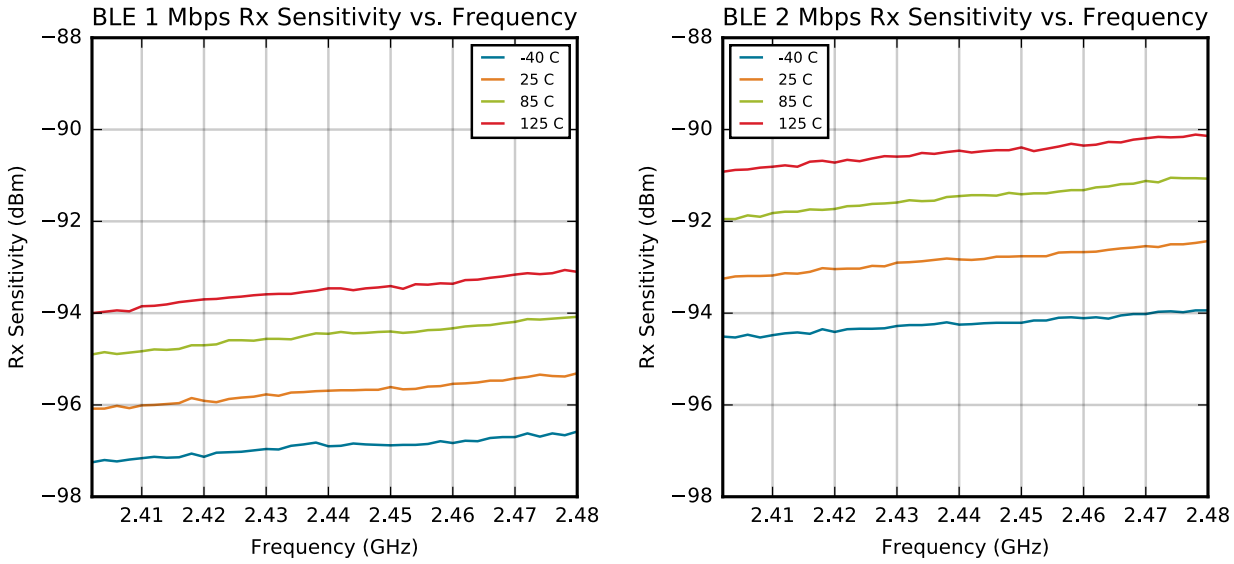

Figure 4.11. BLE Sensitivity

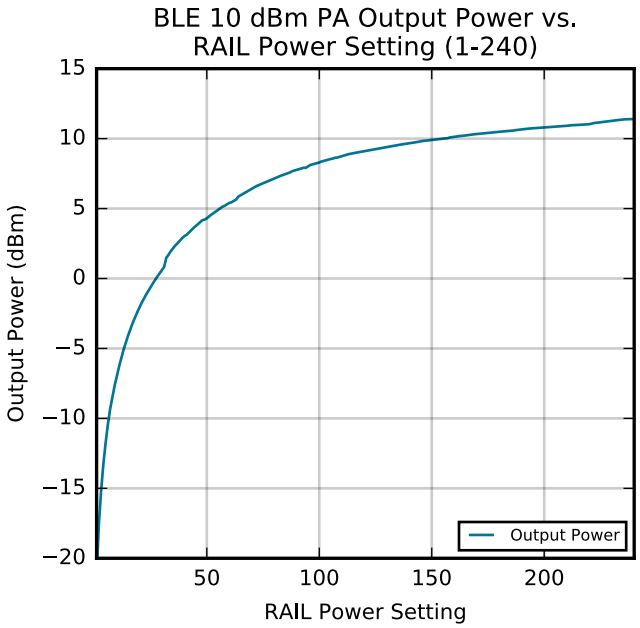

Figure 4.12. 2.4 GHz BLE Transmitter Output Power vs. RAIL Setting

4.30.3 DC-DC Converter

Performance characterized with Samsung CIG22H2R2MNE (L_{DCDC} = 2.2 uH) and Samsung CL10B475KQ8NQNC (C_{DCDC} = 4.7 uF)

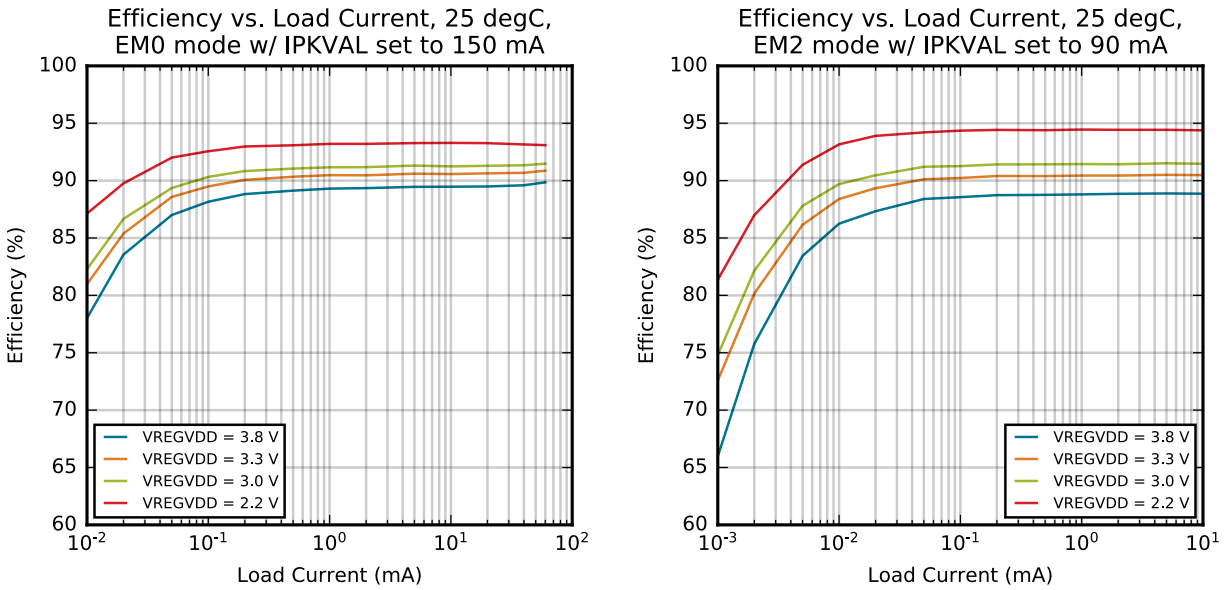

Figure 4.13. DC-DC Efficiency

4.30.4 IADC

Typical performance is shown using 10 MHz ADC clock for fastest sampling speed and adjusting oversampling ratio (OSR).

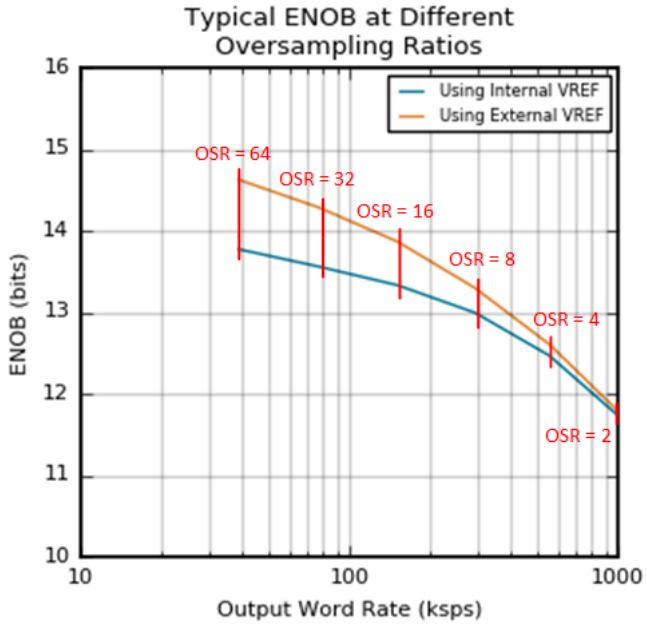

Figure 4.14. Typical ENOB vs. Oversampling Ratio

4.30.5 GPIO

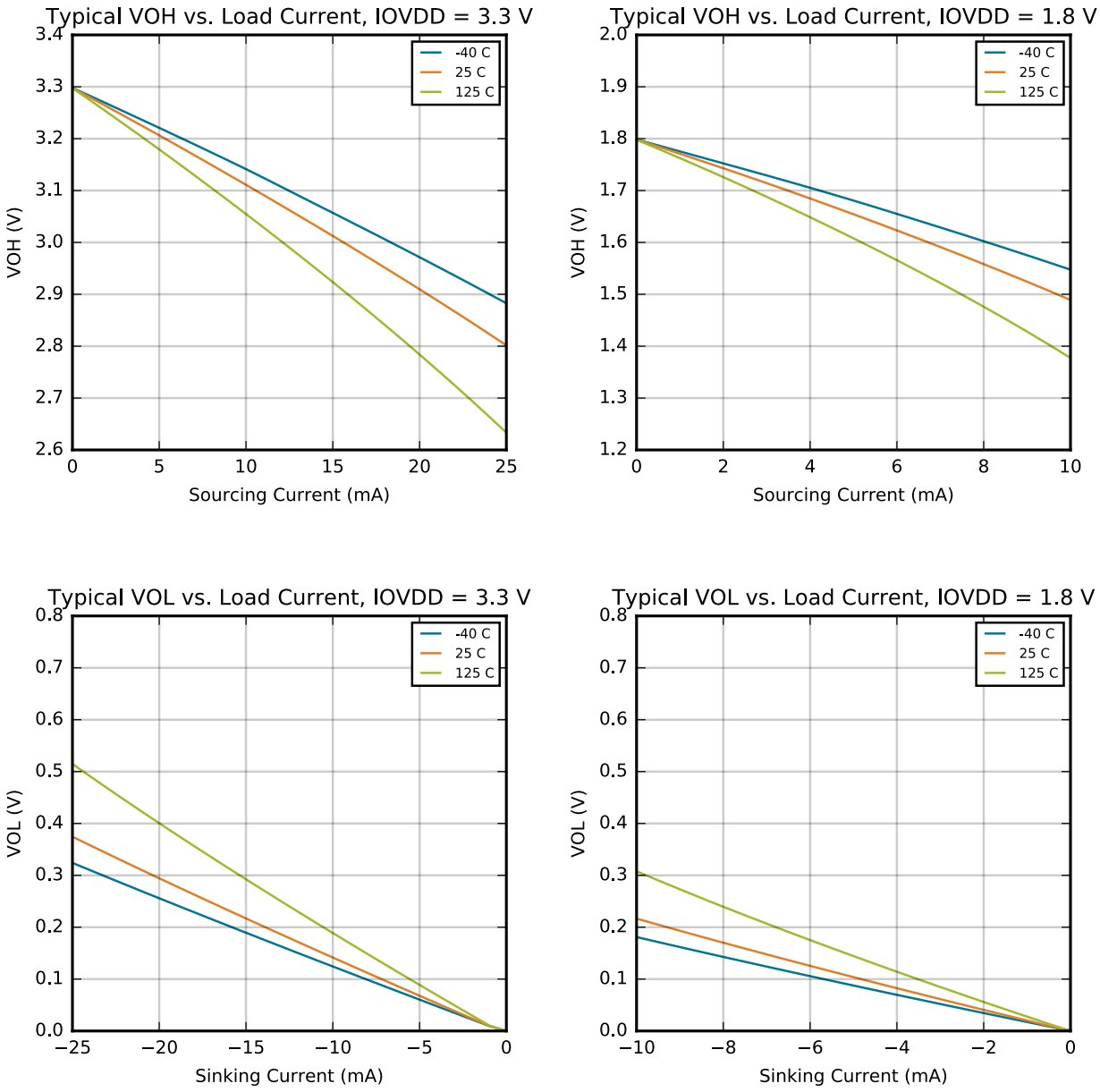

Figure 4.15. VOH and VOL vs. Load Current

5. Typical Connection Diagrams

5.1 Power

Typical power supply connections are shown in the following figures.

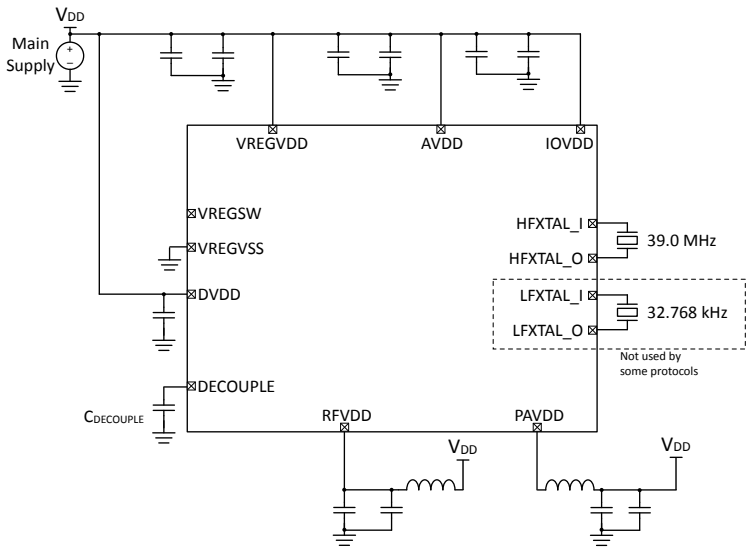

Figure 5.1. EFR32FG28 Typical Application Circuit: Direct Supply Configuration without DCDC

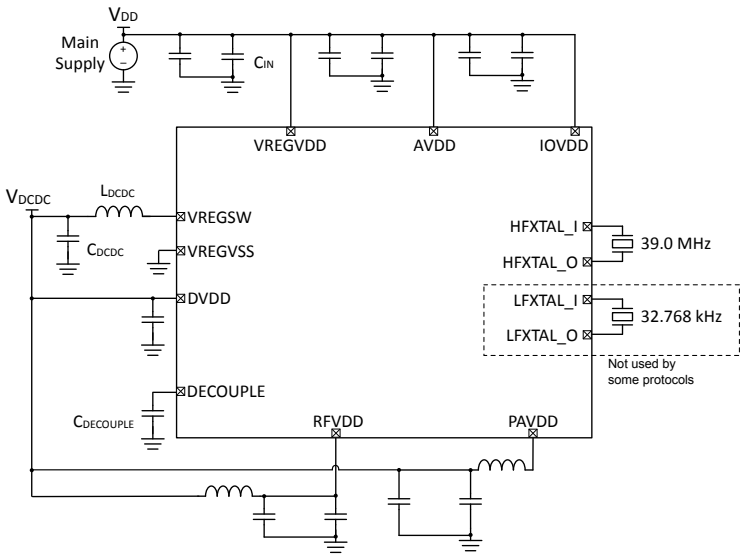

Figure 5.2. EFR32FG28 Typical Application Circuit: DCDC Configuration

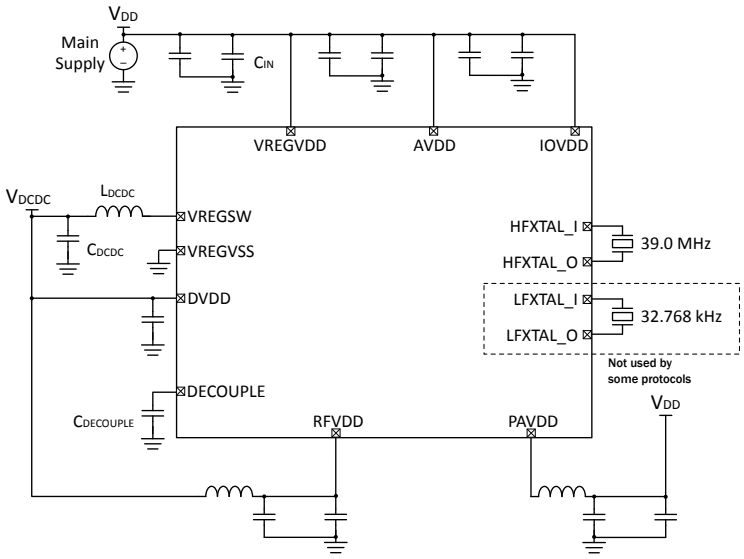

Figure 5.3. EFR32FG28 Typical Application Circuit: DCDC Configuration, PAVDD Powered Separately

5.2 RF Matching Networks

5.2.1 Matching Networks for 868 MHz, 915 MHz, and 920 MHz Bands

The recommended RF matching network circuit diagram for the 868 MHz, 915 MHz, and 920 MHz bands at up to +14 dBm TX output power is shown in Figure 5.4 Typical 868/915/920 MHz RF impedance-matching network circuit, +14 dBm on page 137. This supports all frequencies from 868 to 930 MHz. Typical component values for a +14 dBm match are shown in Table 5.1 868/915/920 MHz Component Values, +14 dBm on page 137. Typical component values for a +10 dBm match in the 868 MHz band are shown in Table 5.2 868 MHz Component Values, +10 dBm on page 137. Please refer to the development board Bill of Materials for specific part recommendation including tolerance, component size, reccomended manufacturer, and recommended part number.

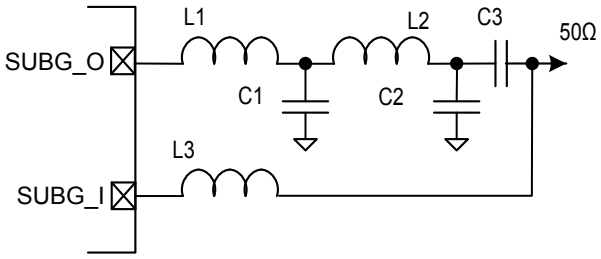

Figure 5.4. Typical 868/915/920 MHz RF impedance-matching network circuit, +14 dBm

Table 5.1. 868/915/920 MHz Component Values, +14 dBm

Designator	Component Values, +14 dBm
L1	4.2 nH
C1	6.3 pF
L2	16 nH
C2	2.1 pF
C3	220 pF
L3	18 nH

Table 5.2. 868 MHz Component Values, +10 dBm

Designator	Component Values, +10 dBm
L1	5.6 nH
C1	5.1 pF
L2	13 nH
C2	3.1 pF
C3	220 pF
L3	18 nH

The recommended RF matching network circuit diagram for the 868 MHz, 915 MHz, and 920 MHz bands at up to +20 dBm TX output power is shown in Figure 5.5 Typical 868/915/920 MHz RF impedance-matching network circuit, +20 dBm on page 138. This supports all frequencies from 868 to 930 MHz. Typical component values are shown in Table 5.3 868/915/920 MHz Component Values, +20 dBm on page 138. Please refer to the development board Bill of Materials for specific part recommendation including tolerance, component size, reccomended manufacturer, and recommended part number.

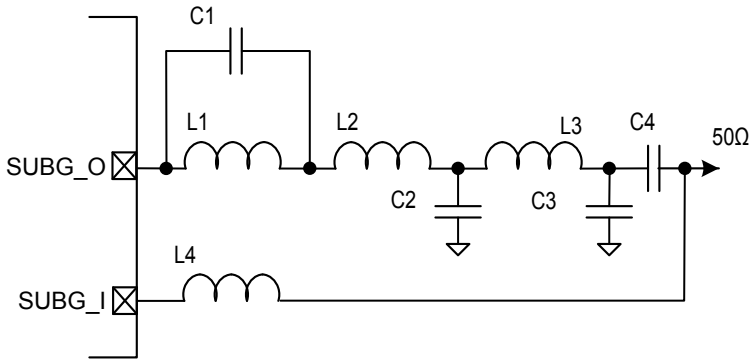

Figure 5.5. Typical 868/915/920 MHz RF impedance-matching network circuit, +20 dBm

Table 5.3. 868/915/920 MHz Component Values, +20 dBm

Designator	Component Values, +20 dBm
L1	1.5 nH
C1	2.0 pF
L2	1.3 nH
C2	7.6 pF
L3	13 nH
C3	1.3 pF
C4	220 pF
L4	18 nH

5.2.2 Matching Network for 470 MHz Band

The recommended RF matching network circuit diagram for 470 MHz band applications is shown in Figure 5.6 Typical 470 MHz Band RF impedance-matching network circuit on page 139. This band covers 470 to 510 MHz and is centered at 490 MHz. Typical component values optimizedfor different power levels are shown in Table 5.4 470 MHz Band Component Values on page 139. Please refer to the develoment board Bill of Materials for specific part recommendation including tolerance, component size, reccomended manufacturer, and reccomended part number.

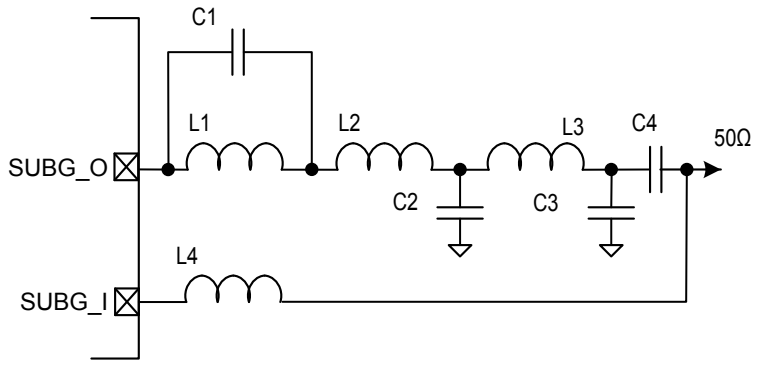

Figure 5.6. Typical 470 MHz Band RF impedance-matching network circuit

Table 5.4. 470 MHz Band Component Values

Designator	Component Values, +20 dBm
L1	1.5 nH
C1	16 pF
L2	3.1 nH
C2	20 pF
L3	20 nH
C3	7.1 pF
C4	220 pF
L4	68 nH

5.2.3 Matching Network for 433 MHz Band

The recommended RF matching network circuit diagram for 433 MHz Band applications is shown in Figure 5.7 Typical 433 MHz Band RF impedance-matching network circuit on page 140. Typical component values optimizedfor different power levels are shown in Table 5.5 433 MHz Band Component Values on page 140. Please refer to the develoment board Bill of Materials for specific part recommendation including tolerance, component size, reccomended manufacturer, and reccomended part number.

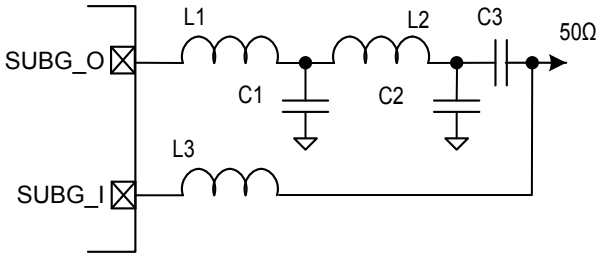

Figure 5.7. Typical 433 MHz Band RF impedance-matching network circuit

Table 5.5. 433 MHz Band Component Values

Designator	Component Values, +14 dBm
L1	10 nH
C1	15 pF
L2	33 nH
C2	5.6 pF
C3	220 pF
L3	82 nH

5.2.4 Matching Network for 315 MHz Band

The recommended RF matching network circuit diagram for 315 MHz Band applications is shown in Figure 5.8 Typical 315 MHz Band RF impedance-matching network circuit on page 141. Typical component values optimizedfor different power levels are shown in Table 5.6 315 MHz Band Component Values on page 141. Please refer to the develoment board Bill of Materials for specific part recommendation including tolerance, component size, reccomended manufacturer, and reccomended part number.

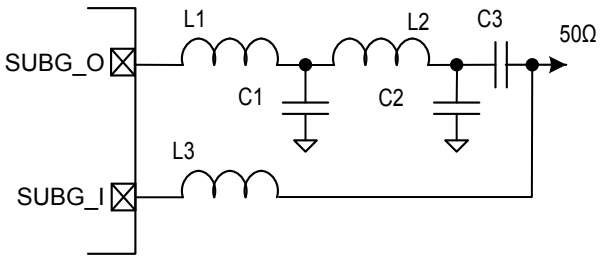

Figure 5.8. Typical 315 MHz Band RF impedance-matching network circuit

Table 5.6. 315 MHz Band Component Values

Designator	Component Values, +10 dBm
L1	22 nH
C1	15 pF
L2	47 nH
C2	9.2 pF
C3	220 pF
L3	150 nH

5.2.5 Matching Network for 169 MHz Band

The recommended RF matching network circuit diagram for 169 MHz Band applications is shown in Figure 5.9 Typical 169 MHz Band RF impedance-matching network circuit on page 142. Typical component values optimizedfor different power levels are shown in Table 5.7 169 MHz Band Component Values on page 142. Please refer to the develoment board Bill of Materials for specific part recommendation including tolerance, component size, reccomended manufacturer, and reccomended part number.

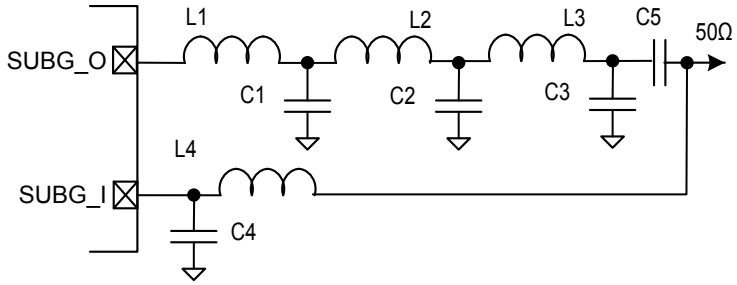

Figure 5.9. Typical 169 MHz Band RF impedance-matching network circuit

Table 5.7. 169 MHz Band Component Values

Designator	Component Values	
	+10 dBm	+20 dBm
L1	22 nH	12 nH
C1	33 pF	62 pF
L2	47 nH	40 nH
C2	27 pF	27 pF
L3	51 nH	51 nH
C3	15 pF	16 pF
L4	220 nH	220 nH
C4	2.6 pF	2.6 pF
C5	220 pF	220 pF

5.2.6 Matching Network for 2.4 GHz BLE

The recommended RF matching network circuit diagram for the 2.4 GHz band at up to +10 dBm TX output power is shown in Figure 5.10 Typical 2.4 GHz RF impedance-matching network circuit, +10 dBm on page 143. Typical component values for a +10 dBm match are shown in Table 5.8 2.4 GHz Component Values, +10 dBm on page 143. Please refer to the development board Bill of Materials for specific part recommendation including tolerance, component size, reccomended manufacturer, and recommended part number.

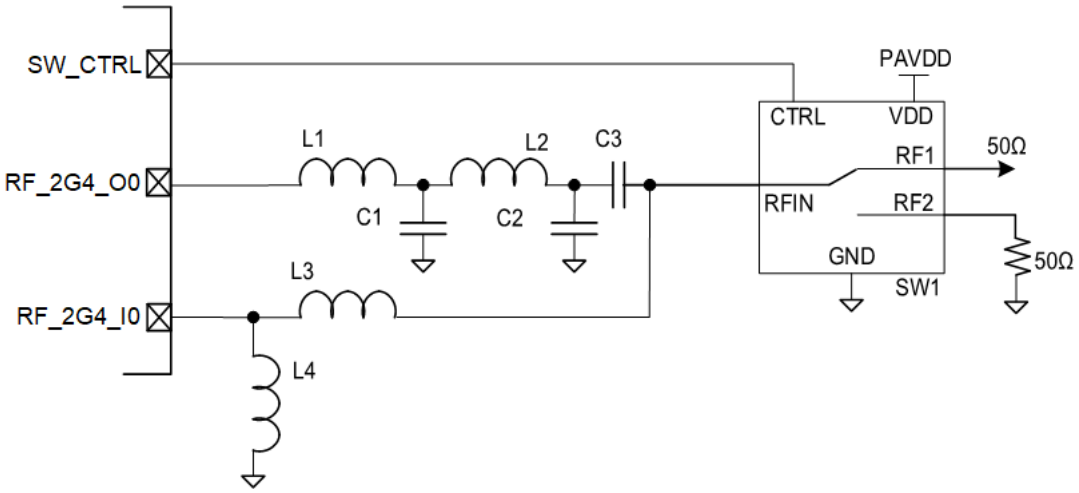

Figure 5.10. Typical 2.4 GHz RF impedance-matching network circuit, +10 dBm

Table 5.8. 2.4 GHz Component Values, +10 dBm

Designator	Component Values, +10 dBm
L1	3 nH
C1	1 pF
L2	8.2 nH
C2	0.3 pF
C3	18 pF
L3	0R
L4	2.3 nH
SW1	BGS12WN6 (SPDT RF Switch)

5.3 Other Connections

Other components or connections may be required to meet the system-level requirements. Application Note AN0002.2: "EFM32 and EFR32 Wireless Gecko Series 2 Hardware Design Considerations" contains detailed information on these connections. Application Notes can be accessed on the Silicon Labs website (www.silabs.com/32bit-appnotes).

6. Pin Definitions

6.1 QFN68 Sub-GHz Device Pinout

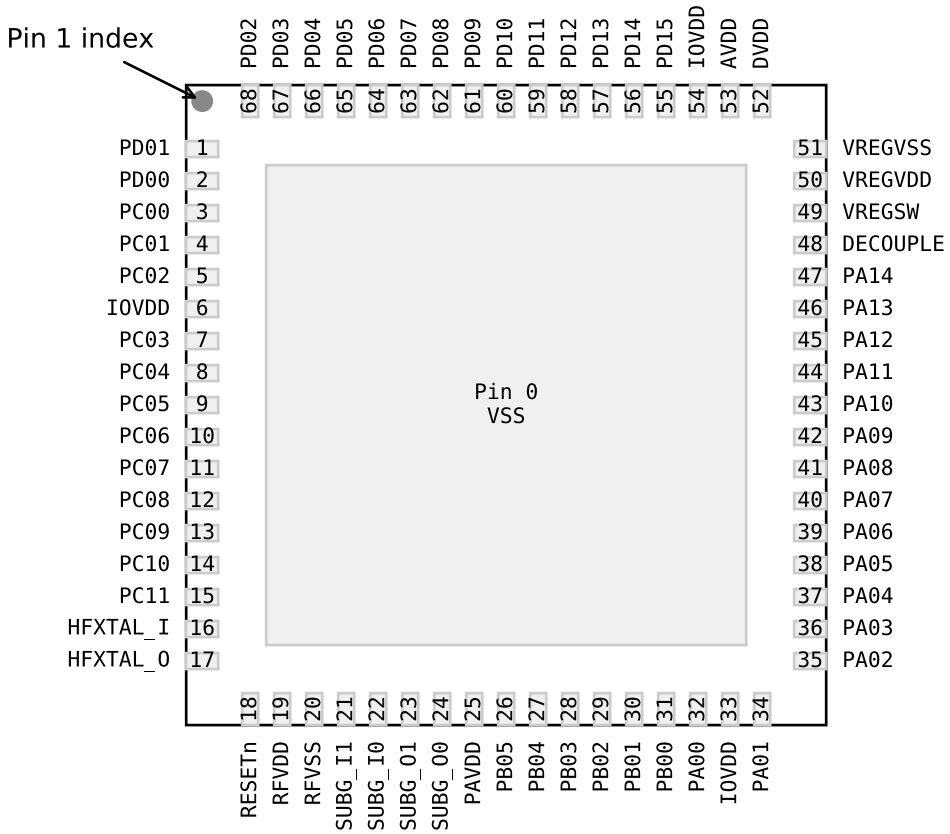

Figure 6.1. QFN68 Sub-GHz Device Pinout

The following table provides package pin connections and general descriptions of pin functionality. For detailed information on the supported features for each GPIO pin, see 6.5 Alternate Function Table, 6.6 Analog Peripheral Connectivity, and 6.7 Digital Peripheral Connectivity.

Table 6.1. QFN68 Sub-GHz Device Pinout

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
PD01	1	GPIO	PD00	2	GPIO
PC00	3	GPIO	PC01	4	GPIO
PC02	5	GPIO	IOVDD	6	IO VDD supply pin
PC03	7	GPIO	PC04	8	GPIO
PC05	9	GPIO	PC06	10	GPIO

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
PC07	11	GPIO	PC08	12	GPIO
PC09	13	GPIO	PC10	14	GPIO
PC11	15	GPIO	HFXTAL_I	16	High Frequency XTAL input pin
HFXTAL_O	17	High Frequency XTAL output pin	RESETn	18	Reset pin (active low)
RFVDD	19	RF VDD supply pin	RFVSS	20	RF VSS ground pin
SUBG_I1	21	Sub-GHz Input 1	SUBG_I0	22	Sub-GHz Input 0
SUBG_O1	23	Sub-GHz Output 1	SUBG_O0	24	Sub-GHz Output 0
PAVDD	25	PA VDD supply pin	PB05	26	GPIO
PB04	27	GPIO	PB03	28	GPIO
PB02	29	GPIO	PB01	30	GPIO
PB00	31	GPIO	PA00	32	GPIO
IOVDD	33	IO VDD supply pin	PA01	34	GPIO
PA02	35	GPIO	PA03	36	GPIO
PA04	37	GPIO	PA05	38	GPIO
PA06	39	GPIO	PA07	40	GPIO
PA08	41	GPIO	PA09	42	GPIO
PA10	43	GPIO	PA11	44	GPIO
PA12	45	GPIO	PA13	46	GPIO
PA14	47	GPIO	DECOUPLE	48	Decoupling Capacitor pin
VREGSW	49	DCDC output (Inductor) pin	VREGVDD	50	DCDC input supply pin
VREGVSS	51	DCDC ground pin	DVDD	52	Digital VDD supply pin
AVDD	53	Analog VDD supply pin	IOVDD	54	IO VDD supply pin
PD15	55	GPIO	PD14	56	GPIO
PD13	57	GPIO	PD12	58	GPIO
PD11	59	GPIO	PD10	60	GPIO
PD09	61	GPIO	PD08	62	GPIO
PD07	63	GPIO	PD06	64	GPIO
PD05	65	GPIO	PD04	66	GPIO
PD03	67	GPIO	PD02	68	GPIO

6.2 QFN68 Dual-Band Device Pinout

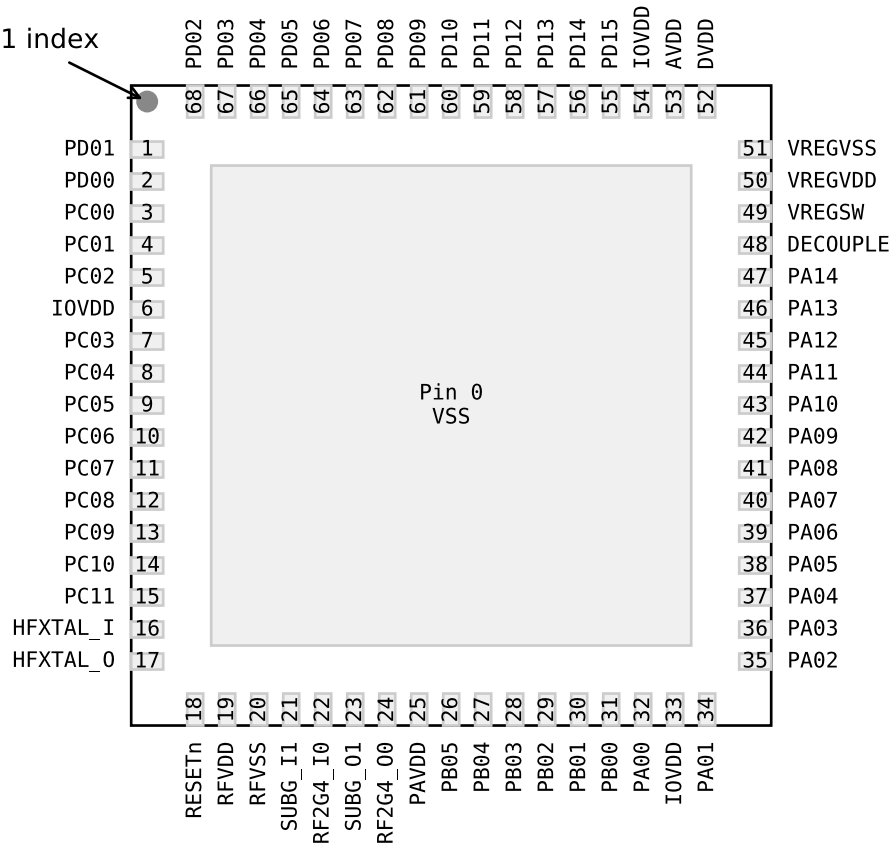

Figure 6.2. QFN68 Dual-Band Device Pinout

The following table provides package pin connections and general descriptions of pin functionality. For detailed information on the supported features for each GPIO pin, see 6.5 Alternate Function Table, 6.6 Analog Peripheral Connectivity, and 6.7 Digital Peripheral Connectivity.

Table 6.2. QFN68 Dual-Band Device Pinout

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
PD01	1	GPIO	PD00	2	GPIO
PC00	3	GPIO	PC01	4	GPIO
PC02	5	GPIO	IOVDD	6	IO VDD supply pin
PC03	7	GPIO	PC04	8	GPIO
PC05	9	GPIO	PC06	10	GPIO
PC07	11	GPIO	PC08	12	GPIO
PC09	13	GPIO	PC10	14	GPIO

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
PC11	15	GPIO	HFXTAL_I	16	High Frequency XTAL input pin
HFXTAL_O	17	High Frequency XTAL output pin	RESETn	18	Reset pin (active low)
RFVDD	19	RF VDD supply pin	RFVSS	20	RF VSS ground pin
SUBG_I1	21	Sub-GHz Input 1	RF2G4_I0	22	2.4 GHz Input 0
SUBG_O1	23	Sub-GHz Output 1	RF2G4_O0	24	2.4 GHz Output 0
PAVDD	25	PA VDD supply pin	PB05	26	GPIO
PB04	27	GPIO	PB03	28	GPIO
PB02	29	GPIO	PB01	30	GPIO
PB00	31	GPIO	PA00	32	GPIO
IOVDD	33	IO VDD supply pin	PA01	34	GPIO
PA02	35	GPIO	PA03	36	GPIO
PA04	37	GPIO	PA05	38	GPIO
PA06	39	GPIO	PA07	40	GPIO
PA08	41	GPIO	PA09	42	GPIO
PA10	43	GPIO	PA11	44	GPIO
PA12	45	GPIO	PA13	46	GPIO
PA14	47	GPIO	DECOUPLE	48	Decoupling Capacitor pin
VREGSW	49	DCDC output (Inductor) pin	VREGVDD	50	DCDC input supply pin
VREGVSS	51	DCDC ground pin	DVDD	52	Digital VDD supply pin
AVDD	53	Analog VDD supply pin	IOVDD	54	IO VDD supply pin
PD15	55	GPIO	PD14	56	GPIO
PD13	57	GPIO	PD12	58	GPIO
PD11	59	GPIO	PD10	60	GPIO
PD09	61	GPIO	PD08	62	GPIO
PD07	63	GPIO	PD06	64	GPIO
PD05	65	GPIO	PD04	66	GPIO
PD03	67	GPIO	PD02	68	GPIO

6.3 QFN48 Sub-GHz Device Pinout

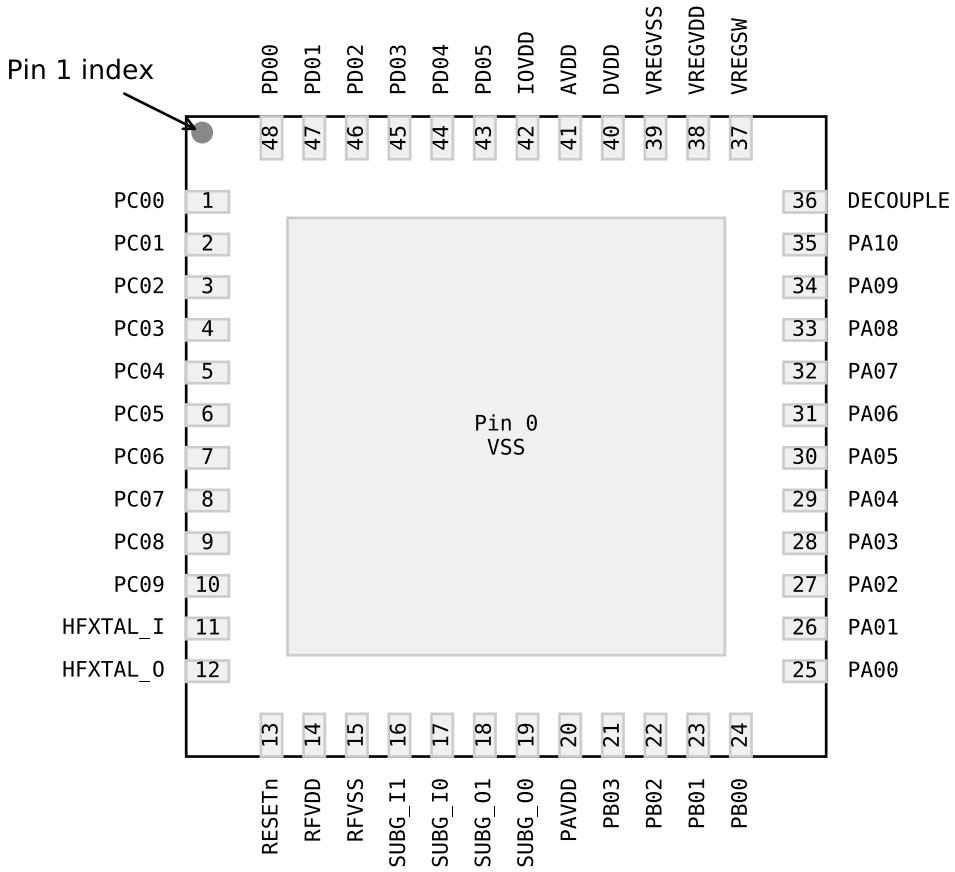

Figure 6.3. QFN48 Sub-GHz Device Pinout

The following table provides package pin connections and general descriptions of pin functionality. For detailed information on the supported features for each GPIO pin, see 6.5 Alternate Function Table, 6.6 Analog Peripheral Connectivity, and 6.7 Digital Peripheral Connectivity.

Table 6.3. QFN48 Sub-GHz Device Pinout

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
PC00	1	GPIO	PC01	2	GPIO
PC02	3	GPIO	PC03	4	GPIO
PC04	5	GPIO	PC05	6	GPIO
PC06	7	GPIO	PC07	8	GPIO
PC08	9	GPIO	PC09	10	GPIO
HFXTAL_I	11	High Frequency XTAL input pin	HFXTAL_O	12	High Frequency XTAL output pin
RESETn	13	Reset pin (active low)	RFVDD	14	RF VDD supply pin

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
RFVSS	15	RF VSS ground pin	SUBG_I1	16	Sub-GHz Input 1
SUBG_I0	17	Sub-GHz Input 0	SUBG_O1	18	Sub-GHz Output 1
SUBG_O0	19	Sub-GHz Output 0	PAVDD	20	PA VDD supply pin
PB03	21	GPIO	PB02	22	GPIO
PB01	23	GPIO	PB00	24	GPIO
PA00	25	GPIO	PA01	26	GPIO
PA02	27	GPIO	PA03	28	GPIO
PA04	29	GPIO	PA05	30	GPIO
PA06	31	GPIO	PA07	32	GPIO
PA08	33	GPIO	PA09	34	GPIO
PA10	35	GPIO	DECOUPLE	36	Decoupling Capacitor pin
VREGSW	37	DCDC output (Inductor) pin	VREGVDD	38	DCDC input supply pin
VREGVSS	39	DCDC ground pin	DVDD	40	Digital VDD supply pin
AVDD	41	Analog VDD supply pin	IOVDD	42	IO VDD supply pin
PD05	43	GPIO	PD04	44	GPIO
PD03	45	GPIO	PD02	46	GPIO
PD01	47	GPIO	PD00	48	GPIO

6.4 QFN48 Dual-Band Device Pinout

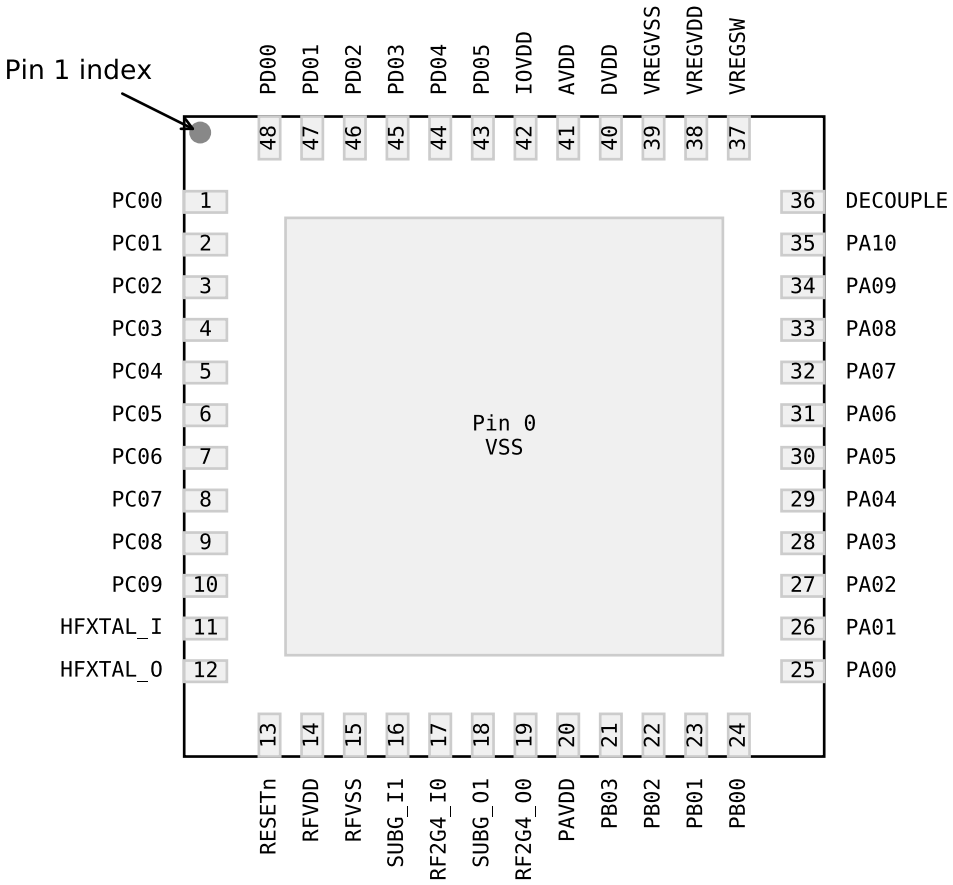

Figure 6.4. QFN48 Dual-Band Device Pinout

The following table provides package pin connections and general descriptions of pin functionality. For detailed information on the supported features for each GPIO pin, see 6.5 Alternate Function Table, 6.6 Analog Peripheral Connectivity, and 6.7 Digital Peripheral Connectivity.

Table 6.4. QFN48 Dual-Band Device Pinout

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
PC00	1	GPIO	PC01	2	GPIO
PC02	3	GPIO	PC03	4	GPIO
PC04	5	GPIO	PC05	6	GPIO
PC06	7	GPIO	PC07	8	GPIO
PC08	9	GPIO	PC09	10	GPIO
HFXTAL_I	11	High Frequency XTAL input pin	HFXTAL_O	12	High Frequency XTAL output pin
RESETn	13	Reset pin (active low)	RFVDD	14	RF VDD supply pin

Pin Name	Pin(s)	Description	Pin Name	Pin(s)	Description
RFVSS	15	RF VSS ground pin	SUBG_I1	16	Sub-GHz Input 1
RF2G4_I0	17	2.4 GHz Input 0	SUBG_O1	18	Sub-GHz Output 1
RF2G4_O0	19	2.4 GHz Output 0	PAVDD	20	PA VDD supply pin
PB03	21	GPIO	PB02	22	GPIO
PB01	23	GPIO	PB00	24	GPIO
PA00	25	GPIO	PA01	26	GPIO
PA02	27	GPIO	PA03	28	GPIO
PA04	29	GPIO	PA05	30	GPIO
PA06	31	GPIO	PA07	32	GPIO
PA08	33	GPIO	PA09	34	GPIO
PA10	35	GPIO	DECOUPLE	36	Decoupling Capacitor pin
VREGSW	37	DCDC output (Inductor) pin	VREGVDD	38	DCDC input supply pin
VREGVSS	39	DCDC ground pin	DVDD	40	Digital VDD supply pin
AVDD	41	Analog VDD supply pin	IOVDD	42	IO VDD supply pin
PD05	43	GPIO	PD04	44	GPIO
PD03	45	GPIO	PD02	46	GPIO
PD01	47	GPIO	PD00	48	GPIO

6.5 Alternate Function Table

A wide selection of alternate functionality is available for multiplexing to various pins. The following table shows GPIO pins with support for dedicated functions across the different package options.

Table 6.5. GPIO Alternate Function Table

GPIO	Alternate Functions	QFN68 Sub-GHz Package[1]	QFN68 Dual-Band Package[2]	QFN48 Sub-GHz Package[3]	QFN48 Dual-Band Package[4]
PA00	IADC0.VREFP	Yes	Yes	Yes	Yes
	LCD.SEG8	Yes	Yes	Yes	Yes
PA01	GPIO.SWCLK	Yes	Yes	Yes	Yes
	LCD.SEG9	Yes	Yes	Yes	Yes
PA02	GPIO.SWDIO	Yes	Yes	Yes	Yes
PA03	GPIO.SWV	Yes	Yes	Yes	Yes
	GPIO.TDO	Yes	Yes	Yes	Yes
	GPIO.TRACEDATA0	Yes	Yes	Yes	Yes
	LESENSE.EN_0	Yes	Yes	Yes	Yes
PA04	GPIO.TDI	Yes	Yes	Yes	Yes
	GPIO.TRACECLK	Yes	Yes	Yes	Yes
	LCD.SEG10	Yes	Yes	Yes	Yes
	LESENSE.EN_1	Yes	Yes	Yes	Yes
PA05	GPIO.TRACEDATA1	Yes	Yes	Yes	Yes
	GPIO.EM4WU0	Yes	Yes	Yes	Yes
	LCD.SEG11	Yes	Yes	Yes	Yes
	LESENSE.EN_2	Yes	Yes	Yes	Yes
PA06	GPIO.TRACEDATA2	Yes	Yes	Yes	Yes
	LCD.LCD_CP	Yes	Yes	Yes	Yes
PA07	GPIO.TRACEDATA3	Yes	Yes	Yes	Yes
	LCD.SEG12	Yes	Yes	Yes	Yes
PA08	LCD.SEG13	Yes	Yes	Yes	Yes
PA09	LCD.SEG20	Yes	Yes	Yes	Yes
PA10	LCD.SEG21	Yes	Yes	Yes	Yes
PA11	LCD.SEG22	Yes	Yes		
PA12	LCD.SEG23	Yes	Yes		
PA13	LCD.COM4	Yes	Yes		
	LCD.SEG24	Yes	Yes		
PA14	LCD.COM5	Yes	Yes		
	LCD.SEG25	Yes	Yes		
PB00	LCD.SEG14	Yes	Yes	Yes	Yes
	VDAC0.CH0_MAIN_OUT	Yes	Yes	Yes	Yes

GPIO	Alternate Functions	QFN68 Sub-GHz Package[1]	QFN68 Dual-Band Package[2]	QFN48 Sub-GHz Package[3]	QFN48 Dual-Band Package[4]
PB01	GPIO.EM4WU3	Yes	Yes	Yes	Yes
	LCD.SEG15	Yes	Yes	Yes	Yes
	VDAC0.CH1_MAIN_OUT	Yes	Yes	Yes	Yes
PB02	LCD.SEG16	Yes	Yes	Yes	Yes
PB03	GPIO.EM4WU4	Yes	Yes	Yes	Yes
	LCD.SEG17	Yes	Yes	Yes	Yes
PB04	LCD.COM6	Yes	Yes		
	LCD.SEG26	Yes	Yes		
PB05	LCD.COM7	Yes	Yes		
	LCD.SEG27	Yes	Yes		
PC00	GPIO.EM4WU6	Yes	Yes	Yes	Yes
	LCD.SEG0	Yes	Yes	Yes	Yes
PC01	GPIO.EFP_TX_SDA	Yes	Yes	Yes	Yes
	LCD.SEG1	Yes	Yes	Yes	Yes
PC02	GPIO.EFP_TX_SCL	Yes	Yes	Yes	Yes
	LCD.SEG2	Yes	Yes	Yes	Yes
PC03	LCD.SEG3	Yes	Yes	Yes	Yes
PC04	LCD.SEG4	Yes	Yes	Yes	Yes
PC05	GPIO.EFP_INT	Yes	Yes	Yes	Yes
	GPIO.EM4WU7	Yes	Yes	Yes	Yes
	LCD.SEG5	Yes	Yes	Yes	Yes
PC06	LCD.SEG6	Yes	Yes	Yes	Yes
PC07	GPIO.EM4WU8	Yes	Yes	Yes	Yes
	LCD.SEG7	Yes	Yes	Yes	Yes
PC08	LCD.SEG18	Yes	Yes	Yes	Yes
PC09	GPIO.THMSW_EN			Yes	Yes
	GPIO.THMSW_HALFSWITCH			Yes	Yes
	LCD.SEG19	Yes	Yes	Yes	Yes
PC11	GPIO.THMSW_EN	Yes	Yes		
	GPIO.THMSW_HALFSWITCH	Yes	Yes		
PD00	LFXO.LFXTAL_O	Yes	Yes	Yes	Yes
PD01	LFXO.LFXTAL_I	Yes	Yes	Yes	Yes
	LFXO.LF_EXTCLK	Yes	Yes	Yes	Yes
PD02	GPIO.EM4WU9	Yes	Yes	Yes	Yes
	LCD.COM0	Yes	Yes	Yes	Yes
PD03	LCD.COM1	Yes	Yes	Yes	Yes

GPIO	Alternate Functions	QFN68 Sub-GHz Package[1]	QFN68 Dual-Band Package[2]	QFN48 Sub-GHz Package[3]	QFN48 Dual-Band Package[4]
PD04	LCD.COM2	Yes	Yes	Yes	Yes
PD05	GPIO.EM4WU10	Yes	Yes	Yes	Yes
	LCD.COM3	Yes	Yes	Yes	Yes

Note:

1. QFN68 Sub-GHz Package includes OPNs EFR32FG28A010F1024GM68-A, EFR32FG28A110F1024GM68-A, EFR32FG28A120F1024GM68-A, EFR32FG28B310F1024IM68-A, and EFR32FG28B320F1024IM68-A
2. QFN68 Dual-Band Package includes OPNs EFR32FG28A112F1024GM68-A, EFR32FG28A122F1024GM68-A, EFR32FG28B312F1024IM68-A, and EFR32FG28B322F1024IM68-A
3. QFN48 Sub-GHz Package includes OPNs EFR32FG28A010F1024GM48-A, EFR32FG28A110F1024GM48-A, EFR32FG28A120F1024GM48-A, EFR32FG28B310F1024IM48-A, and EFR32FG28B320F1024IM48-A
4. QFN48 Dual-Band Package includes OPNs EFR32FG28A112F1024GM48-A, EFR32FG28A122F1024GM48-A, EFR32FG28B312F1024IM48-A, and EFR32FG28B322F1024IM48-A

6.6 Analog Peripheral Connectivity

Many analog resources are routable and can be connected to numerous GPIO's. The table below indicates which peripherals are available on each GPIO port. When a differential connection is being used Positive inputs are restricted to the EVEN pins and Negative inputs are restricted to the ODD pins. When a single ended connection is being used positive input is available on all pins. See the device Reference Manual for more details on the ABUS and analog peripherals. Note that some functions may not be available on all device variants.

Table 6.6. ABUS Routing Table

Peripheral	Signal	PA		PB		PC		PD	
		EVEN	ODD	EVEN	ODD	EVEN	ODD	EVEN	ODD
ACMP0	ANA_NEG	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
	ANA_POS	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
ACMP1	ANA_NEG	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
	ANA_POS	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
IADC0	ANA_NEG	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
	ANA_POS	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
VDAC0	CH0_ABUS_OUT	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
	CH1_ABUS_OUT	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes

6.7 Digital Peripheral Connectivity

Many digital resources are routable and can be connected to numerous GPIO's. The table below indicates which peripherals are available on each GPIO port. Note that some functions may not be available on all device variants.

Table 6.7. DBUS Routing Table

Peripheral.Resource	PORT			
	PA	PB	PC	PD
ACMP0.DIGOUT	Available	Available	Available	Available
ACMP1.DIGOUT	Available	Available	Available	Available
CMU.CLKIN0			Available	Available
CMU.CLKOUT0			Available	Available
CMU.CLKOUT1			Available	Available
CMU.CLKOUT2	Available	Available		
EUSART0.CS	Available	Available		
EUSART0.CTS	Available	Available		
EUSART0.RTS	Available	Available		
EUSART0.RX	Available	Available		
EUSART0.SCLK	Available	Available		
EUSART0.TX	Available	Available		
EUSART1.CS	Available	Available	Available	Available
EUSART1.CTS	Available	Available	Available	Available
EUSART1.RTS	Available	Available	Available	Available
EUSART1.RX	Available	Available	Available	Available
EUSART1.SCLK	Available	Available	Available	Available
EUSART1.TX	Available	Available	Available	Available
EUSART2.CS			Available	Available
EUSART2.CTS			Available	Available
EUSART2.RTS			Available	Available
EUSART2.RX			Available	Available
EUSART2.SCLK			Available	Available
EUSART2.TX			Available	Available
FRC.DCLK			Available	Available
FRC.DFRAME			Available	Available
FRC.DOUT			Available	Available
I2C0.SCL	Available	Available	Available	Available
I2C0.SDA	Available	Available	Available	Available
I2C1.SCL			Available	Available
I2C1.SDA			Available	Available

Peripheral.Resource	PORT			
	PA	PB	PC	PD
KEYSCAN.COL_OUT_0	Available	Available	Available	Available
KEYSCAN.COL_OUT_1	Available	Available	Available	Available
KEYSCAN.COL_OUT_2	Available	Available	Available	Available
KEYSCAN.COL_OUT_3	Available	Available	Available	Available
KEYSCAN.COL_OUT_4	Available	Available	Available	Available
KEYSCAN.COL_OUT_5	Available	Available	Available	Available
KEYSCAN.COL_OUT_6	Available	Available	Available	Available
KEYSCAN.COL_OUT_7	Available	Available	Available	Available
KEYSCAN.ROW_SENSE_0	Available	Available		
KEYSCAN.ROW_SENSE_1	Available	Available		
KEYSCAN.ROW_SENSE_2	Available	Available		
KEYSCAN.ROW_SENSE_3	Available	Available		
KEYSCAN.ROW_SENSE_4	Available	Available		
KEYSCAN.ROW_SENSE_5	Available	Available		
LESENSE.CH0OUT	Available	Available		
LESENSE.CH1OUT	Available	Available		
LESENSE.CH2OUT	Available	Available		
LESENSE.CH3OUT	Available	Available		
LESENSE.CH4OUT	Available	Available		
LESENSE.CH5OUT	Available	Available		
LESENSE.CH6OUT	Available	Available		
LESENSE.CH7OUT	Available	Available		
LESENSE.CH8OUT	Available	Available		
LESENSE.CH9OUT	Available	Available		
LESENSE.CH10OUT	Available	Available		
LESENSE.CH11OUT	Available	Available		
LESENSE.CH12OUT	Available	Available		
LESENSE.CH13OUT	Available	Available		
LESENSE.CH14OUT	Available	Available		
LESENSE.CH15OUT	Available	Available		
LETIMER0.OUT0	Available	Available		
LETIMER0.OUT1	Available	Available		
MODEM.ANT0	Available	Available	Available	Available
MODEM.ANT1	Available	Available	Available	Available
MODEM.ANT_ROLL_OVER			Available	Available
MODEM.ANT_RR0			Available	Available

Peripheral.Resource	PORT			
	PA	PB	PC	PD
MODEM.ANT_RR1			Available	Available
MODEM.ANT_RR2			Available	Available
MODEM.ANT_RR3			Available	Available
MODEM.ANT_RR4			Available	Available
MODEM.ANT_RR5			Available	Available
MODEM.ANT_SW_EN			Available	Available
MODEM.ANT_SW_US			Available	Available
MODEM.ANT_TRIG			Available	Available
MODEM.ANT_TRIG_STOP			Available	Available
MODEM.DCLK	Available	Available		
MODEM.DIN	Available	Available		
MODEM.DOUT	Available	Available		
PCNT0.S0IN	Available	Available		
PCNT0.S1IN	Available	Available		
PRS.ASYNCH0	Available	Available		
PRS.ASYNCH1	Available	Available		
PRS.ASYNCH2	Available	Available		
PRS.ASYNCH3	Available	Available		
PRS.ASYNCH4	Available	Available		
PRS.ASYNCH5	Available	Available		
PRS.ASYNCH6			Available	Available
PRS.ASYNCH7			Available	Available
PRS.ASYNCH8			Available	Available
PRS.ASYNCH9			Available	Available
PRS.ASYNCH10			Available	Available
PRS.ASYNCH11			Available	Available
PRS.SYNCH0	Available	Available	Available	Available
PRS.SYNCH1	Available	Available	Available	Available
PRS.SYNCH2	Available	Available	Available	Available
PRS.SYNCH3	Available	Available	Available	Available
TIMER0.CC0	Available	Available	Available	Available
TIMER0.CC1	Available	Available	Available	Available
TIMER0.CC2	Available	Available	Available	Available
TIMER0.CDTI0	Available	Available	Available	Available
TIMER0.CDTI1	Available	Available	Available	Available
TIMER0.CDTI2	Available	Available	Available	Available

Peripheral.Resource	PORT			
	PA	PB	PC	PD
TIMER1.CC0	Available	Available	Available	Available
TIMER1.CC1	Available	Available	Available	Available
TIMER1.CC2	Available	Available	Available	Available
TIMER1.CDTI0	Available	Available	Available	Available
TIMER1.CDTI1	Available	Available	Available	Available
TIMER1.CDTI2	Available	Available	Available	Available
TIMER2.CC0	Available	Available		
TIMER2.CC1	Available	Available		
TIMER2.CC2	Available	Available		
TIMER2.CDTI0	Available	Available		
TIMER2.CDTI1	Available	Available		
TIMER2.CDTI2	Available	Available		
TIMER3.CC0			Available	Available
TIMER3.CC1			Available	Available
TIMER3.CC2			Available	Available
TIMER3.CDTI0			Available	Available
TIMER3.CDTI1			Available	Available
TIMER3.CDTI2			Available	Available
TIMER4.CC0	Available	Available		
TIMER4.CC1	Available	Available		
TIMER4.CC2	Available	Available		
TIMER4.CDTI0	Available	Available		
TIMER4.CDTI1	Available	Available		
TIMER4.CDTI2	Available	Available		
USART0.CLK	Available	Available	Available	Available
USART0.CS	Available	Available	Available	Available
USART0.CTS	Available	Available	Available	Available
USART0.RTS	Available	Available	Available	Available
USART0.RX	Available	Available	Available	Available
USART0.TX	Available	Available	Available	Available

7. QFN48 Package Specifications

7.1 QFN48 Package Dimensions

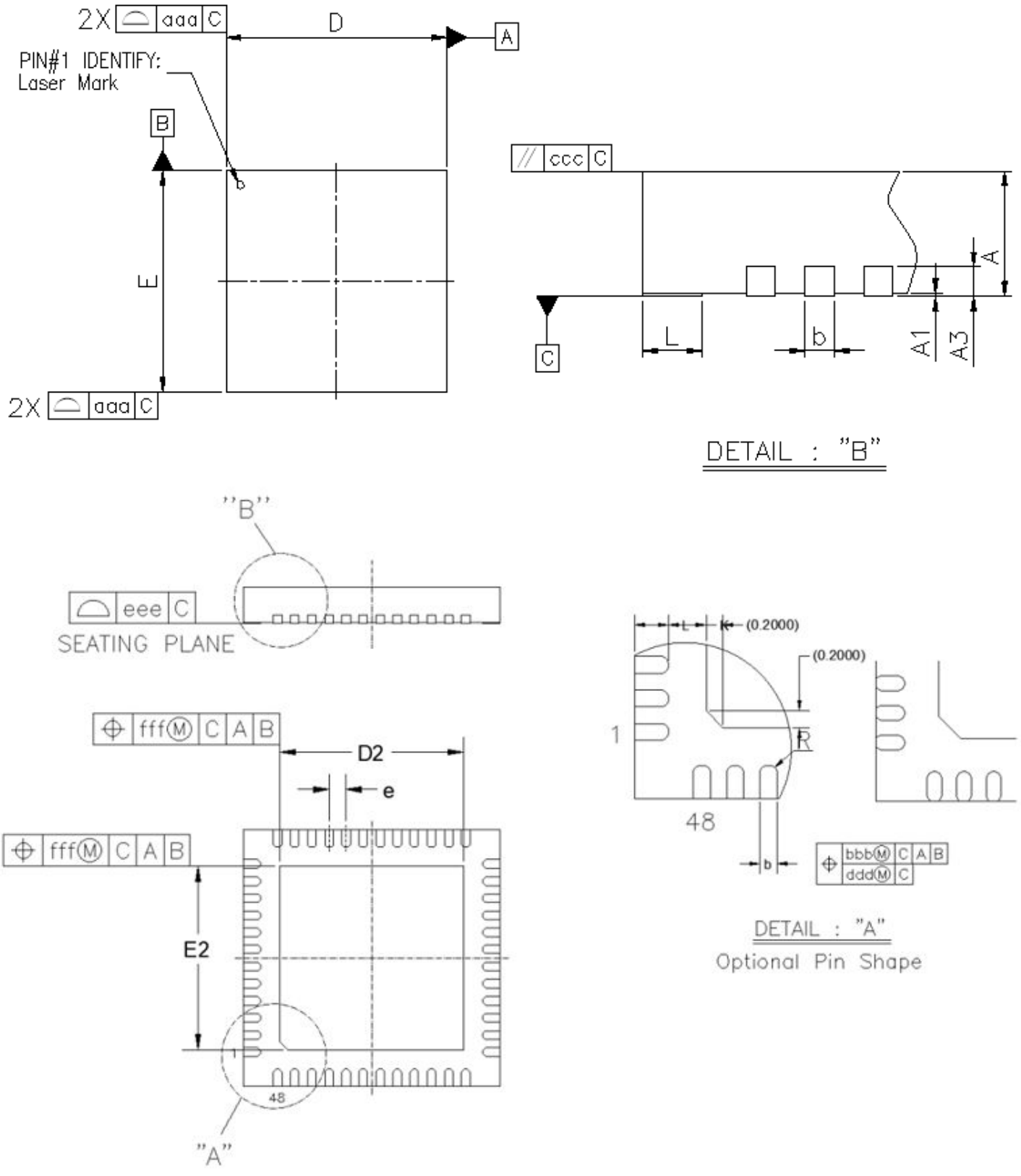

Figure 7.1. QFN48 Package Drawing

Table 7.1. QFN48 Package Dimensions

Dimension	Min	Typ	Max
A	0.80	0.85	0.90
A1	0.00	0.02	0.05
A3		0.20 REF	
b	0.15	0.2	0.25
D	5.90	6.00	6.10
E	5.90	6.00	6.10
e		0.40 BSC	
D2	4.15	4.30	4.45
E2	4.15	4.30	4.45
L	0.30	0.4	0.50
K	0.20	—	—
R	0.075	—	—
aaa		0.10	
bbb		0.07	
ccc		0.10	
ddd		0.05	
eee		0.08	
fff		0.10	

Note:

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.
3. This drawing conforms to the JEDEC Outline MS-013, Variation AA.
4. Recommended reflow profile per JEDEC J-STD-020C specification for small body, lead-free components.

7.2 QFN48 PCB Land Pattern

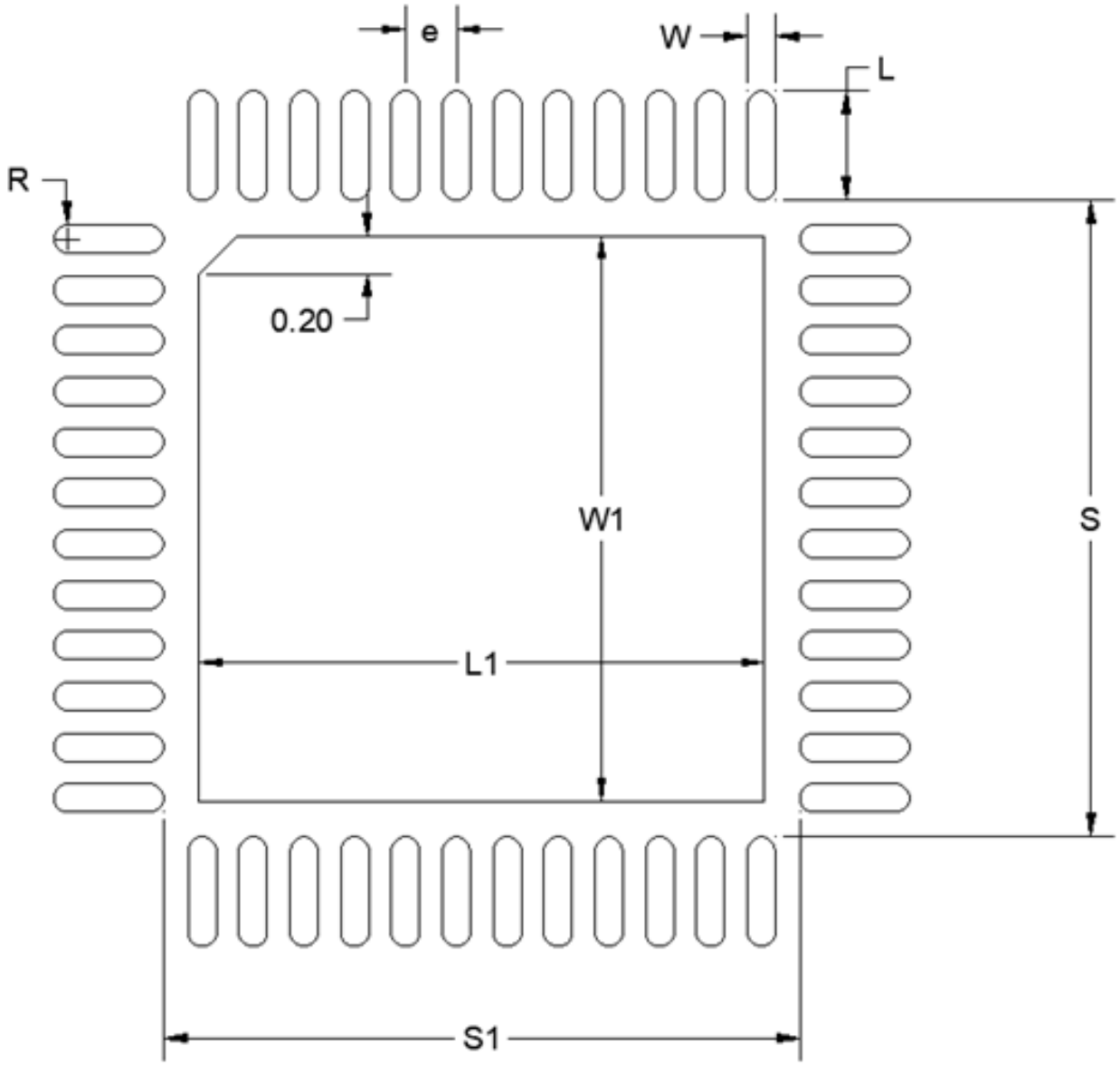

Figure 7.2. QFN48 PCB Land Pattern Drawing

Table 7.2. QFN48 PCB Land Pattern Dimensions

Dimension	Typ
L	0.86
W	0.22
e	0.40
S	5.01
S1	5.01
L1	4.45
W1	4.45
R	0.11

Dimension	Typ

Note:

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. This Land Pattern Design is based on the IPC-7351 guidelines.
3. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.
4. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
5. The stencil thickness should be 0.101 mm (4 mils).
6. The ratio of stencil aperture to land pad size can be 1:1 for all perimeter pads.
7. A 3x3 array of 1.10mm x 1.10mm openings on 1.30mm pitch should be used for the center ground pad.
8. A No-Clean, Type-3 solder paste is recommended.
9. The recommended card reflow profile is per the JEDEC/IPC J-STD-020 specification for Small Body Components.
10. ***Above notes and stencil design are shared as recommendations only. A customer or user may find it necessary to use different parameters and fine tune their SMT process as required for their application and tooling.***

7.3 QFN48 Package Marking

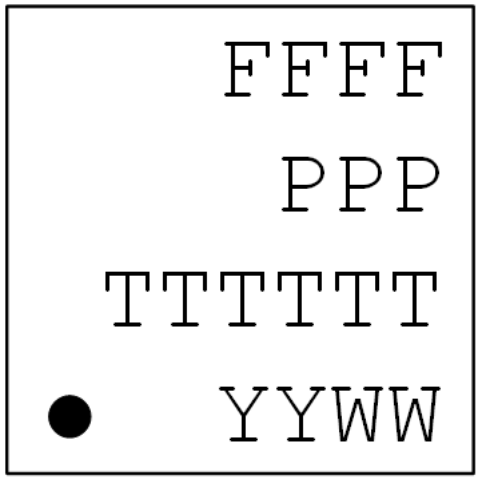

Figure 7.3. QFN48 Package Marking

The package marking consists of:

- FFFF – The product family codes.
  1. Family Code (F | Z)
  2. G (Gecko)
  3. Series (2)
  4. Device Configuration (8)
- PPP – The product option codes.
  - 1-2. Feature codes [f2, f3] (RF configuration)
    - 10 = Two 14 dBm Sub-GHz PAs
    - 12 = One 14 dBm Sub-GHz PA and One 10 dBm BLE 2.4 GHz PA
    - 20 = Two 20 dBm Sub-GHz PAs
    - 22 = One 20 dBm Sub-GHz PA and One 10 dBm BLE 2.4 GHz PA
  - 3. Flash (J = 1024k)
- TTTTTT – A trace or manufacturing code. The first letter is the device revision.
- YY – The last 2 digits of the assembly year.
- WW – The 2-digit workweek when the device was assembled.

8. QFN68 Package Specifications

8.1 QFN68 Package Dimensions

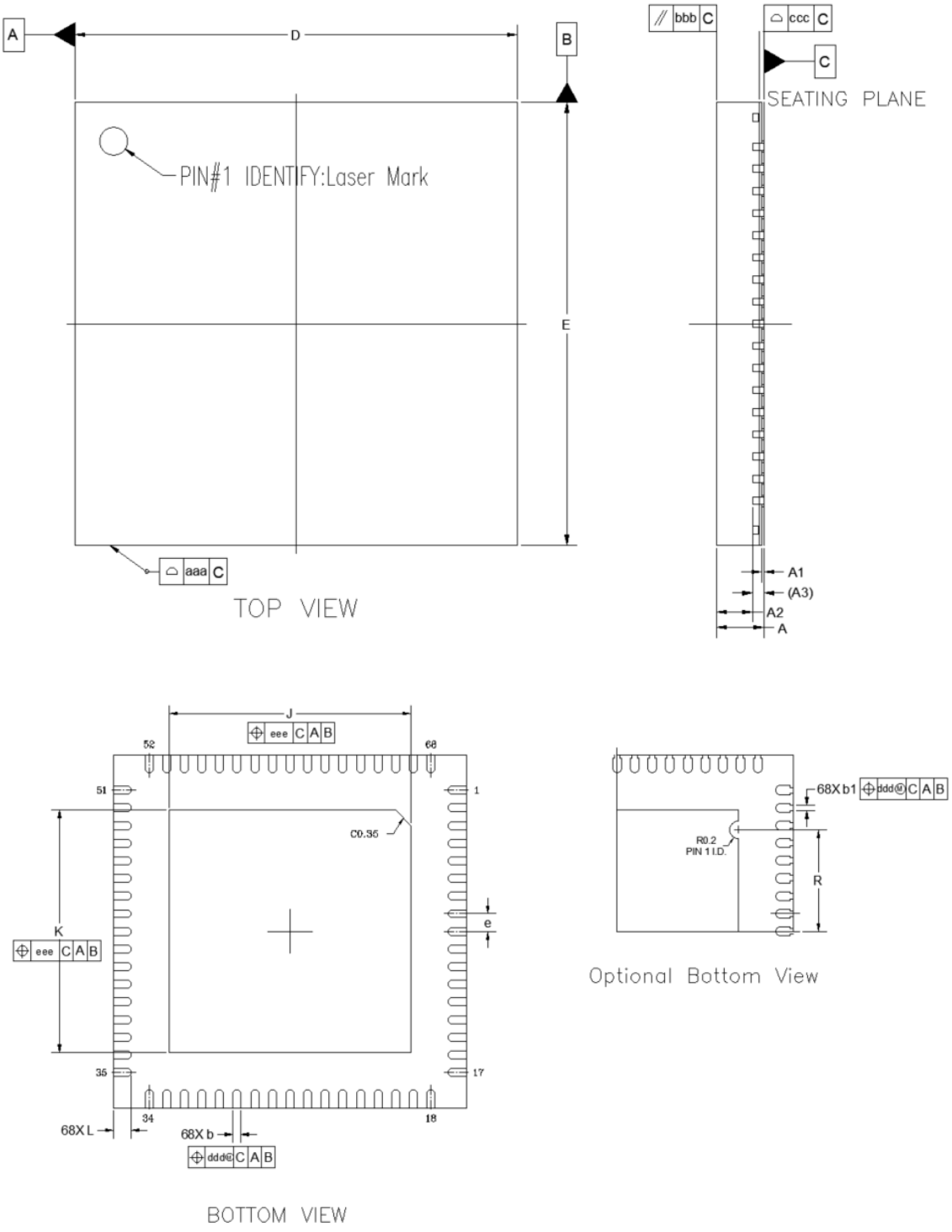

Figure 8.1. QFN68 Package Drawing

Table 8.1. QFN68 Package Dimensions

Dimension	Min	Typ	Max
A	0.80	0.85	0.90
A1	0.00	0.035	0.05
A2	—	0.65	—
A3		0.203 REF	
b	0.13	0.19	0.25
b1	0.075	0.125	0.175
D		8.00 BSC	
E		8.00 BSC	
e		0.40 BSC	
J	5.40	5.50	5.60
K	5.40	5.50	5.60
L	0.30	0.40	0.50
R	2.20	2.30	2.40
aaa	—	0.10	—
bbb	—	0.10	—
ccc	—	0.08	—
ddd	—	0.10	—
eee	—	0.10	—

Note:
1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

8.2 QFN68 PCB Land Pattern

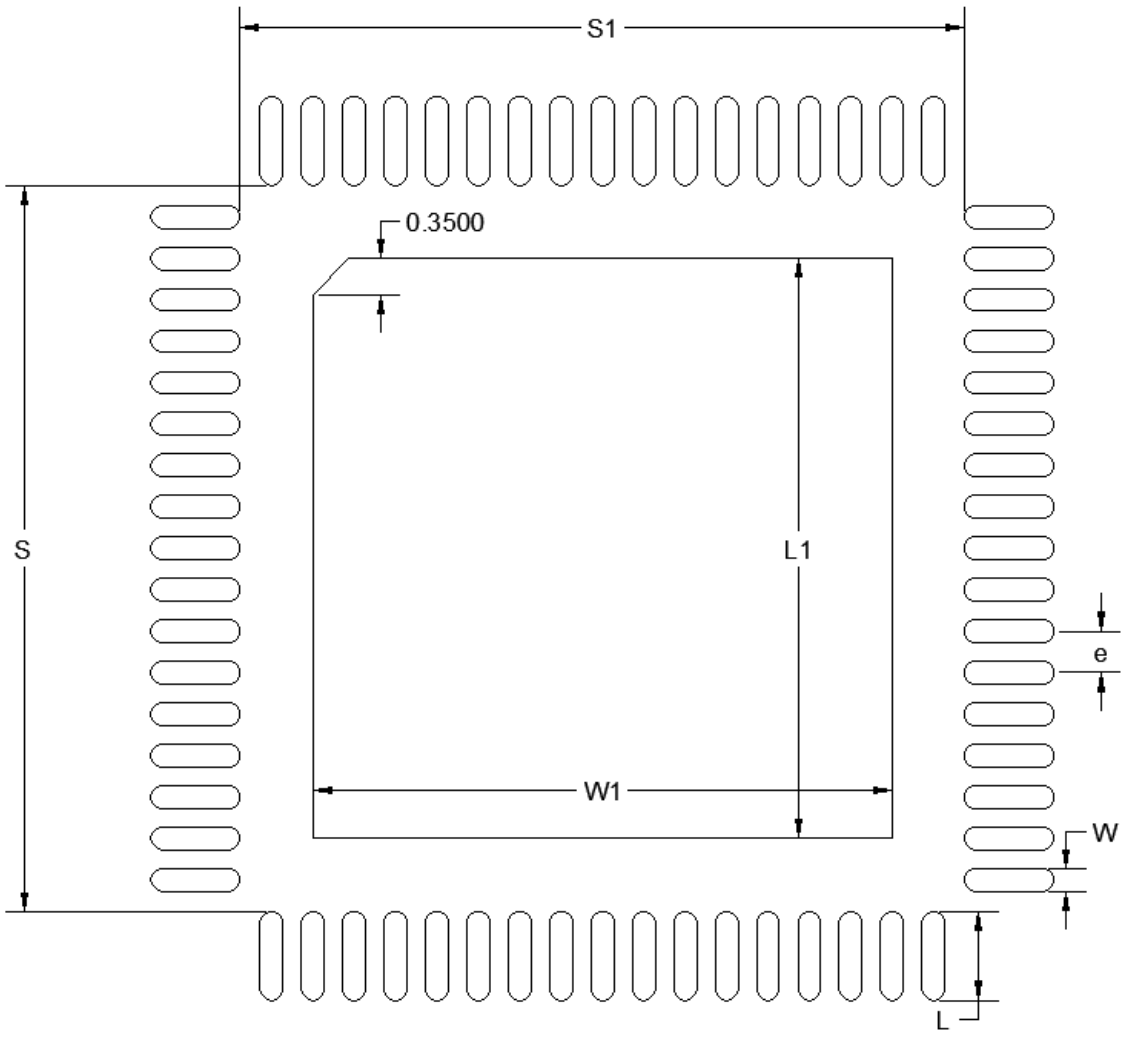

Figure 8.2. QFN68 PCB Land Pattern Drawing

Table 8.2. QFN68 PCB Land Pattern Dimensions

Dimension	Typ
S	7.05
S1	7.05
e	0.40
W	0.20
L	0.85
W1	5.60
L1	5.60

Note:

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on IPC-SM-782 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05mm.
5. All pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60 µm minimum, all the way around the pad.
6. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
7. The stencil thickness should be 0.102 mm (4 mils).
8. The ratio of stencil aperture to land pad size should be 1:1 for the perimeter pads.
9. A 3x3 array of 1.31 mm square openings on a 1.80 mm pitch should be used for the center ground pad.
10. A No-Clean, Type-3 solder paste is recommended.
11. The recommended card reflow profile is per the JEDEC/IPC J-STD-020C specification for Small Body Components.
12. ***Above notes and stencil design are shared as recommendations only. A customer or user may find it necessary to use different parameters and fine tune their SMT process as required for their application and tooling.***

8.3 QFN68 Package Marking

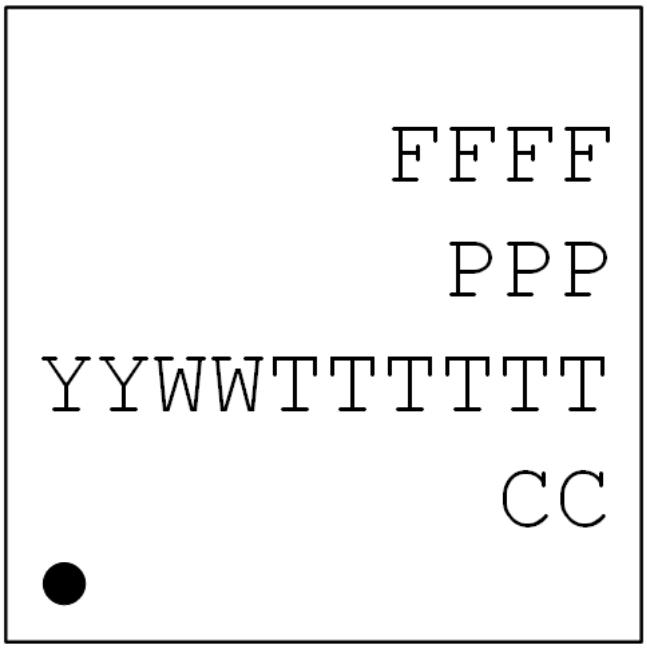

Figure 8.3. QFN68 Package Marking

The package marking consists of:

- FFFF – The product family codes.
  1. Family Code (F | Z)
  2. G (Gecko)
  3. Series (2)
  4. Device Configuration (8)
- PPP – The product option codes.
  - 1-2. Feature codes [f2, f3] (RF configuration)
    - 10 = Two 14 dBm Sub-GHz PAs
    - 12 = One 14 dBm Sub-GHz PA and One 10 dBm BLE 2.4 GHz PA
    - 20 = Two 20 dBm Sub-GHz PAs
    - 22 = One 20 dBm Sub-GHz PA and One 10 dBm BLE 2.4 GHz PA
  - 3. Flash (J = 1024k)
- YY – The last 2 digits of the assembly year.
- WW – The 2-digit workweek when the device was assembled.
- TTTTTT – A trace or manufacturing code. The first letter is the device revision.
- CC – Country of Origin (2-digit ISO 3166).

9. Revision History

Revision 1.1

October, 2023

- Updated Table 5.1 868/915/920 MHz Component Values, +14 dBm on page 137 with optimized component values for +14 dBm and removed +10 dBm match recommendations.
- Added Table 5.2 868 MHz Component Values, +10 dBm on page 137 868 MHz +10 dBm match recommendations.
- Updated Table 5.3 868/915/920 MHz Component Values, +20 dBm on page 138 with optimized component values.
- Updated Table 5.8 2.4 GHz Component Values, +10 dBm on page 143 with optimized component values.
- Corrected recommended matching network and component values in 5.2.2 Matching Network for 470 MHz Band.
- Added 4.4.1 Buck DC-DC Minimum Input.
- Added capsense deprecation note to Table 4.51 Analog Comparator (ACMP) on page 103.

Revision 1.0

August, 2023

- Electrical specification tables updated with final test limits.
- Transitioned to new block diagram format and color scheme.

Revision 0.5

July, 2023

- Electrical specification tables updated with latest characterization data.
- Added section 4.9.4 Amazon Sidewalk RF Receiver Characteristics.
- Updated 4.30 Typical Performance Curves with final characterization results.

Revision 0.3

March, 2023

- Wi-SUN FSK specification tables re-included.
- Electrical specification tables updated with latest characterization data.

Revision 0.2

December, 2022

- Electrical specification tables updated with latest characterization data.
- Temporarily removed Wi-SUN FSK specification tables (to be re-instated at full production).
- Corrected VDAC signal names in Table 6.5 GPIO Alternate Function Table on page 152 and Table 6.6 ABUS Routing Table on page 154.
- Removed hidden and unavailable signals from Table 6.7 DBUS Routing Table on page 155.

Revision 0.1

August, 2022

Initial release.

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